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# **Evaluation Current Reliability Results from the Steam Generator Mock-up Analysis Round-Robin**

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#### Eddy Current Reliability Results from the Steam Generator Mock-up Analysis Round-Robin

by

D. S. Kupperman, S. Bakhtiari, W. J. Shack, J. Y. Park, and S. Majumdar

#### **Abstract**

This report presents the results of a nondestructive evaluation round-robin designed to independently assess the reliability of steam generator (SG) inspection. A steam generator mock-up at Argonne National Laboratory (ANL) was used for this study. The goal of the round-robin was to assess the current state of in-service inspection reliability for SG tubing, determine the probability of detection (POD) as a function of flaw size or severity, and assess the capability for sizing of flaws. Eleven teams participated in analyzing bobbin and rotating coil mock-up data collected by qualified industry personnel. The mock-up contains hundreds of cracks and simulations of artifacts such as corrosion deposits and tube support plates. This configuration mimics more closely than most laboratory situations the difficulty of detection and characterization of cracks experienced in an operating steam generator. An expert task group from industry, ANL, and the Nuclear Regulatory Commission (NRC) has reviewed the signals from the laboratory-grown cracks used in the mock-up to ensure that they provide reasonable simulations of those obtained in the field. The number of tubes inspected and the number of teams participating in the round-robin are intended to provide better statistical data on the POD and characterization accuracy than is currently available from Electric Power Research Institute (EPRI) qualification programs. This document reports results beyond those presented in ANL-01/22, "Evaluation of Eddy Current Reliability from Steam Generator Mock-up Round-Robin."

This report does not establish regulatory position.

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#### **Executive Summary**

A major outcome of regulatory activity over the past 10 years has been the development and implementation of two key concepts, condition monitoring and operational assessment. That effort was intended to develop guidance for tube integrity assessments. Condition monitoring is an assessment of the current state of the steam generator (SG) relative to the performance criteria for structural integrity. An operational assessment involves an attempt to assess the state of the generator relative to the structural-integrity performance criteria at the end of the next inspection cycle. Predictions of the operational assessment from the previous cycle can be compared with the condition monitoring assessment to verify the adequacy of the methods and data used to perform the operational assessment.

A key factor in establishing the reliability of this operational assessment and condition monitoring is the reliability of the nondestructive evaluation (NDE) techniques used to establish the flaw distribution in terms of detection and characterization of flaws and the capability to assess their impacts on the structural and leakage integrity of SG tubes. An NDE round-robin exercise has been used to independently assess SG inspection reliability. This exercise employed a steam generator mock-up at ANL. The purpose was to assess the current state of in-service inspection (ISI) reliability for SG tubing, determine the probability of detection (POD) as a function of flaw size or severity, and assess the capability for flaw sizing. Note that this report, which presents results beyond those in ANL-01/22, "Evaluation of Eddy Current Reliability from Steam Generator Mock-up Round-Robin," does not establish a regulatory position.

Eleven teams participated in analyzing bobbin and rotating probe data from the mock-up that were collected by qualified industry personnel. The mock-up tube bundle contains hundreds of cracks and simulations of artifacts such as corrosion deposits, support structures, and tube geometry variations that, in general, make the detection and characterization of cracks more difficult. An expert NDE Task Group from ISI vendors, utilities, EPRI, ANL, and the NRC has reviewed the eddy current signals from laboratory-grown cracks used in the mock-up to ensure that they provide a realistic simulation of those obtained in the field. The number of tubes inspected and the number of teams participating in the roundrobin are expected to provide better statistical data on the POD and characterization accuracy than is currently available from industry performance demonstration programs.

The mock-up tube bundle consists of 400 Alloy 600 tubes made up of nine test sections, each 0.3 m (1 ft) long. The test sections are arranged in nine levels, each having 400 tube sections. The lowest level simulates the tube sheet, while three other levels simulate tube support plate (TSP) intersections. The remaining five levels are free-span (FS) regions. Tubes rolled into ferritic steel collars simulate the tube sheet geometry. Thus, both the roll transition geometry and the effect of the ferritic tube sheet are simulated. Axial and circumferential cracks are present in the roll transition region. In the TSP crevice, the presence of magnetite was simulated by filling the crevice with magnetic tape or a ferromagnetic fluid. A mixture of magnetite and copper powder in an epoxy binder simulated sludge deposits. Longitudinal outer-diameter stress corrosion cracks (LODSCC), both planar and segmented, and cracks in dents with varying morphologies are present at TSP locations. Cracks in the five FS levels are primarily LODSCC, both planar and segmented. Other types of flaws such as intergranular attack (IGA) and wear are found in the tube bundle but in small numbers.

Bobbin coil (BC) data were collected on all 3600 tube sections of the mock-up by using magnetically biased ("mag-biased") probes. A mag-biased, rotating, three-coil probe was used to collect data from all 400 tube sheet and special-interest test sections. This motorized rotating pancake coil (MRPC) probe included a midrange +Point coil, a 2.9-mm (0.115-in.)-diameter pancake coil, and a 2-mm

(0.080-in.)-diameter, high-frequency, shielded pancake coil. Eddy current data were collected by a qualified industry team and stored on optical disks. Round-robin (RR) teams later analyzed the data with an ANL proctor present to monitor the analysis process. The intent was to make the analysis as close a simulation of an actual inspection as possible. The procedures and training sets were developed in cooperation with the NDE Task Group so that the inspection protocols and training would mimic those in current practice.

The reference state for each flaw in the mock-up, i.e., crack geometry and size, was established by calculations using a multiparameter algorithm developed at ANL for analyzing eddy current (EC) data. Both pre- and post-assembly inspection results were used for this purpose. Throughout the development stage of the algorithm, comparisons were made between the NDE predictions and results obtained by destructive analyses for dozens of flaws. A final validation was performed by comparing the NDE results to destructive analyses in a blind test on a set of 23 flawed specimens. The results from this comparison were used to estimate the uncertainties associated with the depth estimates from the multiparameter algorithm. Further validation was carried out by destructive examination of selected tubes removed from the mock-up.

Eleven teams participated in the analysis round-robin. Each team provided nine reports: a primary analyst report, a secondary analyst report, and a resolution analyst report for each of the three optical data disks containing the inspection results (bobbin coil for all tubes, MRPC for all tube-sheet test sections, and MRPC for a set of selected test sections). Results were analyzed for all teams, including the team-to-team variation in the POD, along with the population average. Analysis of the LODSCC data at the tube support plate and in the free span showed that BC false call rates are about 2% for the TSP and 0.1% for the free span. The MRPC false call rate for the tube sheet is about 6% of all the test sections involved.

The detection results for the 11 teams were used to develop POD curves as a function of maximum depth and the parameter m<sub>p</sub>, a stress multiplier that relates the stress in the ligament ahead of the crack to the stress in an unflawed tube under the same loading. Because m<sub>p</sub> incorporates the effect of both crack depth and length, it better characterizes the effect of a flaw on the structural and leakage integrity of a tube than do traditional indicators, such as maximum depth. The POD curves were represented as linear logistic curves, and the curve parameters were determined by the method of maximum likelihood. The statistical uncertainties inherent in sampling from distributions and the uncertainties due to errors in the estimates of maximum depth and m<sub>p</sub> were determined. The 95% one-sided confidence limits (OSLs), which include errors in maximum depth estimates, are presented along with the POD curves.

The BC POD for TSP IDSCC is higher than for ODSCC: 99% with 98% OSL at 60% throughwall (TW) vs. 75% with 65% OSL at 60% TW. The BC POD for free-span LODSCC (95% at 60% TW) is higher than the POD for TSP LODSCC and lower than that for TSP LIDSCC. For the MRPC in the tube sheet, the POD for IDSCC is about 90% with an OSL of about 75%. The highest tube sheet MRPC POD curve is for LIDSCC, where the POD at 60% TW is 95%. A review was carried out of MRPC results for BC voltages from 2.0 to 5.6 V. Such calls are normally made to confirm or dismiss the BC flaw call. The result, for LODSCC >74% TW, is an average correct call of 98%. All teams missed, with MRPC data, an LODSCC at the TSP with an estimated maximum depth of 28% TW. One example illustrates the possibility of having a strong BC signal and a weak MRPC signal that would not be called a crack by analysts. The example presented had an estimated maximum depth of 99% TW, with only a few tenths of a volt generated by the +Point coil at 300 kHz.

When the PODs are considered as a function of  $m_p$  in the TSP and FS regions, the POD for cracks that would fail or leak under  $3\Delta p$  internal pressure (corresponding to  $m_p \approx 2.3$ ) is >95%, even when uncertainties are accounted for.

The results were analyzed by team to determine whether there was a strong team-to-team variation in the POD. The performances of most of the teams cluster rather tightly, although in some cases a significant variation existed between best and worst. The probability that team-to-team variations in logistic fits to data are due to chance was estimated. For LIDSCC at the TSP, the variation from best to worst is very significant statistically. The probability is <0.1% that the difference is due to chance (DTC). For FS OD, the variation from best to worst is likely to be significant (DTC <20%). For TSP OD, this variation is probably not significant (DTC >60%).

The BC voltages reported for LODSCC indications at TSP regions were also analyzed. In most cases, variations in reported voltages by the teams were fairly small. This finding, in part, is attributed to the fact that all teams analyzed the same set of data, i.e., had identical data acquisition and calibration setups. For each longitudinal OD indication, an average BC voltage and a corresponding standard deviation were computed for all teams. For almost 85% of all indications, the normalized standard deviation in the reported voltage is <0.1 V. Indications with larger variations are not associated with particularly high or low voltage values (i.e., approximately half the signals with standard deviations of >0.1 V have voltages of >2 V). Instead, they are associated with the complexity of the signal and the difficulty of identifying the peak voltage and the associated null position.

The round-robin results for the small number of test sections with IGA have been analyzed separately from the other flawed test sections. The result suggests that this type of volumetric cracking can be detected easily with a bobbin coil for depths greater than 40% TW.

The BC and MRPC results for LIDSCC in dented TSP test sections have been analyzed as a subset of the mock-up (using resolution analyst reports). These results suggest that by combining the BC and MRPC calls rather than trying to verify a BC call with MRPC data, the success rate would be very high for depths greater than 40% TW.

The BC results for electro-discharged machined (EDM) notches and laser-cut slots have also been analyzed as a subset of the mock-up. For depths 40% TW and greater, the success in detecting notches and laser-cut slots is greater than for SCCs of comparable depths. This finding suggests that POD curves generated using notches are unrealistically high for deep cracks.

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### **Acronyms and Abbreviations**

ABB-CE ASEA Brown-Boveri-Combustion Engineering

AECL Atomic Energy of Canada, Ltd. ANL Argonne National Laboratory

ASME American Society of Mechanical Engineers

BC bobbin coil

CIDSCC circumferential inner-diameter stress corrosion crack/cracking CODSCC circumferential outer-diameter stress corrosion crack/cracking

DE&S Duke Engineering and Services

DTC difference due to chance

EC eddy current

ECT eddy current testing

EDM electro-discharge machining EPRI Electric Power Research Institute

ETSS examination technique specification sheet

FS freespan

FTI Framatome Technology-ANP

ID inner diameter IGA intergranular attack

INEEL Idaho National Engineering and Environmental Laboratory

ISI in-service inspection

LIDSCC longitudinal inner-diameter stress corrosion crack/cracking LODSCC longitudinal outer-diameter stress corrosion crack/cracking

MRPC motorized rotating pancake coil
NDD nondetectable degradation
NDE nondestructive evaluation

NRC U.S. Nuclear Regulatory Commission

OD outer diameter

ODSCC outer-diameter stress corrosion crack/cracking

OPG Ontario Power Generation
OSL one-sided 95% confidence limits
PNNL Pacific Northwest National Laboratory

POD probability of detection PWR pressurized water reactor

PWSCC primary-water stress corrosion crack/cracking

QDA qualified data analyst RMSW root mean square error RPC rotating pancake coil

RR round-robin

RTZ roll transition zone

SCC stress corrosion crack/cracking

SG steam generator

SSPD site-specific performance demonstration

TS tube sheet

TSP tube support plate
TTS top of tube sheet
TW throughwall

UT ultrasonic testing W Westinghouse

#### 1 Introduction

One major outcome of regulatory activity over the past 10 years intended to develop guidance for tube integrity assessments is the development and implementation of two key concepts, condition monitoring and operational assessment. Condition monitoring is an assessment of the current state of the steam generator (SG) relative to the performance criteria of structural integrity. An operational assessment is an attempt to assess what will be the SG state relative to the structural integrity performance criteria at the end of the next inspection cycle. The predictions of the operational assessment from the previous cycle can be compared with the results of the condition monitoring assessment to verify the adequacy of the methods and data used to perform the operational assessment. The reliability of the inservice inspection (ISI) is critical to the effectiveness of the assessment processes. Quantitative information on probability of detection (POD) and sizing accuracy of current-day flaws for techniques used for SG tubes is needed to determine if tube integrity performance criteria were met during the last operating cycle, and if performance criteria for SG tube integrity will continue to be met until the next scheduled ISI. Information on inspection reliability will permit estimation of the true state of SG tubes after an ISI by including the flaws that were missed because of imperfect POD. Similarly, knowledge of sizing accuracy will permit corrections to be made to flaw sizes obtained from ISI.

Eddy-current (EC) inspection techniques are the primary means of ISI for assessing the condition of SG tubes in current use. Detection of flaws by EC depends on detecting the changes in impedance produced by the flaw. Although the impedance changes are small ( $\approx 10^{-6}$ ), they are readily detected by modern electronic instrumentation. However, many other variables, including tube material properties, tube geometry, and degradation morphology, can produce impedance changes, and the accuracy of distinguishing between the changes produced by such artifacts and those produced by flaws is strongly influenced by EC data analysis and acquisition practices (including human factors). Similarly, although there is a relationship between the depth of a defect into the tube wall and the EC signal phase response, in practice, features that affect detection also affect sizing capability.

The most desirable approach to establishing the reliability of current ISI methods is to carry out round-robin (RR) exercises in the field on either operating SGs or those removed from service. However, access to such facilities for this purpose is difficult, and validation of the results would be difficult. Such work would also be prohibitively expensive. In addition, obtaining data on all morphologies of interest would require tubes from many different plants.

The approach chosen for this program was to develop an SG tube bundle mock-up that simulates the key features of an operating SG so that the inspection results from the mock-up would be representative of those for operating SGs. Considerable effort was expended in preparing realistic flaws and verifying that their EC signals and morphologies are representative of those from operating SGs. The mock-up includes stress corrosion cracks of different orientations and morphologies at various locations in the mock-up and simulates the artifacts and support structures that may affect the EC signals. Factors that influence detection of flaws include probe wear, EC signal noise, signal-to-noise ratio, analyst fatigue, and the subjective nature of interpreting complex EC signals. In this exercise, all analysts analyzed the same data, which were provided on optical disks. The team-to-team variation in detection capability is the result of analyst variability in interpretation of EC signals. The fits to the POD data and the subsequent lower 95% confidence limits are influenced by the uncertainty in crack depth determined by a multiparameter algorithm and the number of cracks in the sample set. The mock-up is also being used as a test bed for evaluating emerging technologies for the ISI of SG tubes.

In this report, while the probabilities of detecting flaws of various types and at various locations are presented as logistic fit curves to the raw data, along with lower 95% confidence limits, the results do not establish regulatory position.

Note that this document reports results beyond those presented in ANL-01/22, "Evaluation of Eddy Current Reliability from Steam Generator Mock-up Round-Robin" [1].

#### 2 Program Description

The overall objective of the SG tube integrity program [2] is to provide the experimental data and predictive correlations and models needed to permit the NRC to independently evaluate the integrity of SG tubes as plants age and degradation proceeds, new forms of degradation appear, and new defect-specific management schemes are implemented. The objective of the inspection task is to evaluate and quantify the reliability of current and emerging inspection technology for current-day flaws, i.e., establish the probability of detection (POD) and sizing accuracy for different size cracks. Both EC and ultrasonic testing (UT) techniques are being evaluated, although only EC testing organizations have participated in the round-robin up to now.

The procedures and processes for the round-robin (RR) studies mimic those currently practiced by commercial teams in actual inspections. Teams participating in the RR exercise report their data analysis results on flaw types, sizes, and locations, as well as other commonly used parameters such as signal amplitude (voltage) and phase.

An important part of the RR exercise was the NDE Task Group, an expert group from ISI vendors, utilities, EPRI, ANL, and the NRC. This group reviewed the signals from the laboratory-grown cracks used in the mock-up to ensure that they provide reasonable simulations of those obtained from real cracks. The Task Group provided input on the quality of the mock-up data, the nature of the flaws, and procedures for data acquisition, analysis, and documentation. To the extent possible, the intent was to mimic current industry practices.

Because the destructive examination of all the flaws in the mock-up would be extremely expensive and time-consuming, several laboratory NDE methods (including various EC and UT procedures) were evaluated as a way to characterize the defects in the mock-up tubes so that the reference state can be estimated without destructive examinations. Based on these evaluations, multiparameter analysis of rotating probe data that was implemented at ANL was used to determine the reference state of the mock-up test sections [3]. This effort has provided sizing estimates for the tube bundle defects. The multiparameter algorithm has been validated by using 23 test sections with SCCs like those in the mock-up. The depth profiles generated by the multiparameter algorithm were compared to profiles of test sections destructively analyzed with cracks mapped by fractography techniques. These results were further validated by the destructive examination of selected tubes from the mock-up.

#### 2.1 Steam Generator Mock-up Facility

The mock-up tube bundle consists of 400, 22.2-mm (0.875-in.)-diameter, Alloy 600 tubes consisting of 9 test sections, each 0.3 m (1 ft) long. Test sections are arranged in nine levels with 400 tubes at each elevation. The centers of the tubes are separated by 3.25 cm (1.28 in.). Tie rods hold the test sections together. The ends of each test section are pressed into 19-mm (0.75-in.)-thick high-density polyethylene plates that hold it in alignment. One end of each tube is spring-loaded. The lowest level (A) has a roll transition zone (RTZ) and simulates the tube sheet, while the 4<sup>th</sup>, 7<sup>th</sup>, and 9<sup>th</sup> levels simulate intersections of the drilled hole tube support plate (TSP). The other five levels are free-span regions. Above the 9th level is a 0.91-m (3-ft)-long probe run-out section. See Fig. 2.1 for the tube bundle diagram and Fig. 2.2 for photograph of the mock-up. Debris generated during assembly (e.g., shavings from the polyethylene plates) was cleared to assure that the eddy current probes could travel unobstructed through all test sections.

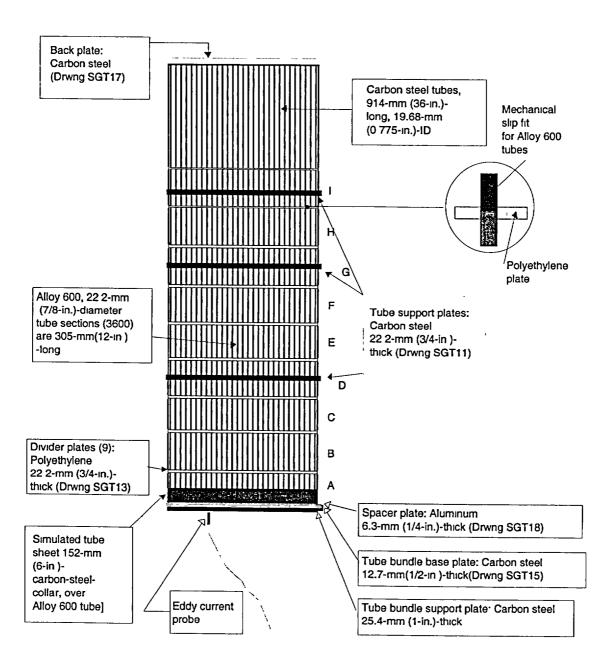


Fig. 2.1. Schematic representation of steam generator mock-up tube bundle.

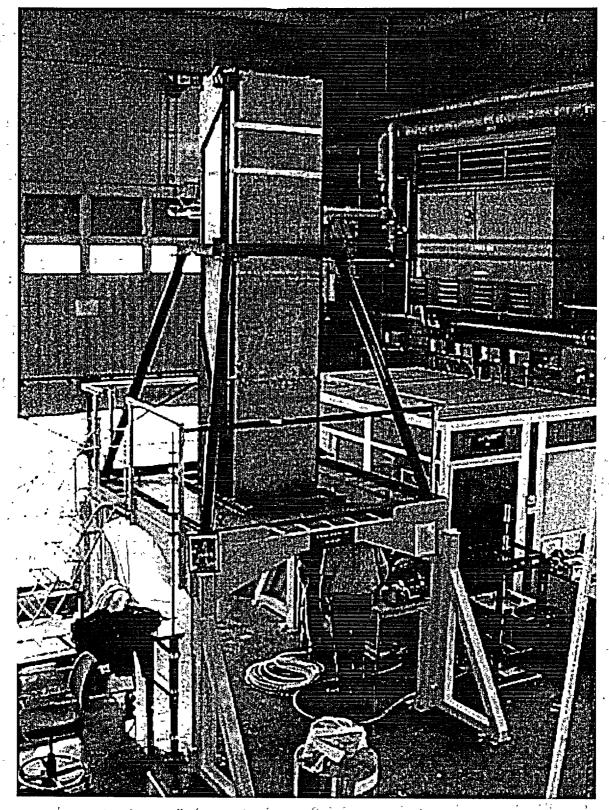


Fig. 2.2. Photograph of mock-up during acquisition of eddy current data.

Most of the degraded test sections were produced at ANL, although some were produced by Pacific Northwest National Laboratory (PNNL); Westinghouse; Equipos Nucleares, SA (ENSA); and the Program for the Inspection of Steel Components (PISC).

The test sections in the tube sheet level are all mechanically expanded onto a 30.5-cm (6-in.)-long carbon steel collar, leaving a RTZ halfway from the tube end. To produce cracks in and near the RTZ, the steel collar was split and removed from the expanded tube. Exposing the expanded test specimen to a chemical solution then induced cracks. Axial and circumferential outer diameter (OD) and inner diameter (ID) stress corrosion cracks (SCC) were produced in the roll transition zones. New steel collars that were expanded by heating were slipped over the cracked tubes. This process produced flawed test sections with realistic EC signals.

In the TSP regions, filling the crevice with magnetic tape or a ferromagnetic fluid simulated magnetite in the crevices. A mixture of magnetite and copper bonded with epoxy simulated sludge deposits. Sludge was placed above the RTZ and at TSP intersections in some cases (see Fig. 2.3 for photograph of sludge on a tube sheet test section). Many test sections had sludge or magnetite but no flaws. LODSCC and LIDSCC, both planar and segmented, and cracks with varying morphologies are present at TSP locations with and without denting (see Fig. 2.4 for a photograph of a dent). Some flaw-free test sections were dented. Cracks in the remaining five free-span levels are primarily LODSCC, both planar and segmented. Axial and circumferential cracks of ID and OD origin are found in the RTZ. A small number of other flaw types such as IGA and wear are placed in the tube bundle. The mock-up also contains test sections with electro-discharge-machined (EDM) notches and laser-cut slots. Table 2.1 summarizes the degradation types and their locations in the mock-up. Flow types included IGA, ODSCC, primary-water SCC (PWSCC), wear/wastage, and fatigue.

Magnetite-filled epoxy markers were placed at the ends of all test sections to provide a reference for the angular location of flaws when collecting data with a rotating or array probe. Figure 2.5 shows an isometric plot (c-scan) indicating the EC response from an axially oriented, magnetite-filled epoxy marker that is 400- $\mu$ m (0.016-in.) wide by 250- $\mu$ m (0.010-in.) thick by 25-mm (1-in.) long and, located on the ID side at the end of a test section. The data were acquired at 400 kHz with a 2.03-mm (0.080-in.)-diameter, high-frequency, shielded pancake coil. This test section also contains an ODSCC at the TSP intersection region. The analysts were instructed to ignore the region 25 mm (1 in.) from each test section end when carrying out their analysis.

Prior to assembly, flawed test sections in the tube bundle were examined with both a bobbin coil (BC) and a three-coil rotating probe that incorporates a +Point coil, a 2.9-mm (0.115-in.) pancake coil, and a 2-mm (0.080-in.) shielded pancake coil. In addition to a full EC examination, many cracked test sections were examined by the dye-penetrant method before being incorporated into the mock-up tube bundle. If EC data, dye penetrant results, or crack growth parameters indicated that a crack must be present, the test section was included in the mock-up. Because primary interest is with deep flaws, the majority of cracks selected for the mock-up had a +Point phase angle consistent with deep (>60% TW) cracks. Note that since the importance of obtaining POD data from deep flaws is greater than that for shallow ones, as expected, high voltage signals are more common in the mock-up than in operating steam generators. This condition is the result of the need for a large number of flaws when establishing a high POD (deep cracks) compared to the smaller number of flaws needed for a low POD (shallow cracks).

BC data from the mock-up were analyzed to show the distribution of voltages. The histograms (Figs. 2.6 and 2.7) show a reasonable distribution of BC voltages (up to 20 V) for cracks and other conditions, and for cracks alone. Figure 2.6 shows the distribution for all signals called in the mock-up

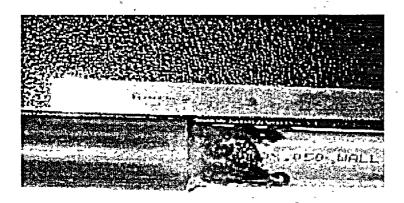


Fig. 2.3.
Photograph of sludge on a tube-sheet test section. Many test sections with and without flaws had sludge deposits.

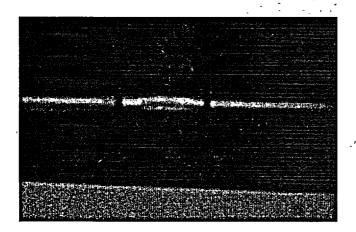


Fig. 2.4.
Photograph of dent in a test section.
Such dents were produced by a device provided by Framatome Technology.
The dent is between the black bars,
which are 25 mm (1 in.) apart. Test sections with and without cracks had dents.

Table 2.1. Flaw types and quantity

-,	EDM & Laser Cut				Wear/	
Location	Slots	IGA	ODSCC	PWSCC	Wastage	Fatigue
Top of Tube sheet	_	_	21	47	-	-
Free-Span	14	8	90	4	3	-
TSPs	7	5	69	31	. 9	3

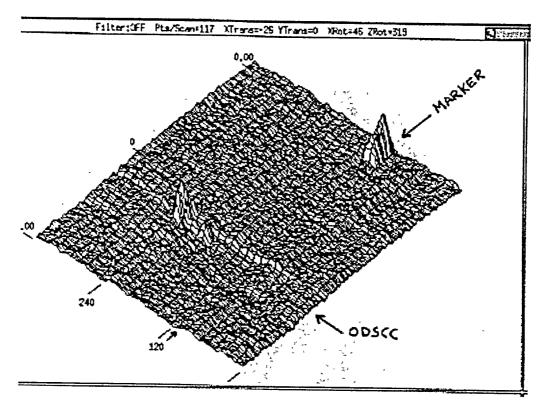


Fig. 2.5. Isometric plot (c-scan) showing eddy current response from axially oriented, magnetite-filled epoxy marker located on ID side at end of 22.2-mm (0.875-in.) Alloy 600 tube. Dimensions of  $400-\mu m$  (0.016-in.) wide by 250- $\mu m$  (0.010-in.) thick by 25-mm (1-in.) long.

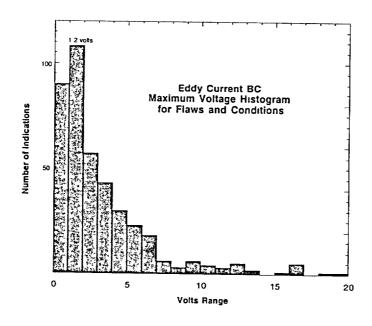


Fig. 2.6.
Bobbin coil voltage histogram for mockup flaws and other conditions

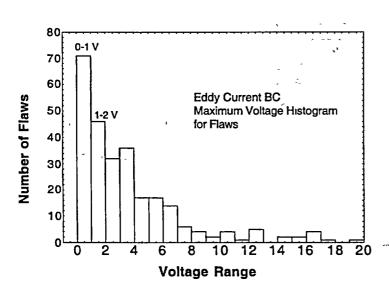


Fig. 2.7.
Bobbin coil voltage histogram for mockup flaws

(cracks, dents, dings, wastage, and all overcall signals associated with artifacts). Figure 2.7 shows the distribution without the signals from artifacts or geometry. Some cracks and conditions with voltages greater than 20 are not shown in the histogram. Voltage and phase angle for mock-up cracks are similar in nature to field data such as from McGuire (Duke Power). Figure 2.8 shows representative data from mock-up flaws and McGuire field data. The general scattering in the voltage-phase representation is similar. Although the diameter for the McGuire tubes is 19 mm (0.75 in.) rather than the 22.2 mm (0.875 in.) for the mock-up, the two types of tube can be compared because the voltages from notches of the same % TW are set the same.

There are differences between the mock-up and an operating steam generator. The mock-up has short sections, non-continuous tubes, and clear EC signals at the test section ends that look like a throughwall 360° circumferential notch or crack. The short lengths were necessary to allow realistic flaws to be made and the mock-up to be reconfigured. The mock-up does not have U-bends. The simulated tube sheet is only 15.2-cm (6-in.) thick with individual ferritic steel collars into which the tube sheet test sections are expanded. For all practical purposes, the EC signals at the inner edge of the collars and at the roll transition areas are the same as found in the field.

#### 2.1.1 McGuire vs. Argonne EC Signals

Pulled tubes from a retired McGuire steam generator have been inspected at Argonne using an NDE glove-box. The NDE glove-box allows for the EC inspection of radioactive test sections, including samples with loose radioactive contamination. The EC results from one McGuire test section are presented in Figs. 2.9 and 2.10 as well as Appendix D. Figure 2.9 shows the bobbin coil Lissajous figure for an LODSCC originally in a dented TSP region of a retired McGuire steam generator. The bobbin coil data were acquired using the NDE glove-box facility. Two standards (one an ASME standard, the other an 18-EDM-notch standard) were in line with the McGuire test section during the inspection. The BC data from the standards are seen in the linear traces on the left side of Fig. 2.9. Figure 2.11 shows a comparable BC Lissajous figure from an Argonne mock-up LODSCC. The similarity of BC voltage, phase angle, and shape for the two LODSCCs provides evidence of the ability to grow, under laboratory conditions, SCCs that mimic the EC signals of field flaws. Figures 2.10 and 2.12 compare the isometric amplitude images (C-scan results) using +Point coils at 300 kHz. The similarity of the two LODSCCs is also obvious from these two figures.

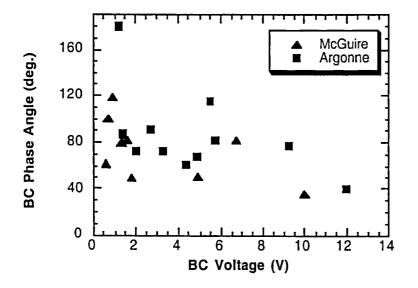


Fig. 2.8.

Bobbin coil voltage and phase angle for representative cracks in mock-up and McGuire field data. Phase/voltage relationships are similar.

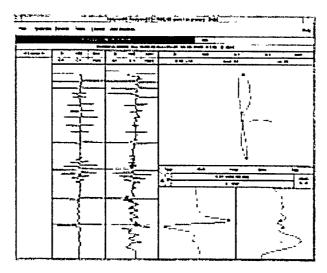


Fig. 2.9. Differential bobbin coil Lissajous figure at 400 kHz from McGuire LODSCC7243. EC data were taken from McGuire pulled tube using Argonne's NDE glove-box facility.

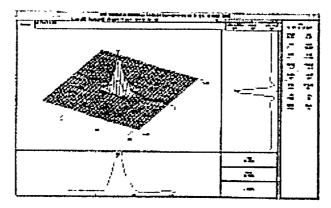


Fig. 2.10. Isometric plot of signal amplitude vs. position for +Point coil at 300 kHz from McGuire LODSCC7243. EC data were taken from McGuire pulled tube using Argonne's NDE glove-box facility.

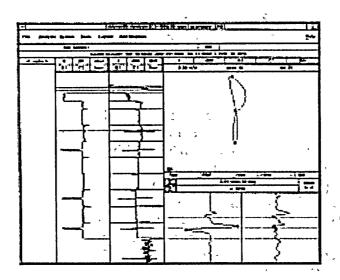


Fig. 2.11. Differential bobbin coil Lissajous figure at 400 kHz from Argonne-grown mock-up crack LODSCC300. BC signal shape, amplitude, and phase of McGuire and Argonne SCC are similar.

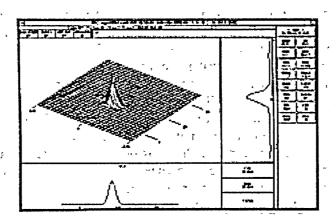


Fig. 2.12. Isometric plot of signal amplitude vs. position for +Point coil at 300 kHz from Argonne-grown mock-up crack LODSCC300. EC +Point signal shape, amplitude, and phase of McGuire and Argonne SCC are similar.

#### 2.1.2 Equivalencies

Mock-up data were collected with magnetically ("mag") biased bobbin and MRPC probes. Data have been collected to show equivalency of mag- and non-mag-biased probes. This is necessary because of the use of non-mag biased probes in the field. Magnetically biased probes were used for the mock-up, so those signals from sensitized and nonsensitized test sections have similar EC responses. Data from several mock-up flaws have been analyzed by using all frequencies employed in the mock-up data acquisition exercise. Data from a mag-biased +Point coil and data from the same flaw obtained with a non-mag-biased coil are virtually the same [2]. Mock-up MRPC data were taken at 900 rpm. Data have been analyzed to show the equivalency between an MRPC at 900 rpm [12.7 mm/s (0.5 in./s)] and an MRPC at 300 rpm [2.54 mm/s (0.1 in./s)] because the lower rpm can be found in field inspections. A Lissajous figure from a mock-up flaw at 2.54 mm/s (300 rpm) using a +Point coil and a Lissajous figure

from a mock-up flaw at 12.7 mm/s (900 rpm) using the same +Point coil are almost indistinguishable. Similar results have also been seen for other frequencies and coils.

#### 2.1.3 Standards

An ASME standard and an 18-notch standard were used during all test section inspections. The ASME standard has 100, 80, 60, 40 and 20% TW holes, a TSP simulation ring, and ID and OD circumferential grooves. The notch standard (fabricated by Zetec, Inc.) has ID and OD axial and circumferential EDM notches that are 20, 40, 60, 80, and 100% TW and 6-mm (0.24-in.) long. Before installation in the mock-up, a test section was scanned in tandem with the two standards. Figure 2.13 shows the stand and tube arrangement for inspections of degraded test sections. A Zetec 4-D pusher-puller, Zetec MIZ30 data acquisition system, and Zetec Eddynet 98 software were employed for data collection and analysis. During collection of data from the mock-up, whether with BC or MRPC, both standards were used before and after each tube, or section of tube, was scanned. Figure 2.14 shows schematic drawings of both standards.

#### 2.1.4 Flaw Fabrication and Morphology

#### 2.1.4.1 Justification for Selection of Flaw Types

The flaw types selected for the mock-up are those currently found in operating steam generators. Since about 1980, steam generator tube degradation has been dominated by SCC, which can occur on either the primary or secondary side, unlike the wastage and denting that occur exclusively on the secondary side (OD) of the tubes. Primary-water stress corrosion cracking (PWSCC) most likely occurs at regions of high residual stress, such as the tube expansion transition and immediately above the tube sheet, at U-bends (particularly the small-radius U-bends), and in tube regions deformed by secondary-side denting. As a result, the mock-up consists primarily of ID and OD SCC at the TSP (with and without dents), at and above the roll transitions, and in the free span. Outer-diameter intergranular attack (IGA) commonly occurs in crevices or under corrosion product scales. Such locations include the TSP crevice, the region near the top of the tube sheet, free-span areas under corrosion products or deposits, and regions under sludge buildup. As a result, some outer-diameter IGA is present in the mock-up. In addition, there are some fatigue cracks, some test sections with wastage, and some with wear.

#### 2.1.4.2 Process for Fabricating Cracks

Alloy 600 test sections at ANL were cracked by using a 1M aqueous solution of sodium tetrathionate at room temperature and atmospheric pressure. Techniques of localized environmental exposure, low applied load, and electrochemical potential were utilized to produce various crack geometries. Masking by coating areas of the tubes with lacquer was used to limit or localize the cracking area. The tubes were internally pressurized to generate hoop stresses to produce axial cracks and then axially loaded to produce circumferential cracks. The times to produce cracking ranged from 20–1000 h, depending on the type of crack being produced. A variety of OD and ID crack geometries were produced: axial, circumferential, skewed, or combinations of these. Many of the specimens contained multiple cracks separated by short axial or circumferential ligaments. Prior to exposure to the sodium tetrathionate solution, specimens were sensitized by heat-treating at 600°C (1112°F) for 48 h to produce a microstructure that is susceptible to cracking. Protective sleeves were used to prevent scratching or other mechanical damage to the test sections. An identification alphanumeric (ID) was permanently inscribed on the OD at both ends of each test section (Fig. 2.15). All documentation is referenced to the test section

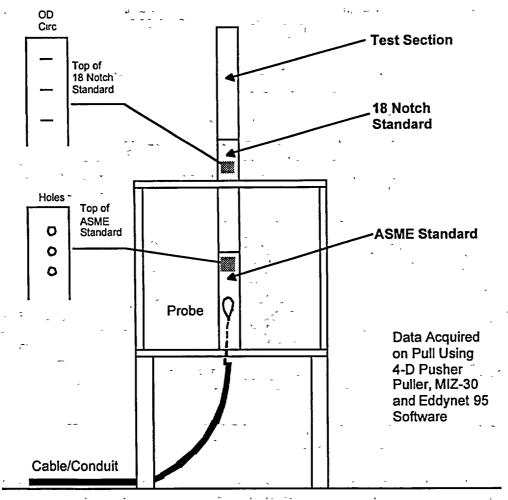
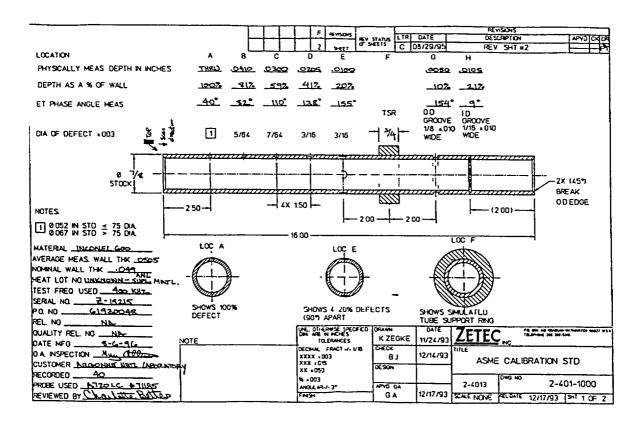


Fig. 2.13. Schematic drawing showing configuration of stand, standards, and degraded test section during an eddy current inspection of a single test section.

ID. The mock-up was seeded with sensitized flaw-free test sections, with and without artifacts, so that the possibility of distinguishing sensitized from unsensitized test sections would not be an indicator that a flaw was present in that test section. In addition, many cracks were grown without sensitizing the test sections from Westinghouse.

Dye penetrant examinations were carried out for degradation on the OD. After completion of the degradation process, test sections were ultrasonically cleaned in high-purity water and dried. Dye penetrant examinations (PT) were performed in the vicinity of degradation for many test sections. The PT was carried out with Magnaflux Spotcheck SKL-SP Penetrant and SKC-S Cleaner/Remover. If SKL-SP Penetrant provided an unsatisfactory result, Zyglo 2L-27A Penetrant was used with Magnaflux Zyglo 2P-9f Developer as an alternative.

The results of dye penetrant examination were documented by photography at 0.5-5X magnification. The photograph includes a calibrated scale so that the magnification factor may be measured directly from the photograph (Fig. 2.16).



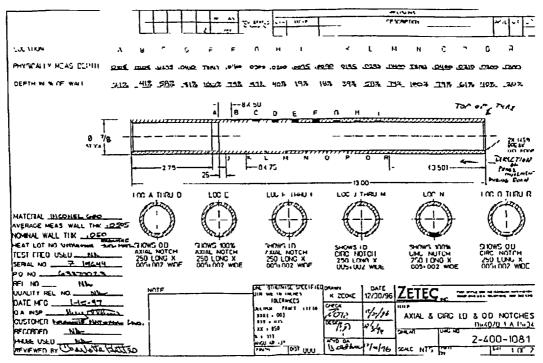


Fig. 2.14. Schematic drawing of ASME (top) and 18-notch standard (bottom) used when scanning degraded test sections and mock-up tubes.

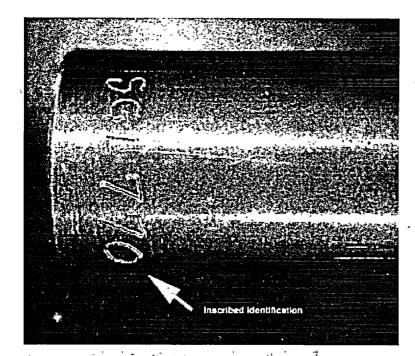


Fig. 2.15. Inscribed identification of tube specimen.

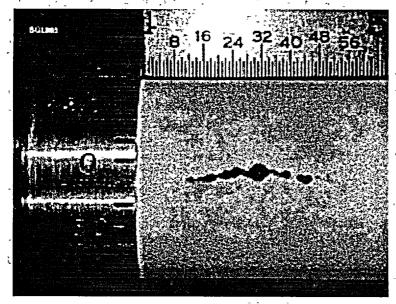


Fig. 2.16.

Dye penetration examination of tube specimen SGL865 showing an LODSCC.

Cross-sectional microscopy was performed on metallographically polished surfaces of many samples to provide documentation of the mock-up crack morphology. Figure 2.17 shows examples of LODSCC. The specimens were sometimes etched to delineate grain boundaries and other microstructural features, by electrolytic etching in 5% nitric acid-alcohol solution at 0.1 mA/mm² for 5-30 seconds. The etching may also enhance contrast of the image, but the tip of a tight intergranular crack could be confused with a grain boundary. Photographic images were recorded at 10-500X magnifications. Cracks in the mock-up provided by PNNL (about 50) were produced by Westinghouse with a doped steam method, which is proprietary and will not be discussed here. Axial and circumferential cracks, both ID and OD, were produced for the free span, TSP, and roll transitions. Several IGA specimens, as well as fatigue and wastage samples, were also provided by PNNL. Figure 2.18 shows sketches of dye penetrant images for ODSCC specimens provided by PNNL for the mock-up.

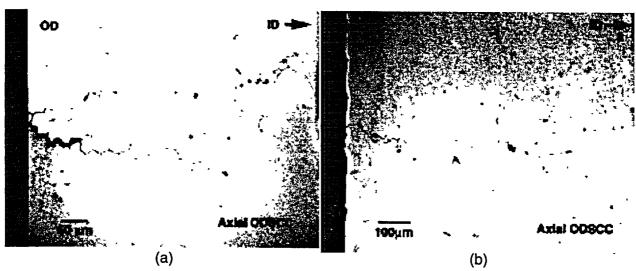


Fig. 2.17. Cross-sectional optical metallography for (a) branched LODSCC and (b) LODSCC.

#### 2.1.4.3 Matrix of Flaws

Table 2.2 shows the distribution of flaw types. The flaw depths are distributed into three ranges, 0-40% TW, 41%-80% TW, and 81-100% TW. The distribution is skewed toward deeper cracks. This skewing is necessary to obtain high confidence in the high POD for the deeper cracks. Draft Regulatory Guide 1074 ("Steam Generator Tube Integrity") describes criteria for performance demonstrations to quantify defect detection performance (POD for a given defect). While the distribution of flaw sizes for the round-robin is not as uniform as required in Draft Regulatory Guide 1074, other requirements involving extraneous signals, signals from fabricated defects, and detection and false calls have, for the most part, been met.

#### 2.1.4.4 Crack Profiles by Advanced Multiparameter Algorithm and Comparison to Fractography

As part of the development of the multiparameter algorithm, results have been compared to fractographic results on a wide variety of SCC cracks and EDM and laser notches. To provide an objective benchmark, however, an additional set of 29 SCC cracks was produced and used in a blind test of the predictions of the algorithm against fractographic measurements of the crack geometry. Six of the benchmark samples have not yet been destructively analyzed because they will also be used for leak and ligament rupture tests that have not yet been performed.

The stress corrosion cracks for the blind test were produced by the same technique in 1M aqueous solutions of sodium tetrathionate described in the previous page. A variety of OD and ID crack geometries were produced: axial, circumferential, skewed, or combination of these. Many of the specimens contained multiple cracks separated by short axial or circumferential ligaments. Cracked tubes were examined by dye penetrant techniques, conventional eddy current NDE, the multiparameter algorithm, and destructive methods.

#### 2.1.4.4.1 Procedures for Collecting Data for Multiparameter Analysis

The data collection procedures for multifrequency inspection of the mock-up tubes are described in Section 2.2.2.2. These guidelines define the instrumentation setup (coil excitation frequencies, gain setting, cable length, sampling rate, probe speed, etc.) and calibration procedures for a given probe (e.g.,

Table 2.2. Distribution of flaw types.

Maximum Depth Range	EDM & Laser- Cut Slots	ÍGA	ODSCC TS	ODSCC TSP	ODSCC Free Span	PWSCC TS	PWSCC TSP	PWSCC Free Span	Wear/ Wastage	Fatigue
0-40% TW	7	2	3	14	15	, 4	.8	- 1	6	0
41-80% TW	13	9.	2	14	26	. 8	16 :-	0	· 6	0
81-100 % TW	1,	2	`16	41 ′	49	35	7	3 ,	-0-, -2	3

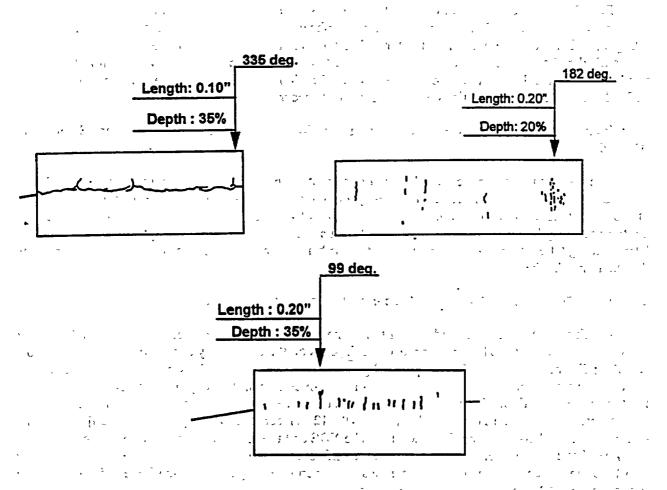


Fig. 2.18. Sketch of dye penetrant images of three ODSCCs in mock-up. Test section axis is vertical. Top-left SCC is circumferential; top-right and bottom sketches show numerous LODSCCs distributed around the circumference. Bottom sketch shows a series of LODSCCs at the roll transition.

bobbin, rotating, and array probes). Although the quality of data affects both detection and sizing, this issue is of particular concern when quantitative estimates of flaw size are to be determined. The multiparameter algorithm used to obtain flaw size estimates for the mock-up requires data at three frequencies and the minimum sampling rate recommended in the Examination Technique Specification Sheet (ETSS) for MRPC probes. The multiple-frequency EC data were acquired with a standard three-coil rotating probe that incorporates a 2.92-mm (0.115-in.) mid-range primary pancake coil, a mid-range +Point<sup>TM</sup>, and 2.03-mm (0.080-in.) high-frequency pancake coil. Initial amplitude profiles are obtained from the +Point coil at a single channel. The final estimated depth profiles are obtained by using multichannel information from the mid-range primary pancake coil for multiparameter data analysis. A detailed description of the algorithm and the data quality issue is given in Ref. 2, which also presents the conversion of Eddynet-formatted data to a standard format for off-line analysis.

### 2.1.4.4.2 Fractography Procedures

For the destructive examination, the samples were heat-tinted before fracture to permit differentiation of the SCC and fracture opening surfaces. The specimens were then chilled in liquid nitrogen, and cracks were opened by fracture. The fracture surfaces were examined macroscopically and with optical and scanning electron microscopy. The fractography and NDE data were digitized to obtain tabular and graphical comparisons of the depths as a function of axial or circumferential position. Well-defined markers on the test sections provided a means to accurately overlap the profiles.

Individual pieces of the specimen resulting from fracture are clearly identified, marked with new IDs, and documented.

The fractured surfaces are recorded by digital photography at a 0.2–10X magnification (Fig. 2.19). Methods of illuminating the fracture surface play an important role in obtaining the optimal image quality of the degradation. Optimal illumination may be found by a trial-and-error method. For a large crack, photographs may be taken for partial areas, and then a whole composite photograph may be constructed later. All digital photographs have been identified with a unique file name that is traceable to a particular degradation and tube.

### 2.1.4.4.3 Procedure for Comparing Multiparameter Results to Fractography

Crack profiles were obtained by digitizing the photographs of the fracture surfaces and drawing lines through the points. The sampling distance depends on the complexity of the crack geometry. Short sampling distances were used for complicated geometries over a small scale, while longer distances were used for simpler geometries, e.g., straight line or smooth contours. Fractography and NDE results were plotted in the same figure for comparative purposes (e.g., see Fig. 2.20). Drawing lines through the EC data points generates the NDE profiles (nominally 12 per centimeter [30 points per inch] around the circumference and 30 points per inch axially). The NDE and fractography profiles were then compared at many axial and circumferential positions, and the differences were used to establish the NDE uncertainty as a function of depth. The NDE uncertainties were then used in generating the lower 95% confidence limits for the POD curves presented in the report.

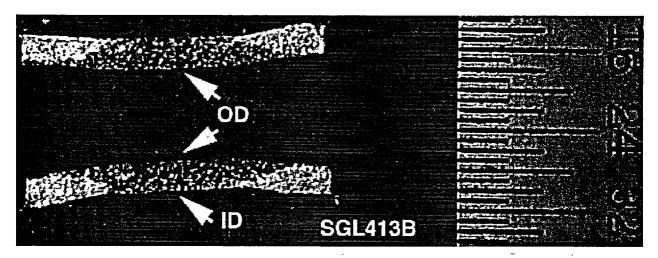


Fig. 2.19. Fractography of tube specimen SGL413.

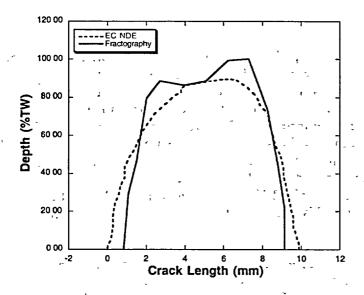


Fig. 2.20.
Sizes and shapes of LODSCCs in tube specimen AGL 536 determined by EC NDE using the multiparameter algorithm (dotted curve) and fractography (smooth curve).

### 2.1.4.4.4 Multiparameter Profiles vs. Fractography for Laboratory Samples

In the development of the multiparameter algorithm, the results from the algorithm have been compared to fractographic results on a wide variety of SCCs and EDM and laser-cut notches. To provide an objective benchmark, however, additional SCCs were produced and used for a blind test of the predictions of the algorithm against fractographic measurements of the crack geometry. Crack profiles from the destructive analyses are compared with those obtained from multiparameter algorithm in Figs. A1-A23 of Appendix A. Figure 2.21 shows maximum depths as determined by both fractography and the multiparameter algorithm. A linear regression fit and 95% confidence bounds for the observed data as a function of the multiparameter estimates are shown in the figure. The overall root mean square error (RMSE) in the predicted maximum depths is 13.7%. If the comparison is limited to deeper cracks, the RMSE is smaller, 9.7% for depths 30–100%, and 8.2% for ODSCCs of depths 50–100%. The data are too few, however, to determine whether the apparent variation of the RMSE with depth is statistically significant.

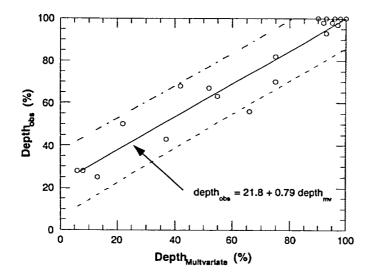


Fig. 2.21.
Comparison of maximum depth determined by the multiparameter algorithm with that determined by fractography

Because the field of view of the rotating pancake probe is limited, the depth measurements at points ≥5 mm apart along the crack profile are essentially independent, and additional comparisons of the estimated depth with that determined by fractography were made at various points along the crack profile. To avoid observer bias in the selection of the data for comparison, the intersections of the crack profiles with the major grid lines in the graphs of the superimposed profiles were chosen as the points for the comparison. This corresponds, in most cases, to a spacing of 5 to 10 mm between points. Figures 2.22 and 2.23 show the results for 89 points from 20 different cracks, axial and circumferential, ID and OD. A linear regression curve and 95% confidence bounds for the observed data as a function of the multiparameter estimates are shown. The intercept in Fig. 2.22 is 13.8, somewhat less than that generated from the maximum depth data, but the slope of 0.78 is almost identical to the linear regression line slope for the maximum depth data.

A set of 20 test sections analyzed with the multiparameter algorithm was destructively analyzed by PNNL in an exercise carried out before the 23 test section set was evaluated. While these 20 test sections, prepared by doped-steam techniques, represented a small subset of the mock-up test sections, the NDE results from this set provided guidance for selecting the multiparameter approach. Many NDE techniques were evaluated before selecting the multiparameter algorithm for establishing the reference state of the mock-up flaws. The evaluated techniques include phase analysis of EC +Point data, multivariate regression analysis of EC data, multiparameter analysis of EC data with neural networks, high-frequency ultrasonics (UT) from the OD, Lamb waves, acoustic microscopy, and a combination of UT and EC data (from the ID). The multiparameter algorithm provided the best accuracy for sizing the cracks. The capability of the multiparameter algorithm for characterizing cracks from a 20-test-section set is shown in Fig. 2.24. Here, the EC depth estimates for the 10 LODSCC and CODSCC are compared with actual depths from metallographic destructive analysis. In general, estimates of flaw depth are accurate to within about 10% TW. Note that this approach to sizing would have to be reviewed if used by industry for an alternative repair criterion. The current approach to carrying out a performance demonstration is to metallographically section the specimens used. Qualifications are based on sectioning.

In Fig. 2.25, estimates of crack depths by the multiparameter algorithm are compared with estimates of maximum crack depth using +Point phase analysis at 300 kHz. Significant differences can be seen in maximum depth estimates. The comparison was made by using test sections from a 23-tube set that was destructively analyzed and profiled by fractography.

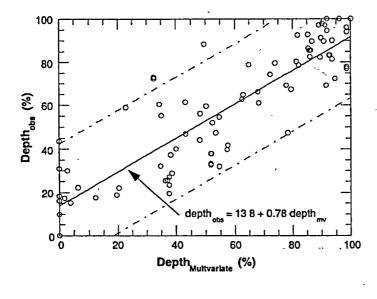


Fig. 2.22.
Comparison of depths (% TW)
determined by the multiparameter
algorithm with those by fractography and
regression fit and estimated 95%
bounds for the observed depth as a
function of the multiparameter depth
estimate.

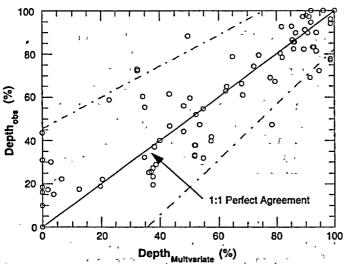


Fig. 2.23.
Comparison of depths (% TW)
determined by the multiparameter
algorithm with those by fractography. In
this case, the observed and predicted
results are shown in terms of the
"perfect agreement" 1:1 line and
estimated 95% bounds that account for
the variation in the uncertainty with
depth.

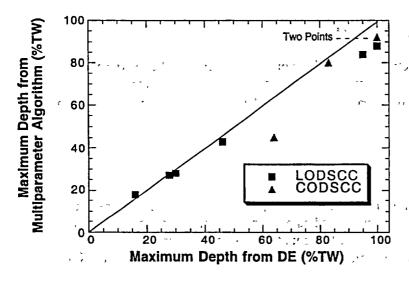


Fig. 2.24.
Maximum eddy current depth as percent throughwall (% TW) using a pancake coil and multiparameter algorithm for 10 LODSCC and CODSCC from a 20-test-section set vs. destructive analysis result.

Destructive evaluation (DE) was carried out using metallographic sectioning techniques.

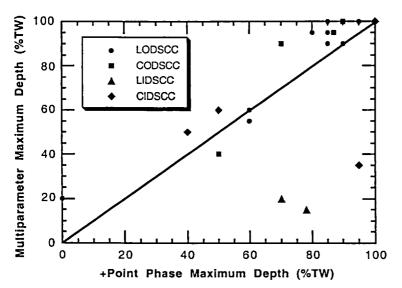


Fig. 2.25.
Estimates of maximum crack depths by the multiparameter algorithm compared with estimates using +Point phase analysis at 300 kHz.

In addition to comparing crack depths as determined by the multiparameter algorithm with those estimated by +Point phase analysis, comparisons have also been made to depth estimates from the amplitude and phase of bobbin coil signals. Figure 2.26 compares the depth as determined by the multiparameter algorithm to the maximum voltage in the bobbin coil EC signal for mock-up cracks. The correlation between bobbin coil signal amplitude and depth of mock-up cracks is poor for either free span or TSP cracks. The correlation between bobbin coil phase angle and depth of mock-up TSP cracks is also poor, as can be seen in Fig. 2.27 for LODSCC and in Fig. 2.28 for LIDSCC. The use of bobbin coil voltage or phase angle can result in very large errors in predicting crack depths. For example, a 3-V bobbin coil signal could be generated by cracks with depths of 25-100% TW. Predicting depth from bobbin coil phase angle is just as uncertain.

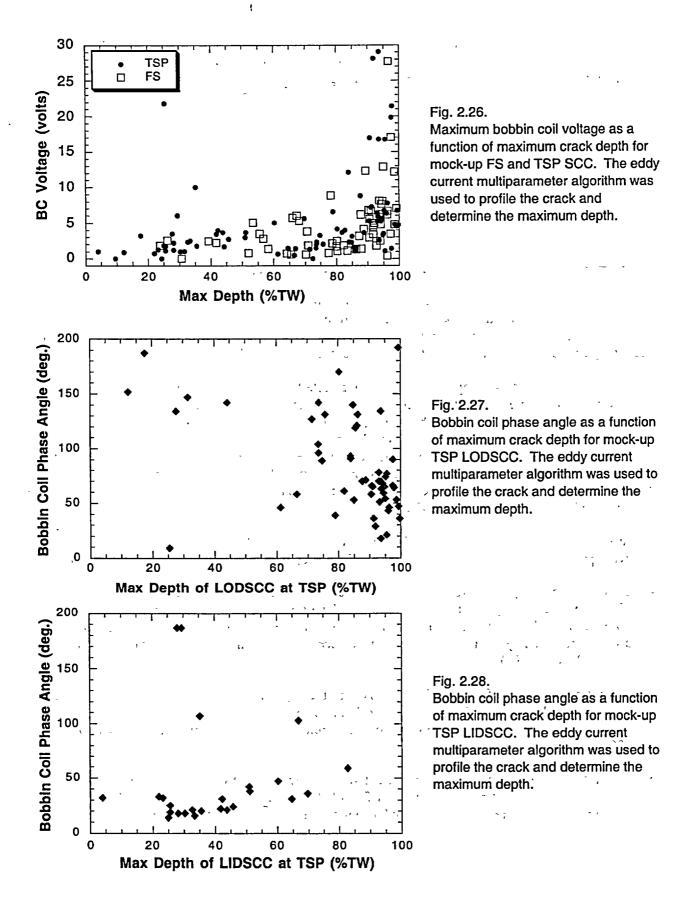
Following the completion of the RR analysis, several test sections in the mock-up were removed to further help validate the multiparameter algorithm for profiling and providing maximum depths. Figures A1-A30 of Appendix A shows profiles obtained from the multiparameter algorithm vs. fractography. The agreement is good.

### 2.1.4.4.5 Characterization of Cracks in Terms of mp

Although the probability of detection is normally expressed in terms of the maximum depth of the crack, it is also useful to express POD in terms of a parameter that better characterizes the structural integrity (i.e., ligament rupture) of the tube. A useful parameter for this purpose is m<sub>p</sub>, which is defined as:

$$m_p = \frac{p_b}{p_{sc}}, \qquad (1)$$

where  $p_b$  is the bursting pressure of an unflawed tube, and  $p_{sc}$  is the ligament failure pressure of a part-throughwall crack. The parameter can be interpreted as a stress multiplier that relates the stress in the ligament ahead of the crack to stress in an unflawed tube under the same loading. Incorporating the effect of both crack depth and length,  $m_p$  better characterizes the effect of a flaw on the integrity of a tube than



does maximum depth. For short cracks, the ligament may not correspond to tube bursting pressure. The crack may just "pop" through without increasing in length. For rectangular cracks, m<sub>p</sub> can be expressed as a function of the crack and tube geometries by using the correlation [4]:

$$m_{p} = \frac{1 - \alpha \frac{a}{mh}}{1 - \frac{a}{h}}, \qquad (2a)$$

$$\alpha = 1 + 0.9 \left(\frac{a}{h}\right)^2 \left(1 - \frac{1}{m}\right),$$
 (2b)

where a = crack depth, h = wall thickness of tube, and m = bulging parameter [4].

Although Eqs. 1 and 2a-b can be used to estimate pressure for the tip ligament rupture of rectangular part-throughwall cracks, they are not directly applicable to laboratory-grown SCC cracks, which are irregular in shape and have variable depths along their lengths. Instead of being a single planar crack, they are composed of a family of crack segments in different planes.

Currently, no widely accepted models are available for predicting the ligament failure pressure of cracks with such complex geometries. From a limit analysis viewpoint, it can be argued that the collapse behavior of a crack tip ligament with an irregular point-by-point variation of crack depth should be similar to a crack with a smoothed-out, "average" profile for crack depth. For the present, we assume that the average profile measured by the EC method is the one that is relevant for limit analysis. With this assumption, although the real crack may have short throughwall segments at a number of locations, from the standpoint of plastic collapse of the ligament, the tube behaves as if it has a smoothly varying average ligament thickness (or crack depth) profile.

Because the measured crack depth profile by ANL's EC algorithm is generally not rectangular, the following procedure was used to establish the length and depth of an equivalent rectangular crack [4]:

- Choose a crack depth  $d_0$  and assume that any crack segment with depth  $d < d_0$  does not adversely affect the crack tip ligament rupture pressure of the tube (Fig. 2.29a). In other words, replace the original crack depth profile by a new crack depth profile in which any crack segment with depth  $d < d_0$  is replaced by d = 0 (Fig. 2.29b). The choice of  $d_0$  fixes the length of the candidate equivalent rectangular crack ( $L_0$ ).
- Determine the depth of the candidate equivalent rectangular crack by equating its area to the area under the crack depth profile defined in step 1 (Fig. 2.29b). For example, in Figs. 2.29a-b, the choice of d<sub>o</sub> = 50% fixes the length and depth of the candidate equivalent rectangular crack at 9 mm and 70%, respectively.
- Generate a series of candidate equivalent rectangular cracks by parametrically varying d<sub>0</sub> and calculate the ligament rupture pressures for all the candidates (Fig. 2.30). The final equivalent rectangular crack corresponds to the candidate with the lowest ligament rupture pressure (Fig. 2.30).

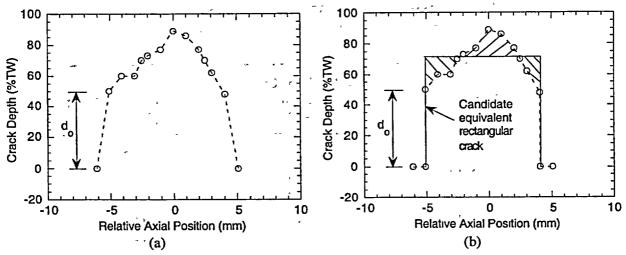


Fig. 2.29. (a) Crack depth profile measured by eddy current and (b) a candidate equivalent rectangular crack corresponding to depth  $d_0 = 50\%$  and  $L_0 = 10$  mm (0.39 in.).

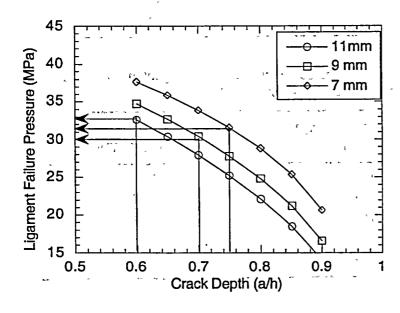


Fig. 2.30.
Ligament rupture pressures
corresponding to three candidate
equivalent rectangular cracks, 11 mm
(0.43 in.) by 60%, 9 mm (0.35 in.) by
70%, and 7 mm (0.28 in.) by 75%. The
equivalent rectangular crack is 9 mm
(0.35 in.) by 70% because these values
correspond to the lowest ligament
rupture pressure (30 MPa or 4.35 ksi).

This procedure has been automated by systematically choosing various candidate equivalent crack lengths  $L_0$  (instead of  $d_0$ ), determining the corresponding candidate equivalent crack depths, and selecting the equivalent crack length, depth, and value of  $m_p$  that correspond to the minimum ligament rupture pressure.

### 2.1.4.5 Summary of Sizing Accuracy

The RMSE values from the data of Figs. A1-A23, for various binned depth ranges, are presented in Tables 2.3 and 2.4. In Table 2.3, the depth ranges are given in terms of the metallographic depths. This is useful when assessing the capability of the multiparameter algorithm for cracks of a certain depth. In Table 2.4, the depth ranges are given in terms of the predicted depths. This is more useful when assessing the uncertainty in predicted depths. In Fig. 2.31, the standard deviation in depth (in % TW) is plotted

Table 2.3. Comparison of RMSE for depth estimates by multiparameter algorithm as a function of metallographic crack depth.

Depth Range (% TW)	RMSE Max. Crack Depth (%TW)	RMSE Crack Profiling (% TW)
0–100	13.7	15.5
30–100	9.7	-
50-100 (ODSCC only)	8.2	-
0–20	-	11.9
20-40	-	15.9
40–60	-	20.5
60–80	-	18.7
80–100	<u>-</u>	9.8

Table 2.4. Comparison of RMSE for depth estimates by multiparameter algorithm (MV) and by regression fit in Fig. 2.22 as a function of predicted crack depth.

Depth Range (% TW)	RMSE Crack Depth MP (% TW)	RMSE Crack Depth Regression (% TW)
0-20	19.5	12.8
20-40	21.0	23.0
40–60	16.3	16.1
60–80	12.2	10.6
80–100	9.8	9.5

against the maximum depth. The largest uncertainty is in the 50-70% TW range. While the deviation is small for the shallow cracks, it represents a relatively large error. For example, the standard deviation for 20% TW is 12% TW.

The overall RMSE for all cracks of all depths is 15.1%, but this value is somewhat misleading because of the significant variation in the RMSE with depth. The RMSE value is significantly better for the 80–100% TW bin than for the other depth bins.

In Table 2.4, two sets of RMSE values are given: one is based on the values obtained directly from the multiparameter algorithm, and the other on "corrected" values obtained from the regression fit shown in Fig. 2.22. For the shallowest cracks, the "corrected" values give a significantly lower RMSE value, but when all the data are considered, the differences in the RMSE for corrected and uncorrected predictions are small. This finding indicates little systematic bias in the predictions of the multiparameter algorithm, i.e., the errors are random.

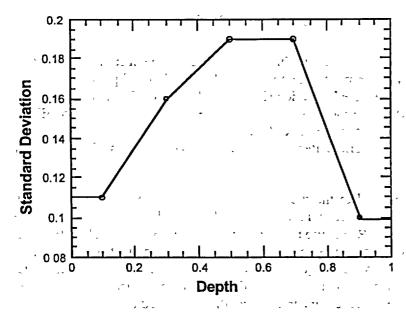


Fig. 2.31. Standard deviation in percent throughwall as a function of maximum depth.

The regression fit is very sensitive to the values at zero depth. However, these primarily reflect a problem of detection: the errors are not caused by sizing errors, but cracks that were not detected. Thus, direct comparison of the multiparameter and observed values may be a better measure of the sizing capability of the algorithm. This comparison is shown in Fig. 2.23, where the direct multiparameter predictions are used as the best estimate of the crack depth, and the 95% confidence bounds in the figure account for the variation of the RMSE with crack depth.

These results can be used to estimate the uncertainty in POD curves if the multiparameter algorithm is used to determine the "true" state of the mock-up for the NDE round-robin. Instead of characterizing the error in the depths in terms of the overall average for all depths (≈15%), the error will be taken as a function of depth. Analytically, the values of RMSE given in Table 2.4 are assumed to apply at the midpoint of the depth range for each bin. The error at other depths is then estimated by linear interpolation of these values.

#### 2.1.4.6 Reference-State Summary Table for Mock-up

The reference state table for the mock-up provides all the relevant information for analyzing the results from the round-robin analysts. Tables B1 and B2 of Appendix B highlight the primary information for a flaw in the table. The flaw type, BC volts, BC phase, whether ID or OD, three-letter code for the flaw, maximum depth as determined by multiparameter algorithm, flaw length, average depth area, and mp are all included in the flaw table. Not shown are flaw location in the mock-up (row, column, and level) and beginning and end points of the flaw, in BC data points. The test sections included in the tables are those for which mp was determined. As a result, these tables present data from the flaws that have relatively large EC signals, permitting the profiling to be carried out accurately and leading to an accurate value of mp. Table B1 shows the values for TSP SCC, while Table B2 shows the values for free-span SCC.

### 2.2 Design and Organization of Round-Robin

A very important aspect of developing the round-robin (RR) exercise was input from an NDE Task Group. The Task Group helped define the parameters found in a field inspection and provided input on how to ensure that the RR mimicked an in-service inspection (ISI). Members of the Task Group are from utilities, vendors, EPRI, NRC, and ANL. The industry members are G. Henry and J. Benson (EPRI), T. Richards and R. Miranda (FTI), D. Adamonis and R. Maurer (Westinghouse), D. Mayes (Duke Engineering and Services), S. Redner (Northern States Power), and B. Vollmer and N. Farenbaugh (Zetec).

The Task Group provided input related to the makeup of the mock-up, the quality of the data collected for the RR, the nature of the flaws, procedures for analyzing data, and documentation. The Task Group helped meet the goal of providing an RR exercise that represents, as closely as possible, a true field inspection. The Task Group provided input on the analysis guidelines, data acquisition, degradation assessment, training manual, and examination technique specification sheets (ETSSs). The RR began only after the Task Group approved the documentation used for the RR and concluded that flaws in the mock-up had EC signals similar to those observed under field conditions. In addition, opinions were expressed on the handling of spin calls, the handling of the logistics of distributing EC data to the various teams, the content of the training documentation, the makeup of the analysis team, and the equivalency demonstrations needed. As a result of the input on the analysis team, a decision was made to use a fivemember team that would include a primary, a secondary, and two equally qualified resolution analysts to analyze the EC data. The fifth member, the independent qualified data analyst (QDA), should be from a utility. The primary and secondary analysts reported their observations independently of each other. The resolution analysts reviewed calls when the primary and secondary analysts' calls differed. The independent QDA monitored the effort looking for, in his opinion, excess overcalls and sampled 40 test sections to ascertain, in his opinion, if flaws were being missed.

### 2.2.1 The Mock-up as ANL's Steam Generator

The mock-up was treated as a steam generator owned by a utility. The role of the utility in this case was taken by ANL. The ISI followed the process and procedures used by industry. ANL was responsible for preparing documentation, monitoring data collection, monitoring data analysis, and carrying out statistical analysis.

### 2.2.1.1 Responsibilities

#### 2.2.1.1.1 Data Collection

Data were collected by a qualified (according to EPRI guidelines) team from Zetec in June and again in August 1999. A qualified observer from Westinghouse was also present. The data acquisition team included a QDA Level II and a QDA Level IIIa.

#### 2.2.1.1.2 NDE Task Group

The NDE Task Group provided input on data collection during the development of the documentation. They also provided input on how to carry out the degradation assessment, how to select the ETSS, how to carry out the site-specific examinations, and how to prepare the training manual. The role of the Task Group, in general, was to help ANL mimic a field inspection.

### 2.2.1.1.3 Analysis of Round-Robin

Analysts' RR reports on optical disks were collected from RR teams by ANL proctors and converted to Excel files so they could be analyzed in a convenient manner. Proctors (ANL staff) were present during all analysts' activities to ensure that procedures developed for the analysis of data were followed correctly.

### 2.2.1.1.4 Statistical Analysis

Data were analyzed at ANL. Logistical fits to data for POD as a function of crack depth and m<sub>p</sub> with confidence limits that include errors in reference state were developed. Assistance from P. Heasler and R. Kurtz of PNNL ensured that the statistical analysis was carried out correctly. Decisions regarding the grading unit for the statistical analysis were arrived at through discussions with P. Heasler. : Section and the second section of the section of the second section of the section of the second section of the section of the second section of the section of the second section of the sectio

### 2.2.1.1.5 Documentation

The documentation prepared included the degradation assessment, the appropriate ETSS, data collection procedures, analysis guidelines, and the training manual. Detailed documentation was prepared on how the RR exercise was carried out, the sequence of events, and the role of the ANL proctors, including administration of site-specific exams.

## 2.2.2 Round-Robin Documentation

Four documents were prepared for the mock-up testing and for the RR data analysis. They are ANL001 Rev. 2 "Argonne Analysis Guideline," ANL002 Rev. 3 "Multifrequency EC Examination of Tubing within the ANL SG Mock-up," ANLO03 Rev. 3 "SG Mock-up Tubing Degradation Assessment and Technique Qualification," and ANL004 Rev. 3 "Training Manual." These documents are discussed below.

2.2.2.1 Degradation Assessment (ANL003 Rev. 3)

A "Steam Generator Tube Degradation Assessment" for flaws was prepared, per the requirements specified in NEI-97-06 and Revision 5 of the "EPRI PWR Steam Generator Examination Guidelines." In accordance with Rev. 5 of the "EPRI-PWR Steam Generator Examination Guidelines," the EPRIqualified techniques were reviewed to ensure that application of these techniques was pertinent to sitespecific conditions of the mock-up.

This document identified the degradation mechanisms in the tubing of the steam generator mockup. This assessment also identified the inspection methods to be used to ensure that the inspection techniques and personnel used for the detection and sizing of tube flaws are appropriate for all degradation mechanisms. The training document for the RR addressed the handling of anomalous The state of the s signals.

The degradation assessment reviewed all types of degradation in the mock-up, including the following:

(a) Intergranular attack (IGA) characterized by a uniform or relatively uniform attack of the grain

boundaries over the surface of the tubing. When the occurrence is over a relatively large extent exhibiting three-dimensional features, the IGA is referred to as volumetric IGA. IGA is associated with the outside diameter of the tubing material. The IGA present in the mock-up is not mixed with SCC, a combination that can be found in the field and is easier to detect than pure IGA. However, the IGA in the mock-up is similar to that found in several operating plants. It is representative of IGA at the Cook, Point Beach, and San Onofre nuclear plants, simulating the IGA found in tube sheet crevices.

- (b) Primary-water stress corrosion cracking (PWSCC), defined as cracking that occurs on the tube's primary side (the inside diameter) when a source of stress is present in susceptible material. Locations of PWSCC in the mock-up include expansion transitions and dents.
- (c) Wear, the volumetric removal of material caused by the mechanical action of one material in contact with another.
- (d) Corrosive fatigue, which is a result of alternating stress cycles produced by tube vibration that may be accelerated by a corrosion process occurring during stress cycling. A few fatigue cracks can be found in the mock-up.
- (e) Wastage that is corrosive wear to the outer wall of the tubing.
- (f) Stress corrosion cracking initiating at the outer diameter (ODSCC) of Alloy 600 steam generator tubes, which is present at the TSP, in the free span, and in the tube sheet. ODSCC refers to a range of stress corrosion cracking morphologies observed to occur along the OD of Alloy 600 steam generator tubing. Inspection requirements for this damage mechanism include 100% of the tube sheet transitions in Level A of the mock-up.

### 2.2.2.2 Data Acquisition Documentation (ANL002 Rev. 3)

The document "Multifrequency EC Examination of Tubing within the ANL SG Mock-up" provides all information necessary to collect the RR data. The procedures mimic those of an actual ISI. The basis of the data acquisition is the ETSS. The document defines the frequencies, axial and rotational speeds, and calibration procedures. Two ETSSs were developed for the ANL mock-up. These ETSSs are the result of reviewing EPRI ETSSs for the various degradation mechanisms in the mock-up and combining them into the two used.

All of the tubes were inspected over their full length with a bobbin coil. The EPRI site-qualified technique ETSS 96008, covered by ANL's ETSS#1 (described later), was used. This technique has an EPRI-reported probability of detection of 85% at >40% TW at a confidence level of 90% in those areas not associated with the roll transition.

In addition, all the tubes were inspected with a three-coil MRPC probe (Plus-Point™, standard pancake and shielded high-frequency coil) at the top of the tube-sheet region. The EPRI site-qualified technique ETSS 96403, covered by ANL's ETSS#2 (described later), was used for the detection of tube sheet flaws. This technique has an EPRI-reported probability of detection of 81% at >50% TW and a 90% confidence level for both axial and circumferential indications.

Bobbin-coil indications at TSPs were investigated with a rotating coil (Plus-Point™). The site-qualified bobbin technique for nondented TSPs is EPRI ETSS 96007, covered by mock-up ETSS#1. The EPRI-reported probability of detection is 89% at >60% TW and a 90% level of confidence. For all rotating coil inspections, the site-qualified technique EPRI ETSS 96403, covered by mock-up ETSS#2, was used. This technique has an EPRI-reported probability of detection of 81% at >50% TW and a 90% confidence level for axial and circumferential indications.

The tubing in the mock-up steam generator was mechanically expanded (rolled) in the ANL shop. The transition zone is the region of the tube where the tube transitions from the expanded tube diameter to the nominal tube. Axial and circumferential indications are found in this region. A 100% rotating coil examination of the top of the tube sheet was performed to detect PWSCC. The EPRI site-qualified technique ETSS 96508, covered by mock-up ETSS#2, was used for detection of this degradation mechanism. This technique has an EPRI-reported probability of detection of 84% at >50% TW and a 90% confidence level for both axial and circumferential indications.

Corrosion of the TSPs causes the tubing to become dented, resulting in high localized stresses that lead to stress corrosion cracking. The EPRI site-qualified Technique ETSS 96012 (covered by mock-up ETSS#1) was used for bobbin detection of axial PWSCC at TSP intersections (dent <2 V). This technique has an EPRI-reported probability of detection of 89% at >34% TW and a confidence level of 90%.

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Site-qualified technique EPRI ETSS 96508 (covered by mock-up ETSS#2) was used for rotating coil detection of axial and circumferential PWSCC at dented locations and has an EPRI-reported probability of detection of 84% at >50% TW and a confidence level of 90%.

Degradation due to wear is adequately identified by a bobbin coil examination. The technique used for detection of tube wear was EPRI ETSS 96004 (covered by mock-up ETSS#1) with an EPRI-reported probability of detection of 82% for >50% TW and a 90% confidence level.

No special examination requirements are listed in the "EPRI PWR Steam Generator Examination Guidelines" for fatigue degradation due to rapid growth rates.

Note that the EPRI-reported PODs may be determined from small sample sets, with the lower confidence limit being the stated POD. As an example, if all cracks in a set of 11 test sections were detected (100% detection), the lower 90% confidence limit is 82%, and the stated POD would be 0.82. EPRI-stated PODs are adjusted to sample size.

### 2.2.2.3 ANL Analysis Guideline (ANL001 Rev. 3)

This procedure provided the technical direction for the performance of EC examinations of the ANL SG mock-up. This procedure was applicable to all examination personnel and generally mimics industry ISI guidelines. Flaws were located by data point. Percent throughwall and the three-letter codes for the flaw types were recorded, with the exception of dents and dings. Data were reviewed for the presence of undesirable noise with the following criteria: (a) Undesirable system noise was determined by identifying electrical interference or spiking associated with faulty probes, cabling, and equipment. Studies have shown that probe wear can generate undesirable horizontal noise, resulting in poor signal-to-noise ratios. (b) Undesirable tube noise was determined by identifying signals caused by excessive permeability, pilgering, chatter, variations in tube geometry and tube cleanliness, and secondary-side sludge and deposits. These conditions were reported by the analyst so that a review could be performed to disposition these locations.

The primary and secondary analysts generated data used in the final analyst report and were responsible for reporting all indications. The resolution team (consisting of two resolution analysts and an independent QDA) performed the task of comparing and resolving discrepancies between the primary and secondary analyses. All identified differences in data interpretation were reviewed by resolution analysts to arrive at the final interpretation. The following procedures were used:

- (a) If the primary and secondary analysts agreed that an indication is a flaw, it was reviewed by two resolution analysts. The independent QDA has the final say if there is no consensus on the call.
- (b) If the primary and secondary analysts both give the "no detectable degradation" (NDD) call for a test section, there was no further analysis.
- (c) If the primary and secondary analysts disagreed, the disagreement was resolved by the two resolution analysts. If the resolution analysts were not in agreement, the independent QDA made the final call.

Table 2.5 shows an example of the data recorded by the analysts. The row and column of the test section was entered along with the voltage, phase angle, % TW, EC analysis channel (CH), location by data point, three-letter code, and whether ID or OD.

## 2.2.2.4 Training Manual (ANL004 Rev. 3)

A training manual was developed for review by all analysts before the RR exercise. The manual provided information on the mock-up design, including a schematic diagram, listing of type of artifacts present, a discussion regarding the presence of the circumferential markers, discussion of how the data for the RR were acquired, and a table showing the format for entering data. Examples of mock-up bobbin coil data (Eddynet 98 line traces and Lissajous figures), followed by MRPC data (isometric plots) for the various types of flaws present, were provided. The types of flaw included LODSCC and CODSCC at the top of the tube sheet (TTS) with and without sludge, LODSCC at TSP and at a free span location, CODSCC at a free span location, PWSCC at dented TSP and at top of the tube sheet with and without sludge, free span ding with and without an LIDSCC, fatigue crack, and degradation resulting from IGA.

## 2.2.2.5 Preparations for Examination Technique Specification Sheets (ETSSs)

Before development of the mock-up ETSSs, the essential variables for all EPRI-qualified techniques were reviewed. This procedure ensured that the applications of the EPRI techniques are pertinent to site-specific conditions for the mock-up steam generator.

The EPRI Appendix H EC techniques used during the examination of the steam generator mock-up were reviewed to determine their applicability to the site-specific mock-up conditions. The tube bundle degradation was investigated to support the Appendix H technique qualifications.

Three classifications of EC techniques are available: "site-qualified," "qualified," and "nonqualified."

"Site-qualified techniques" have an EPRI Examination Technique Specification Sheet (ETSS) for detection and/or sizing. The ETSSs have been reviewed for similarity and applicability to the mock-up conditions. For degradation previously "detected" in the mock-up, the EC signals have been compared to the EPRI signals to classify the technique as site-qualified. Damage mechanisms in the mock-up have site-qualified techniques for detection. The ETSSs for the round-robin are given in Appendix C.

Table 2.5. Example format for entering data

SG	ROW	COL	VOLTS	DEG	% TW	СН	LOC (Data Point)	UTIL 1	UTIL 2
11	F ·	19	4.23	174	^O	P1	+2383	DNT	^ <b>OD</b> - '
11	В	20	3.67	110 ິ	50	, P 1	+2578	DSI	OD "
11	В	15	1.31	13	-33	P1	+3789	NQI	ID
11	F C	14	0 32	109	52	P1 '	+3299	NQI -	OD
11	D	3	3.1	180	0	P 1	+2678	DNT	
· 11	$\mathbf{E}_{\pm}$	8	1.51	, 125	30 ~	<sub>1</sub> P 1	+2276	NQI	OD .
11	F	6 .	2.36	88	68	6	+6578	ADI -	OD -
11	Ε .	7 '	2.98	181	0	P1	+2386	DNG	
11	, G	13	4.56	125	30	P 1	+2768	, DTI ,	OD
11	- <b>E</b> .	8	2.61	89	66	6	+3287	VOL	OD
11	A	15	1.76	76	80	P2	+2367	SCI	ID
11	I	17	2.67	89	66	<sub>.</sub> 6	+987	SAI	OD
11	, <b>G</b>	11	4.7	₹105	-50	- 6/P	, +1224	MVI	OD .
11	Α	5	3.8	98	40	P2	+3398	MCI	OD
11	D	3	1.6	15 .	,40	P1	+2688	DNI	, ID ,
11	<b>B</b> .	22	3.45	76	₹80 ₹	· 6	+3267	MAI	OD

## 2.2.3 Acquisition of Eddy Current Mock-up Data and Description of Data Acquisition Documentation

The qualified Level II Operator was responsible for acquiring examination data and for the quality of that data. This Operator reviewed all calibrations performed, for acceptance. The Level III Examiner was responsible for all aspects of the examination task: establishing the essential variables for the examination, approving the procedures to be used and making changes when required, recommending the appropriate examination technique(s), providing judgment on data quality issues, resolving analysis discrepancies, and evaluating data.

The equipment used for data acquisition was the Zetec MIZ-30(A) Digital Multi-frequency Eddy Current Instrument used with Zetec Eddynet Software for data acquisition and analysis. The electronic instrumentation of the EC system was certified. A Hewlett-Packard computer, compatibly configured to operate the EC instrument and associated controllers and fixtures, was used for data acquisition.

Removable-media data storage devices, such as optical disk drives and disks, of a type compatible with the EC system and operating software were used.

The EC probes were specified on the appropriate technique sheets. For each examination, the manufacturer, description or part number, type, and size and length of probe used were reported on the summary form recorded with each calibration group.

The calibration tube standards were manufactured from a length of tubing of the same nominal size and material type as that of the tubing examined. The tubing size and material type are listed on each technique sheet.

The inside surfaces of all tubes to be examined were as clean as practical and free of obstructions or other extraneous matter. For bobbin probe examination, the scan included the full length of each tube scheduled for examination, unless specified differently in the inspection plan. For rotating-probe examination, the scan was as specified in the inspection plan. Bobbin-coil examination data were acquired during probe retraction (pull). The scan direction for rotating examination may be during probe insertion or retraction (push or pull).

During June and August of 1999, a qualified three-man team from Zetec collected data from the mock-up (Fig. 2.32); an observer from Westinghouse was also present. The data acquisition team included a QDA Level IIa and a QDA Level IIIa. Data were acquired with a 10-D pusher-puller, MIZ30 with 36-pin cables, and Eddynet software. BC data from a mag-biased probe were collected from all 3600 test sections of the mock-up. The BC data were calibrated before and after the 4-h interval required to collect the data. No change in voltage from the standard was detectable during this time period. A magnetically biased, rotating, three-coil probe that includes a +Point, 2.9-mm (0.115-in.)-diameter pancake and high-frequency shielded coil was used to collect data from all 400 tube-sheet test sections and all special-interest (spin call) test sections. A comparison of magnetically biased and unbiased coils showed that biasing eliminates the voltage shift and noise in the +Point EC signal resulting from tube sensitization.

The BC data were taken at 0.53 m/s (21 in./s), maintaining a digitization rate of 15 samples/cm (37 samples per in.). Bobbin coil data were taken at 400, 200, 100, and 20 kHz (differential and absolute). MRPC data were gathered from all degraded test sections in addition to hundreds of clean test sections and test sections with artifacts. An ASME standard and a standard with 18 ID and OD axial and circumferential EDM notches (20, 40, 60, 80, and 100% TW) were used for calibration. MRPC data were taken at 900 rpm and an axial speed of 12.7 mm/s (0.5 in./s) to maintain a digitization rate of 12 samples/cm (30 samples per in.) in the circumferential direction and 30 in the axial direction. Data were taken at 600, 400, 300, 200, and 100 kHz. Nine +Point probes were used during this exercise because of probe wear. MRPC probes were replaced when one of the channels could not be nulled. This condition appears on the computer screen as an alert "flag."

All data were recorded on 2.6-GB magneto-optical disks. Two copies of the master disk were made, and all the data were copied to an ANL archive computer backup system. The setup for the bobbin coil and +Point probe matches or exceeds the specifications of the ETSSs qualified for the flaws in the tube bundle.

The mock-up data collected by Zetec were analyzed at ANL (by ANL personnel) with Eddynet98 software. The locations of the flaw signals were checked against the location data of the flaw map. Locations of possible dings due to assembly that could lead to significant EC signals were noted. These dings could be created if a test section were inadvertently pressed against the simulated TSP during assembly.

During summer 1999, a recognized industry expert reviewed the bobbin coil data from the ANL steam generator mock-up and some of the MRPC data acquired by Zetec. The overall quality of the data was judged to be good, generally representative of field data and meeting or exceeding requirements for qualified techniques. For IGA, the examples in the mock-up are pure IGA, and not mixed with other

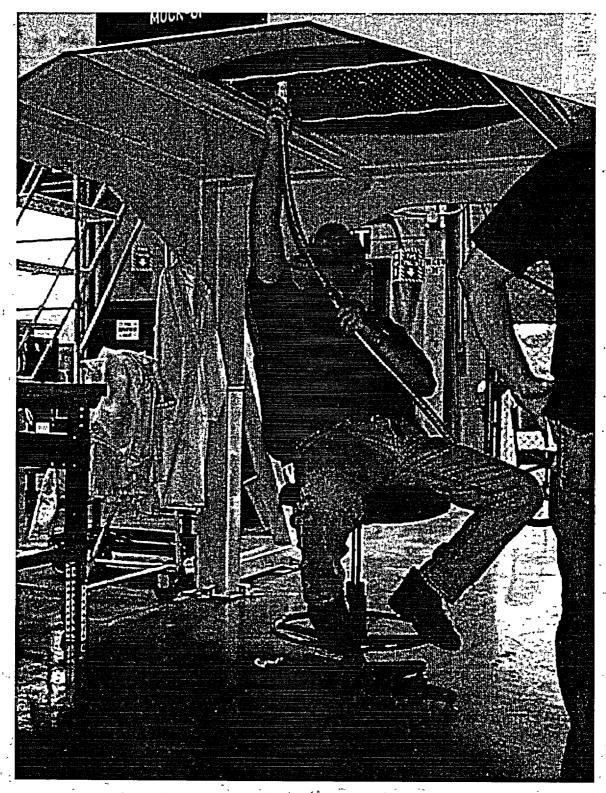


Fig. 2.32. Photograph of underside of tube bundle. Conduit carrying the EC probe is shown being positioned under a tube.

cracks. The mock-up IGA is representative of IGA at the Cook, Point Beach, and San Onofre nuclear plants, simulating IGA found in the tube sheet crevice. As a result of this data review, important knowledge on how to prepare the site-training document was acquired.

### 2.2.4 Examination Technique Specification Sheets

The Examination Technique Specification Sheets (ETSSs) developed for the RR are included in Appendix C. There are two ETSSs, one for the bobbin coil and one for the three-coil MRPC, which includes a mid-range +Point coil. The ETSSs provide the parameters for collecting and analyzing the RR data.

### 2.2.5 Participating Companies and Organization of Team Members

Companies participating in the RR provided a list of analysts who would be available to participate. For those companies who supplied more names than would be needed, ANL selected the team members by random picks from the list provided. The team members were expected to be available during the entire exercise, generally seven to eight working days. Analysts were generally QDA Level IIa or III. The resolution analysts and independent QDAs were Level III or IIIa. During the RR exercise, the primary and secondary analysts did not communicate with each other or the resolution analysts. Upon submitting their reports, the primary and secondary analysts could discuss the reports with the resolution analysts, but the reports were not changed as a result. The resolution analysts provided the report used for establishing POD.

### 2.2.6 Review of Training Manual by Teams

Team members reviewed the training manual either the day before or the same day that the ANL proctor arrived with the mock-up data and site-specific tests. The analysts were able to review the types of degradation in the mock-up and typical EC signal responses. They also carefully reviewed the mock-up geometry and became familiar with the EC signal response from test-section ends, as well as from roll transitions, TSPs, and the run-out section of the mock-up. The analysts reviewed the reporting procedure and could ask questions related to the training manual, to be answered by ANL staff.

### 2.2.7 Sequence of Events during Round-Robin Exercise

Before the RR exercise was started, a training manual, supplemental schematics, and final reports for the training data were sent to the teams for review. The training optical disk was either sent for review before the exercise was started or was provided by the proctor on his arrival. The ANL proctor arrived at the analysts' site with exams, documentation (analysts' guidelines, etc.), and optical disks containing all the data to be analyzed. The proctor provided nondisclosure agreements signed by all analysts participating in the RR and collected all analyst certifications. After the analysts finished studying the training manual, analyst guidelines, the training disk, and supplemental schematics, the ANL proctor gave and graded the written and practical site-specific exams. The passing grade for the written exam was 80%. For the bobbin-coil practical exam, the analysts had to correctly call all "I" codes without excessive overcalling. For the MRPC data the analysts had to correctly indicate the presence of all cracks and their orientations (circumferential vs. axial). About 10% of the analysts had to take the second practical exam, which they passed. The ANL proctor retrieved the exam disk after testing was complete. The process of evaluating the analysts closely followed standard industry practice. After the analysts completed the site-specific exam, the proctor provided a third disk containing all bobbin coil

data. The primary and secondary analysts analyzed the BC data, and their reports were recorded on the disk. The resolution analysts resolve the primary/secondary discrepancies. A resolution analyst's report was provided along with the primary and secondary analyst reports. The Argonne BC disk contained primary, secondary, and resolution analysts' reports for BC data at the conclusion of the BC analysis. The proctor collected hard copies of these reports and the data disk.

The ANL proctor then provided a fourth disk containing MRPC special-interest data. The primary and secondary analysts analyzed the MRPC data, and their reports were recorded on the disk except for tube sheet data, which were analyzed later. Analysts reported the depth at maximum amplitude and location information, following instructions in the training manual. The resolution analysts resolved the primary/secondary discrepancies. A resolution analyst's report was provided. Upon recording the special-interest data, the special interest disk contained primary, secondary and resolution analysts' reports for MRPC data at other than the tube sheet level. The proctor collected hard copies of these reports and the data disk.

The ANL proctor then provided a fifth disk containing only tube-sheet (Level A) MRPC data from all 400 tubes. The primary and secondary analysts analyzed the data of the tube sheet level and provided their report. The resolution analysts resolved any discrepancies and provided their report. The completed tube sheet disk contains primary, secondary, and resolution analysts' reports for the tube sheet. The report was printed and the hard copy given to the ANL proctor, who also collected the data disk.

After testing, the proctor returned to ANL with all the optical disks containing the analysis reports for the team.

## 2.2.8 Data Analysis Procedures and Guidelines

All flaw indications were evaluated. Indication types to be reported were characterized by the frequencies or frequency mixes that were qualified. For indication types to be reported in terms of depth, a means of correlating the indication depth with the signal amplitude or phase was established and based on the basic calibration. Flaw depth was reported in terms of percentage of loss of tube wall. For axial and circumferential flaws reported with MRPC, depth was determined from the "hit" that provides the greatest amplitude. For circumferential cracks, the maximum depth was determined from axial cuts through the crack. Reported indications of possible tube wall degradation were described in terms of the following, as a minimum:

- (a) The location along the length of the tube with respect to the actual data point, as appropriate for the technique used. For MRPC data, the circumferential location was defined by the data point of the flaw called.
- (b) The depth of the indication through the tube wall, when applicable.
- (c) The signal amplitude.
- (d) The frequency or frequency mix from which the indication was evaluated.

In addition to the ANL documents, the analysts were given an errata sheet with eight corrections and two procedure changes. The errata sheet indicated additional three letter codes to be used, clarifications regarding setting of span and inputting of data, and corrections to references in documentation provided. The changes involved clarification regarding how to input MRPC data for

complex flaws (at a maximum, four indications were recorded for a given axial position) and a channel change for the voltage normalization of the high-frequency coil of the three-coil MRPC probe.

## 2.3 Comparison of Round-Robin Data Acquisition and Analysis to Field ISI

The RR exercise very closely mimics a field ISI. Procedures, equipment used, and documentation are based on those used by industry for inspection of steam generators. Similar to field inspections, a Zetec MIZ30 instrument, along with a 10-D pusher-puller and Eddynet 98 software, were used to collect the data. A standard magnetically biased bobbin coil and an MRPC with 0.115 pancake, +Point, and 0.080 shielded high-frequency pancake coils were used. Round-robin teams used Eddynet98 software to analyze the data. While flaws and flaw responses have been shown to be representative of those in the field, the mock-up is mechanically different from a steam generator. There are no U-bends in the mock-up. Test sections are in contact with each other, resulting in strong EC signals similar to a 360° 100% TW circumferential crack at the test section ends. The analysts, through training and practice, easily adjusted to these signals, and there is no indication that the PODs reported are compromised by this mechanical arrangement. Another physical difference is the presence of a circumferential marker at the bottom of each test section. Again, through review of training examples, the analysts quickly adjusted to the marker signals, and their presence appears to have had no effect on the POD results.

Noise levels in the mock-up data are generally lower than those in field data. Although many of the test sections had sludge and magnetite on the OD, many test sections with flaws did not. Noise as severe as that in the U-bends of plants such as at Indian Point 2 was not present in the mock-up free span and TSP levels. A review of BC field data from seven plants provided a rough estimate of the noise from a bobbin-coil field inspection. Baseline noise in the bobbin-coil voltage trace of field data was generally about 0.7 V (excluding noise from U-bends and tube sheet). The mock-up BC baseline noise level was less, about 0.3 to 0.4 V. This low noise suggests that the results from the mock-up are an upper limit on POD for the TSP and free-span levels for flaws with low-voltage bobbin coil signals. While a deep crack is possible with a low BC voltage, the difference in baseline noise levels between the field and the mockup would possibly affect the POD for shallow cracks and possibly to have a significant effect on the logistic fit. Noise in the mock-up tube sheet level, however, was significant and did play a role in the ability of analysts to detect and correctly characterize the flaws in and around the roll transition zone (RTZ). The tube sheet noise is present in the mechanically expanded portion and in the roll transition. Variation in the geometry of the RTZ contributed to the difficulty of analyzing data from the tube sheet and can be seen in the three examples of flaw-free tube sheet sections in the mock-up test, presented in Figs. 2.33-2.35. For comparison, an isometric plot from McGuire field data is presented in Fig. 2.36. The McGuire and mock-up RTZ geometries are similar.

As in field inspections, the analyst involved with the RR decides whether the quality of the data is sufficient to analyze for flaws. In one example from the field (Union Electric Callaway), the bobbin coil was replaced when the Vpp exceeded twice the initial control level (from a reference tube). In the RR, the quality of the bobbin coil data did not vary during the time that BC data were collected. At Callaway, for example, the signals from notches in the standard must be clearly discernible from background noise when MRPC data are collected; otherwise, the probe is replaced. A similar protocol was followed for the RR, except that if the MRPC probe could not be nulled, it was replaced. This procedure led to high-quality MRPC data from the mock-up test sections.

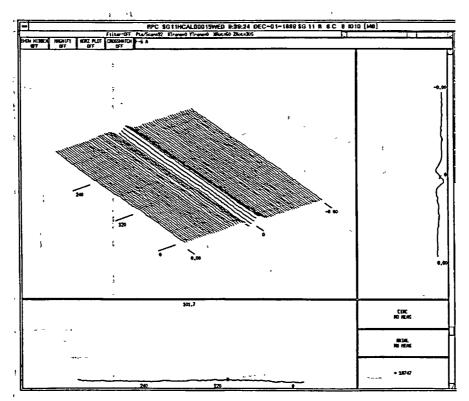


Fig. 2.33. Isometric plot of mock-up roll transition from tube-sheet-level data collected by rotating +Point coil at 300 kHz (example 1).

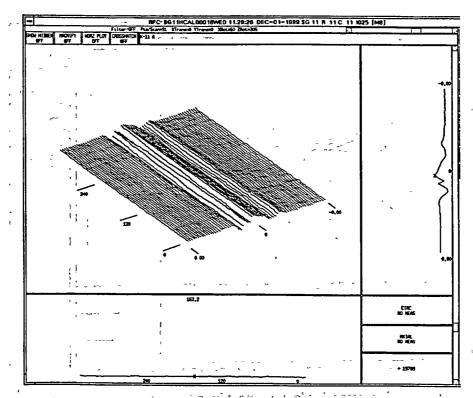


Fig. 2.34. Isometric plot of mock-up roll transition from tube-sheet-level data collected by rotating +Point coil at 300 kHz (example 2).

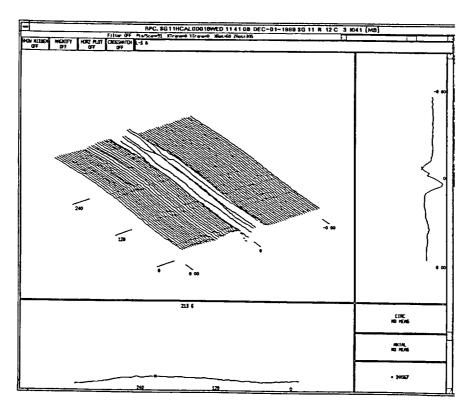


Fig. 2.35. Isometric plot of mock-up roll transition from tube-sheet-level data collected by rotating +Point coil at 300 kHz (example 3).

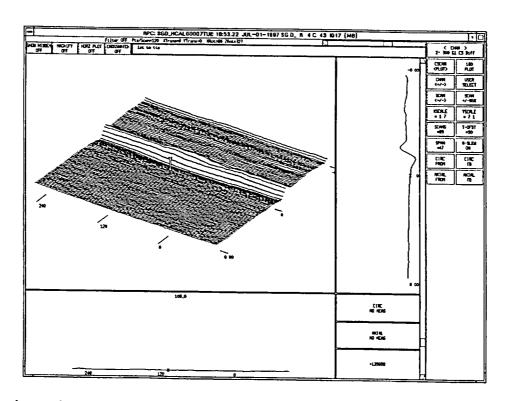


Fig. 2.36. Isometric plot of roll transition in tube sheet from McGuire steam generator.

Parameters set for the probes are typical of ISI and are detailed in the earlier section (2.2.4) on Examination Technique Specification Sheets. The 100, 200, 300, and 400 kHz frequencies used for the BC are standard for the industry and allow use of the conventional 100-400 kHz mix to suppress the TSP indication. The range of frequencies used for the MRPC data covers the requirements of the EPRI ETSSs for flaws present in the mock-up. The mock-up may have a greater variety of flaws than might be present in any given steam generator. Nevertheless, the analysts are familiar with the EC responses to all types of flaws in the mock-up, as demonstrated by their passing the EPRI personnel qualification exams. The variety of flaws in the mock-up does not affect the POD results. Figures 2.37 to 2.43 present examples of EC data (BC as well as MRPC) obtained from Eddynet 98 software for a variety of flaws in the mock-up.

Reporting requirements are slightly different for a field ISI. The analyst reports for the mock-up have an extra column showing whether the flaw indication is OD or ID. In addition, the location of an indication is given by data point, not number of inches from a physical reference. Another variation from conventional reporting is that no more than four flaws (two axial and two circumferential) are reported for any given axial location. These variations from standard practice were necessary so that an RR exercise could be completed in a reasonable time (7-8 days) and provide as much information as possible while not negatively affecting the work of the analysts. These variations are carefully described in the training manual and analyst guidelines. The analysts made the adjustment to the mock-up reporting requirements quickly.

A primary objective of the RR is to establish the POD for deep flaws. While some deep flaws may result in relatively low EC signal amplitude, deep flaws generally have high signal amplitudes. As a result, although the voltage histogram for the mock-up flaws looks reasonable, more high-voltage signals are present than expected from a field inspection. A review of field data, such as from McGuire (a better than average plant), shows that while BC signals from TTS can be many volts in amplitude (i.e., >10 V), the signals from the TSP regions are primarily less than 3 V, with most being less than 1 V in the 100-400 kHz mix channel. Stronger TSP flaw signals can be found in the mock-up because of the emphasis on deep flaws.

Analysis training and testing for the RR are comparable to those for a field ISI. For example, after a recent outage at the Union Electric Callaway Plant, a training class was presented on examples of the Callaway Plant's active degradation as well as potential degradations: ding and free-span OD cracking. This protocol is virtually the same as for the mock-up except that a formal class was not arranged. At Callaway, personnel performing the data analysis were required to successfully complete a site-specific performance demonstration involving bobbin coil and MRPC data prior to performing any data analysis. The written exam covered design, data acquisition, and analysis. The practical exam covered in-situ tubes with calls based on expert opinion. Overcalls were allowed for up to 10% of all intersections. Passing required a correct call as to whether a crack is axial or circumferential. For rotating probe data, 100% on detection and orientation is required to pass the test. This protocol on testing is identical in every respect to that for the ANL mock-up.

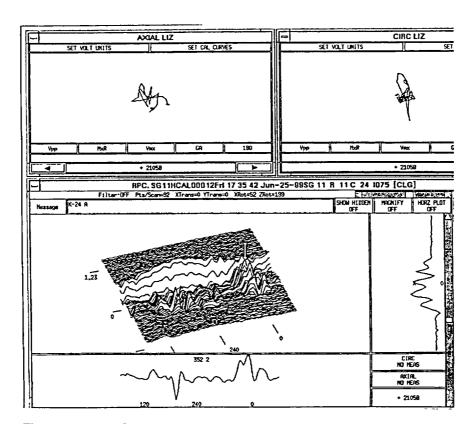


Fig. 2.37. MRPC data plotted for LODSCC at TS with sludge.

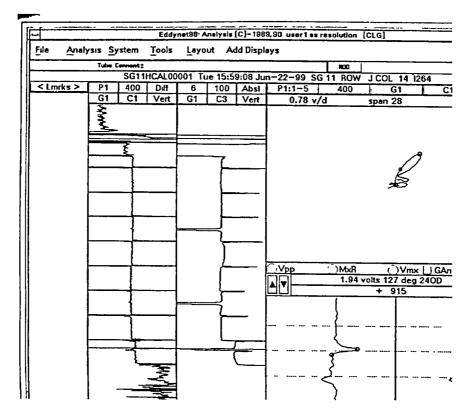


Fig. 2.38. BC data plotted for LODSCC at TSP.

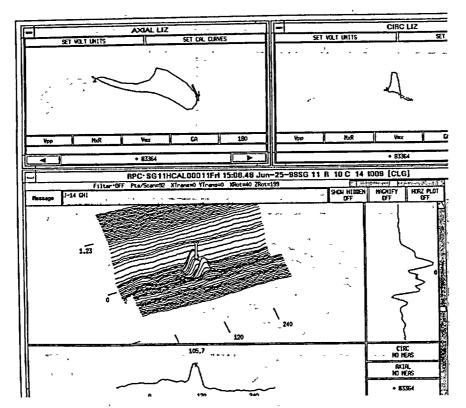


Fig. 2.39. MRPC data plotted for LODSCC at TSP.

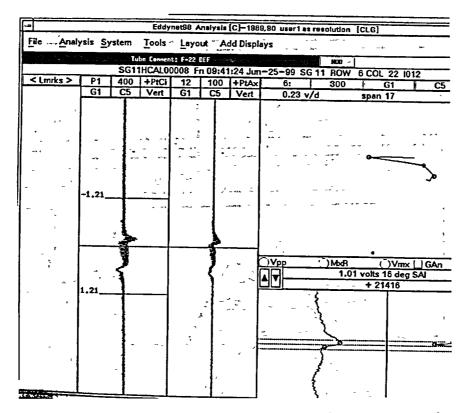


Fig. 2.40. BC data plotted for LIDSCC in dent at TSP.

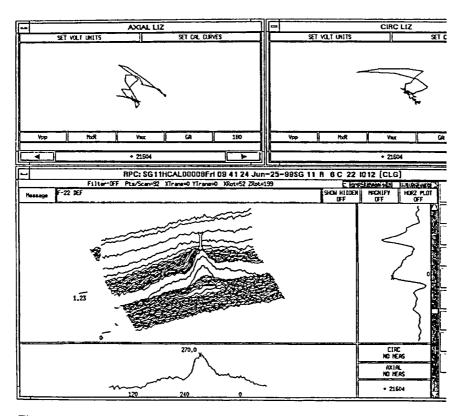


Fig. 2.41. Isometric plot for LIDSCC in dent at TSP.

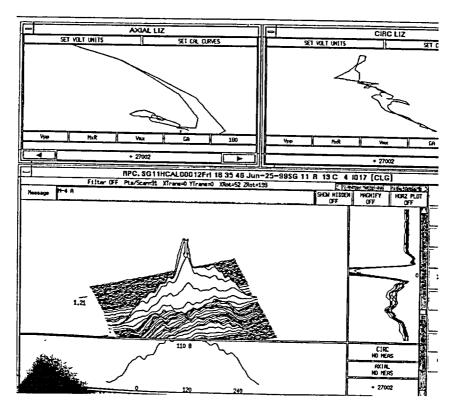


Fig. 2.42. Isometric plot for CIDSCC at TS with sludge.

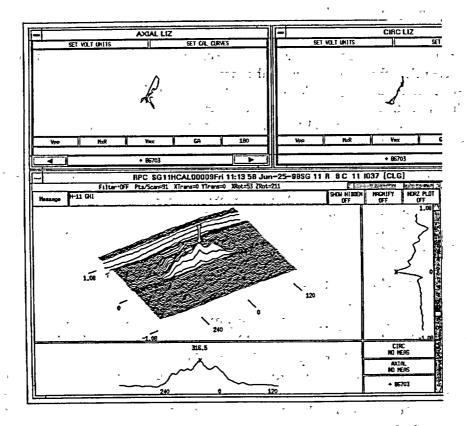


Fig. 2.43. RPC data plotted for IGA at TSP.

## 2.4 Strategy for Evaluation of Results

### 2.4.1 General Principles

The POD has been determined for the flaws in the mock-up as a function of flaw type and flaw location (i.e., free span, TSP, and tube sheet). The PODs have been plotted against maximum depth, m<sub>p</sub>, average depth, and, for the case of circumferential cracking, area. Logistic fits have been calculated and include errors in depth sizing and false call rates. Upper and lower 95% confidence limits are included in the logistic fit curves. An analyst is given credit for detecting a flaw if the call is an "I" code (e.g., NQI, DNI, DTI for BC calls, MAI, SAI, SCI, MCI, and MMI for MRPC calls) and the location is within 25 mm (1 in.) of the ends of the flaw.

## 2.4.2 Tolerance for Errors in Location (1)

The location error allowed for calls made from bobbin coil data is 25 mm (1 in.) from either end of the flaw along the tube axis. This allowed error converts to 30 data points for bobbin coil data. For MRPC data the error allowed in the axial direction is also 25 mm (1 in.) from the ends of the flaw along the tube axis. This allowed error converts to 3000 data points for the MRPC data.

### 2.4.3 Handling of False Calls

Analysts' reports were used to determine the false call rate. The rate was determined from a review of randomly selected flaw-free test sections in the mock-up and the number of "I" codes called in those test sections. An "I" code call (NQI, DTI, DNI) signifies a flaw indication in the section, even though no flaw was actually present. In total, 522 test sections were analyzed. No known stress corrosion cracks were in any of the test sections. With 11 teams, there were 5742 chances to make a false call. The result was 6% for the tube-sheet level using MRPC data, 1.7% for the TSP with BC data, and 0.1% for the free span with BC data. These rates are low enough to avoid any consideration of penalizing the analysts for false calls. The false call rates for the TSP and free span are lower than in field inspections because of the lower noise levels in the mock-up. The false call rate for the tube sheet is of the same order found in the field. Since higher false call rates would lead to higher POD curves, the results presented in this report could be considered conservative. However, even doubling the false call rate would have no discernible effect on the POD curves presented in this report.

### 2.4.4 Procedures for Determining POD

Data from the eleven teams participating in the RR exercise were first handled by using the EPRI "Shell" program, which had been loaded into an ANL computer. The optical disks used by the analysts contained the analysts' reports and were read by the "Shell" Program. The program sorted the data. Calls from primary, secondary, and resolution analysts were compared to the results of expert opinion. Note that the comparison to expert opinion is not the result sought because expert opinion does not always provide the true state of the flaws. The reference state of the flaws was provided by the ANL flaw characterization algorithm, which uses a multiparameter approach to analyzing the EC data taken at multiple frequencies. All POD curves use the depth estimates determined by analyzing the EC data with the multiparameter algorithm. Three reports were analyzed for each team for each of the three parts of the RR: the bobbin coil data, the MRPC tube sheet data, and the MRPC special-interest (spin call) data. The "Shell" program sorted the data by degradation and, for LODSCC at the tube support plate, by voltage. The principal advantage of using the "Shell" program is the ability to transfer the analysts' reports into an Excel file, which can then be used to carry out the statistical analysis. Table 2.6 gives the number of teams analyzing the three data disks. One team was not able to complete the Special Interest MRPC disk. Table 2.7 summarizes the information provided by the EPRI "Shell" program.

Indication tables are generated for both bobbin coil and MRPC data and compared with the Flaw Indication Table, which contains all the information needed to estimate POD.

Tables 2.8 and 2.9 show simulated inputs to the Flaw Table and the Flaw Indication Table for a bobbin coil inspection. Table 2.8 shows input for a flaw in row A, column 7, at TSP level D, where the maximum BC voltage is at data point 1865 (as noted in the column "Flaw ID"). The flaw is a longitudinal ID with a BC voltage of 2.04 V and phase angle of 25 degrees. The flaw begins at data point 1839 and ends at 1873. About 3600 data points are stored for each tube examined with the bobbin coil (nine test sections). Table 2.8 shows the estimated depth to be 40% TW. This depth is determined by application of a multiparameter algorithm to MRPC data for the flaw. An "I" code triggers an inspection with an MRPC. The reference-state three-letter code is SAI, single axial indication. A second example is also provided in Table 2.8. The second flaw, a longitudinal ODSCC, is at row M, column 14, and free span level F. The result for the bobbin coil inspection is shown in Table 2.9. An indication was found in row A, column 7, at data point 1855, close to the correct flaw location. The ID/OD call is correct, and an "I" code is also called, although in this case it is DTI (distorted TSP indication). The DTI call also requires MRPC data to be acquired. The second indication would also be graded as a correct call.

Table 2.6. Number of round-robin analyst reports for the three data sets from the first eleven participating teams.

	Number of	Number of	Number of
3x + 3	Primary	Secondary	Resolution
*	Analyst	Analyst	Analyst
	Reports to	Reports to	Reports to
Mock-up Data Set	Date	- Date	Date
Bobbin Coil (All Tubes)	11	11	11
MRPC (All Tube-Sheet Test Sections)	11	11 .	- 11
MRPC (All Special Interest, i.e., Spin Calls)	10	10	10

Information provided by the EPRI "Shell" program using results from round-robin Table 2.7. analysts' reports.\*\*

Flaw Type	2	3	4	5	6	7	8	9	10	11	12	13	14	26	27	28	Total	31	32	Total	33	34	Total
No. of Expert Opinion Calls	*	*	*	*	*	*	*	*	*	*	* :	**	*	*	*	*	* _	*	*	.* ( ),	*	*	*
No Analyst Calls	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*
RMSE Volts	*	*	*	*	*	*	*													,			
No. of Overcalls	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*	*

<sup>\*</sup>Data generated.

<sup>\*\*</sup>Note that analysts' reports are compared to expert opinion, not to true state of the mock-up.

2	TSP/BC/ODSCC 0.25-0.49 v.	, , , , , , , , , , , , , , , , , , ,	12 TSP/BC/IGA/Free Span
3	TSP/BC/ODSCC 0 50-0.74 v.	* 5 44. 4 * .	13 BC/ODSCC/Sludge Pile
4	TSP/BC/ODSCC 0.75-0.99 v.	* * *	14 Expansion/BC/PWSCC
5	TSP/BC/ODSCC 1.001.49 v.	_ ,	26 BC/ All Dents
6	TSP/BC/ODSCC 1.50-2.99 v.		27 BC/Other
7	TSP/BC/ODSCC >3.00 v.	* * * * * *	28 TSP/BC/Thinning-Wastage/Free Spar
8	TSP/BC/PWSCC-Dent <2.0 v.	, , , ,	31 +Point/PWSCC
9	BC/ODSCC/Free Span	ti es e	32 +Point/ODSCC
10	BC/PWSCC-Ding/Free Span		33 +Point/Expansion/PWSCC
11	TSP/BC/Wear/Free Span		34 +Point/Expansion/ODSCC
	_		

Table 2.8	3. Sim		ut to flaw ta			l inspection	on. [ ]		-
Flaw ID	Flaw	BC Volts	BC Phase	ID/OD	Beg. Pt.	End Pt.	Depth (% TW)	Expert BC Call	True State Call
A07D18 65	LID	2.04	25	ID	1839	1873	40	NQI	SAI '
M14F31 77	LOD	2.61	70	OD :	3157	3192	90	NQI	SAI

Table 2.9. Simulated bobbin coil input to flaw indication table.

Indication	BC Volts	BC Phase	ID/OD	Depth Est.	Call
AO7 1855	2.14	29	ID	50	DTI
M14 3157	2.68	60	OD	80	NQI

## 2.4.4.1 Converting Site-Specific Performance Demonstration (SSPD) Results to Text Files and Excel Files

The Eddynet software provides a series of files that contain the reports of results from each analyst who participated in the RR. These data are saved under an Eddynet environment and are identified by extensions that refer to primary, secondary, and resolution analysts' reports. These files are then read by a text editor and converted into a format usable for off-line manipulation. The text files are then imported into Excel. Excel macros were written to sort the results and carry out the grading.

### 2.5 Statistical Analysis

### 2.5.1 Determination of Logistic Fits

To obtain an analytical form for the POD curve, we assume that the probability of detection as a function of depth can be expressed as a linear logistic function of x:

$$p(x) = \frac{1}{1 + e^{a + bx}}$$
 (3)

or

$$p(x) = logistic(a + bx)$$

where a and b are parameters determined by comparison with the observed results. Other forms for the POD curve can be chosen, but the linear logistic curve has been widely used for this purpose and is used in other fields to describe binomial responses (detected or not detected) [5].

The Method of Maximum Likelihood [6] is used to estimate statistical parameters such as a and b. For quantities that are normally distributed, it can be shown to be equivalent to the familiar method of least squares [5-7]. It is more generally applicable, however, and can be applied to events such as detection of cracks that are not normally distributed.

If p(x) is the probability that a crack of depth x will be detected by an inspection team, the probability that the crack will not be detected is 1-p(x). The probability that n out of N teams of inspectors will detect a crack of depth x is

$$\binom{N}{n}p^n(1-p)^{N-n} \tag{4}$$

where  $\binom{N}{n} = \frac{N!}{n!(N-n)!}$  is the combinatorial symbol. Equation 4 assumes that the teams are equally capable and are independent of each other.

The probability L that a collection of K cracks of depth  $x_1, x_2, ..., x_K$  will be detected successfully  $n_1, n_2, ..., n_K$  times is just the product of the probabilities for the individual cracks:

$$L = \prod_{k=1}^{K} {N_k \choose n_k} p_k^{n_k} (1 - p_k)^{N_k - n_k}$$
 (5)

where  $p_k = p(a, b, x_k)$ , and a and b are the parameters of the logistic fit. The Method of Maximum Likelihood seeks to determine a and b such that the probability of the observed outcome, L, is maximized. It is more convenient to deal with the log of Eq. 5:

hore convenient to deal with the log of Eq. 5:
$$\ln(L) = \sum_{k=1}^{K} \ln\binom{N_k}{n_k} + \sum_{k=1}^{K} \left[ n_k \ln(p_k) + (N_k - n_k) \ln(1 - p_k) \right]$$
(6a)

The first summation in Eq. 6a is a constant that is independent of the choice of a and b. Defining D as the second summation in Eq. 6a,

$$D = \sum_{k=1}^{K} \left[ n_k \ln(p_k) + (N_k - n_k) \ln(1 - p_k) \right]$$
(6b)

we can determine the choice of a and b that maximizes D or L by solving

$$\frac{\partial D}{\partial a} = 0$$

$$\frac{\partial D}{\partial b} = 0$$

or

$$\sum_{k=1}^{K} \frac{n_k - N_k p_k}{p_k (1 - p_k)} \frac{\partial p_k}{\partial a} = 0$$

$$\sum_{k=1}^{K} \frac{n_k - N_k p_k}{p_k (1 - p_k)} \frac{\partial p_k}{\partial b} = 0$$
(7)

Differentiating Eq. 7, we find that

$$\frac{\partial p_k}{\partial a} = -p_k (1 - p_k)$$

$$\frac{\partial p_k}{\partial b} = -p_k (1 - p_k) x_k$$
(8)

Using Eqs. 5 and 6, Eqs. 7 and 8 reduce to

$$\sum_{k=1}^{K} (n_k - N_k p_k) = 0$$

$$\sum_{k=1}^{K} (n_k - N_k p_k) x_k = 0$$
(9)

Equations 8 and 9 are a pair of simultaneous nonlinear equations for a and b. For computation, it is generally more convenient to determine a and b by algorithms that directly maximize D rather than attempt to solve these equations. Excel spreadsheets were developed for this purpose and benchmarked against the commercial statistical software package STATA.

### 2.5.2 Uncertainties in the POD Curves

Equation 9 can be solved for a and b. These values depend on the round-robin results, i.e., on  $n_1$ ,  $n_2$ , etc. If the round-robin was repeated with a different set of teams or a different set of cracks, different values would be obtained for a and b, i.e., there will be distributions for a and b. Similarly, the depths of the cracks,  $x_k$ , are not known exactly, instead we have a measured value  $\hat{x}_k = x_k + \epsilon_k$ , where  $\epsilon_k$  is the error in the measured value of  $x_k$ . The errors will be random variables. The distributions for a and b can be characterized by mean values and variances. The mean values can be found by solving Eq. 9, although it is generally easier to obtain a and b by direct maximization of D (Eq. 6b). However, Eq. 9 involves the unknown quantities  $x_k$ , where, in reality, only the measured values,  $\hat{x}_k$ , are known. If we denote the solution of the approximate equations,

$$\sum_{k=1}^{K} (n_k - N_k \hat{p}_k) = 0$$

$$\sum_{k=1}^{K} (n_k - N_k \hat{p}_k) \hat{x}_k = 0$$
(10)

which involve only the measured values,  $\hat{x}_k$  as  $\hat{a}$  and  $\hat{b}$ , then the shift or bias in the mean values due to the errors in the measured depths  $x_k$ ,  $\Delta a$  and  $\Delta b$ , can be determined by expanding Eq. 9 in terms of  $\epsilon_k$ ,  $\Delta a$ , and  $\Delta b$ . Thus

$$p_{k} = \hat{p}_{k} + \frac{\partial \hat{p}_{k}}{\partial a} \Delta a + \frac{\partial \hat{p}_{k}}{\partial b} \Delta b + \frac{\partial \hat{p}_{k}}{\partial x_{k}} \varepsilon_{k} + \frac{\partial^{2} \hat{p}_{k}}{\partial x_{k}^{2}} \varepsilon_{k}^{2} + O(\Delta a^{2}, \Delta b^{2}, \varepsilon_{k}^{3})$$
(11)

The other derivatives are

$$\frac{\partial \hat{p}_k}{\partial x_k} = -\hat{p}_k (1 - \hat{p}_k) \hat{b}$$

$$\frac{\partial^2 \hat{p}_k}{\partial x_k^2} = -\frac{\partial \hat{p}_k}{\partial x_k} (1 - \hat{p}_k) \hat{b} + \hat{p}_k \frac{\partial \hat{p}_k}{\partial x_k} \hat{b}$$

$$= \hat{p}_k (1 - 3\hat{p}_k + 2\hat{p}_k^3) \hat{b}^2$$
(12)

If only first-order terms in  $\Delta a$ ,  $\Delta b$ , and  $\varepsilon_k$  are retained in the expansion of Eq. 10, then  $\Delta a$  and  $\Delta b$  vanish. Thus,  $\Delta a$  and  $\Delta b$  are  $O(\varepsilon_k^2)$ . Substituting from Eq. 11 into Eq. 9, using Eqs. 10, and retaining only terms  $O(\varepsilon_k^2)$ , one can obtain equations for  $\Delta a$  and  $\Delta b$ . The values  $\varepsilon_k$  are not known, since they vary randomly. The average values of  $\Delta a$  and  $\Delta b$  can, however, be obtained in terms of the variance of  $\varepsilon_k$ , which is known from NDE studies of sizing errors. The final equations for the average values of  $\Delta a$  and  $\Delta b$  are

$$\left[\sum_{k=1}^{K} N_{k} \hat{p}_{k} (1-\hat{p}_{k})\right] \Delta a + \left[\sum_{k=1}^{K} N_{k} \hat{x}_{k} \hat{p}_{k} (1-\hat{p}_{k})\right] \Delta b = \left[\sum_{k=1}^{K} N_{k} (\hat{p}_{k} + 2\hat{p}_{k}^{2}) (1-\hat{p}_{k}) \hat{b}^{2}\right] \sigma_{x_{k}}^{2} \\
\left[\sum_{k=1}^{K} N_{k} \hat{x}_{k} \hat{p}_{k} (1-\hat{p}_{k})\right] \Delta a + \left[\sum_{k=1}^{K} N_{k} \hat{x}_{k}^{2} \hat{p}_{k} (1-\hat{p}_{k})\right] \Delta b = \left[\sum_{k=1}^{K} N_{k} x_{k} \hat{p}_{k} (1+2\hat{p}_{k}) (1-\hat{p}_{k}) \hat{b}^{2} - N_{k} \hat{p}_{k} (1-\hat{p}_{k}) \hat{b}\right] \sigma_{x_{k}}^{2}$$
(13)

where  $\sigma_{x_k}^2$  is the estimated variance of the errors in the measured depths. The variance  $\sigma_{x_k}^2$  can be determined from comparisons of the NDE and destructive data. It will vary with the depth of the crack.

Equations 10 and 13 give estimates of the mean values of a and b. Note that variances in dependent variables like a and b are related to the variances of the independent variables  $n_k$  and  $x_k$  through the propagation of error equations:

$$\sigma_{a}^{2} = \sum_{k=1}^{K} \left[ \sigma_{n_{k}}^{2} \left( \frac{\partial a}{\partial n_{k}} \right)^{2} + \sigma_{x_{k}}^{2} \left( \frac{\partial a}{\partial x_{k}} \right)^{2} \right]$$

$$\sigma_{b}^{2} = \sum_{k=1}^{K} \left[ \sigma_{n_{k}}^{2} \left( \frac{\partial b}{\partial n_{k}} \right)^{2} + \sigma_{x_{k}}^{2} \left( \frac{\partial b}{\partial x_{k}} \right)^{2} \right]$$

$$\sigma_{ab}^{2} = \sum_{k=1}^{K} \left[ \sigma_{n_{k}}^{2} \left( \frac{\partial a}{\partial n_{k}} \right) \left( \frac{\partial b}{\partial n_{j}} \right) + \sigma_{x_{k}}^{2} \left( \frac{\partial a}{\partial x_{k}} \right) \left( \frac{\partial b}{\partial x_{j}} \right) \right]$$

$$(14)$$

The variance  $\sigma_{n_k}^2$  for a binomial process is

$$\sigma_{n_k}^2 = N_k p_k (1 - p_k)$$

The array  $\begin{bmatrix} \sigma_a^2 & \sigma_{ab}^2 \\ \sigma_{ab}^2 & \sigma_b^2 \end{bmatrix}$  is generally referred to as the covariance matrix C.

The derivatives  $\frac{\partial a}{\partial n_k}$ ,  $\frac{\partial a}{\partial x_k}$ ,  $\frac{\partial b}{\partial n_k}$ , and  $\frac{\partial b}{\partial x_k}$  can be obtained from Eq. 9. Differentiating Eq. 9 with respect to  $n_j$  gives

$$1 - \sum_{k=1}^{K} N_k \frac{\partial p_k}{\partial n_j} = 0$$

$$x_j - \sum_{k=1}^{K} N_k x_k \frac{\partial p_k}{\partial n_j} = 0$$
(15)

Differentiating Eq. 9 with respect to x<sub>i</sub> gives

$$\sum_{k=1}^{K} N_k \frac{\partial p_k}{\partial x_j} = 0$$

$$n_j - N_j p_j - \sum_{k=1}^{K} N_k x_k \frac{\partial p_k}{\partial x_j} = 0$$
(16)

The partial derivatives of pk can be expressed in terms of the derivatives of a and b:

$$\begin{split} \frac{\partial p_{k}}{\partial n_{j}} &= \frac{\partial p_{k}}{\partial a} \frac{\partial a}{\partial n_{j}} + \frac{\partial p_{k}}{\partial b} \frac{\partial b}{\partial n_{j}} \\ &= -p_{k} (1 - p_{k}) \frac{\partial a}{\partial n_{j}} - p_{k} (1 - p_{k}) x_{k} \frac{\partial b}{\partial n_{j}} \\ \frac{\partial p_{k}}{\partial x_{j}} &= \frac{\partial p_{k}}{\partial x} \frac{\partial x}{\partial x_{j}} + \frac{\partial p_{k}}{\partial a} \frac{\partial a}{\partial x_{j}} + \frac{\partial p_{k}}{\partial b} \frac{\partial b}{\partial x_{j}} \\ &= -p_{k} (1 - p_{k}) b \delta_{kj} - p_{k} (1 - p_{k}) \frac{\partial a}{\partial x_{1}} - p_{k} (1 - p_{k}) x_{k} \frac{\partial b}{\partial x_{1}} \end{split} \tag{17}$$

Substituting Eq. 17 into Eqs. 15 gives

$$-\alpha_0 \frac{\partial a}{\partial n_j} - \alpha_1 \frac{\partial b}{\partial n_j} = 1$$

$$-\alpha_1 \frac{\partial a}{\partial n_j} - \alpha_2 \frac{\partial b}{\partial n_j} = x_j$$
(18)

where

$$\alpha_{0} = -\sum_{k=1}^{K} N_{k} p_{k} (1 - p_{k})$$

$$\alpha_{1} = -\sum_{k=1}^{K} N_{k} p_{k} (1 - p_{k}) x_{k}$$

$$\alpha_{2} = -\sum_{k=1}^{K} N_{k} p_{k} (1 - p_{k}) x_{k}^{2}$$
(19)

Equation 18 is easily solved for the partial derivatives of a and b with respect to n<sub>j</sub>:

$$\frac{\partial \mathbf{b}}{\partial \mathbf{n}_{j}} = \frac{\mathbf{x}_{j} - \frac{\alpha_{1}}{\alpha_{0}}}{\frac{\alpha_{1}^{2}}{\alpha_{0}} - \alpha_{2}}$$

$$\frac{\partial \mathbf{a}}{\partial \mathbf{n}_{j}} = \frac{-1}{\alpha_{0}} - \frac{\alpha_{1}}{\alpha_{0}} \frac{\partial \mathbf{b}}{\partial \mathbf{n}_{j}}$$
(20)

Similar expressions can be obtained for the partial derivatives of a and b with respect to x<sub>i</sub>.

Defining

$$\eta(x) = \ln\left(\frac{1-p}{p}\right)$$

$$= a + bx$$
the variance of  $\eta_j$  corresponding to the j<sup>th</sup> crack is

$$\sigma_{\eta_{J}}^{2} = \sigma_{a}^{2} \left(\frac{\partial \eta_{j}}{\partial a}\right)^{2} + \sigma_{b}^{2} \left(\frac{\partial \eta_{j}}{\partial b}\right)^{2} + 2\sigma_{ab}^{2} \left(\frac{\partial \eta_{j}}{\partial a}\right) \left(\frac{\partial \eta_{j}}{\partial b}\right)$$

$$= \sigma_{a}^{2} + x_{j}^{2} \sigma_{b}^{2} + 2x_{j} \sigma_{ab}^{2}$$
(22)

The confidence limits for  $p_j$  can be expressed in terms of  $\sigma_{\eta_i}$ :

$$p_{j} = \frac{1}{1 + e^{\eta_{j} \pm Z\sigma_{\eta_{j}}}}$$
(23)

where Z is a constant that depends on the confidence level desired.

# 2.5.3 Significance of Difference between Two POD Curves

There are a several ways to test whether two POD curves are the same. The test described below is the easiest because it only requires the logistic regression results. A logistic regression is run on two sets of data. Each regression fit has as a result a set of parameter estimates u = (a,b) and an associated covariance matrix C. The two data sets are designated by letters  $\alpha$  and  $\beta$ , and the two regression fits are described by

$$p_{\alpha,i} = logistic(a_{\alpha,1} + b_{\alpha,2} x_{\alpha,i})$$
(24)

$$p_{\beta,i} = logistic(a_{\beta,1} + b_{\beta,2} \times \beta,i).$$
 (25)

The regression fits produce the estimates  $u_{\alpha}$  and  $u_{\beta}$  along with the covariance matrices  $C_{\alpha}$  and  $C_{\beta}$ . To test whether  $u_{\alpha} = u_{\beta}$ , one forms a chi-squared statistic:

$$\chi^2 = (\mathbf{u}_{\alpha} - \mathbf{u}_{\beta})^{\mathrm{T}} \left[ \mathbf{C}_{\alpha} + \mathbf{C}_{\beta} \right]^{-1} (\mathbf{u}_{\alpha} - \mathbf{u}_{\beta}) \tag{26}$$

and compares  $\chi^2$  to a critical value obtained from a chi-squared table. The degree of freedom associated with the critical value equals the number of model parameters; in this case, two. The two sets of parameters are equal when  $\chi^2$  is less than the critical value. For example, to conduct the test at a 10% level of significance, the critical value would be 4.61.

A chi-squared table can also be used to assign a p-value to the statistic  $\chi^2$ . When performing this test, a less stringent level of significance than typical can be used, such as 10% or 20% instead of the typical 5%. This approach has been used to determine if POD curves by different teams using the same data are different by chance or if the difference is significant.

### 2.6 Results of Round-Robin Analysis

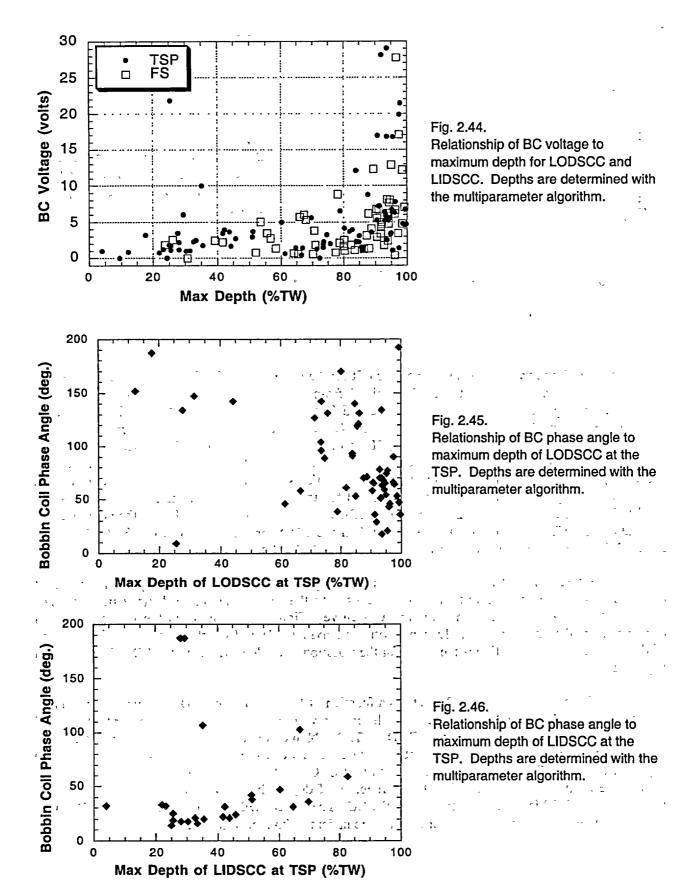
The lack of reliability in estimating the maximum depth of an SCC with either the voltage or phase angle from bobbin coil data, a well-known problem in field inspections, can be illustrated for the mock-up with results from the RR. Figure 2.44 shows the relationship of BC voltage and maximum depth (determined from the multiparameter algorithm) for LODSCC and LIDSCC. While very high voltages (>10 V) indicate deep flaws (>80% TW), lower amplitudes do not correlate with depth. The results for TSP and free span are similar. Figure 2.45 shows the relationship of BC phase angle to maximum depth of LODSCC at the TSP. For LODSCC, ideally the phase angle should increase monotonically from 40° as the depth increases. The scatter indicates the difficulty in using the BC phase angle to estimate depth. Figure 2.46 shows a similar result for LIDSCC at the TSP. For LIDSCC, the phase should increase from 0 to 40° as the depth increases from 0 to 100% TW.

# 2.6.1 POD Logistic Fits with 95% Lower Confidence Bounds

The bobbin coil voltages reported for LODSCC at tube support plates by teams analyzing the mock-up data have been statistically examined. In most cases, voltage variations identified by the teams were fairly small. For each LODSCC, an average BC voltage and a corresponding standard deviation were computed. The cumulative distribution of the normalized standard deviations (i.e., the standard deviation divided by the corresponding value of the average voltage) can be fit well by a Weibull distribution (the RMS difference between the observed distribution and the Weibull fit is <0.03). The fitted distribution is shown in Fig. 2.47. For almost 90% of the indications, the normalized standard deviation in the reported voltages is <0.15. This result is consistent with NRC Generic letter 95-05, which assumes that a 15% cutoff for the voltage-response variability distribution is acceptable. The indications with larger variations are not associated with particularly high or low voltages (i.e., approximately half the signals with standard deviations >0.1 have voltages >2 V), but are associated with the complexity of the signal and the difficulty in identifying the peak voltage.

#### 2.6.1.1 Bobbin Coil Results

The reference table shows the flaw parameters: max depth,  $m_p$ , average depth, and for circumferential cracks, the crack area and the observed POD. The flaw characterization parameters were determined from the profiles generated by the multiparameter algorithm. The results reported here are derived from the bobbin coil reports of resolution analysts from the eleven RR teams. Figures are shown for tube support plate and free-span flaws. Analysts are given credit for calling a flaw if their reported flaw location is within 25 mm (1 in.) of the ends of the flaw. The analyst's estimate of depth was not a factor in calculating POD.



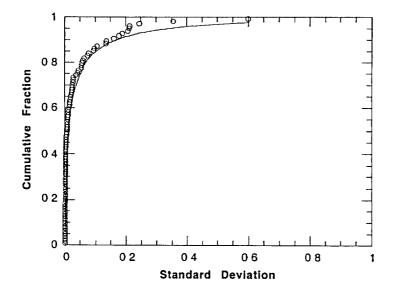
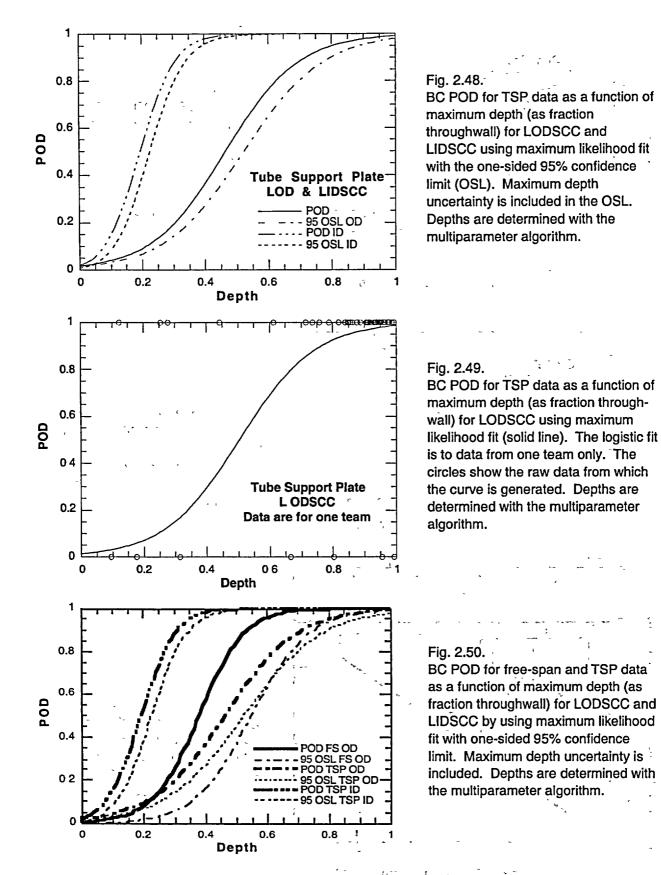


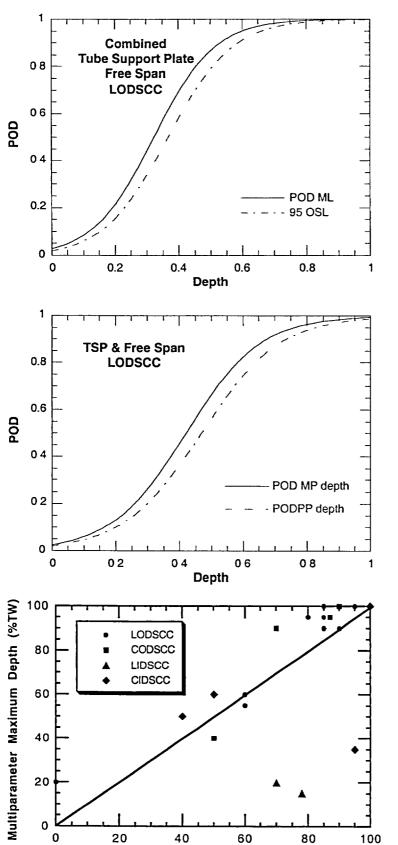
Fig. 2.47.
Cumulative distribution of normalized standard deviations for bobbin coil voltages for LODSCC at tube support plates.

Figure 2.48 shows the maximum likelihood fit for the POD with LODSCC and LIDSCC at the TSP as a function of maximum depth (as determined from the multiparameter algorithm). The NDE uncertainty in depth is included in the one-sided 95% lower confidence limit (OSL). In general, the curves have a reasonable shape, providing plausible PODs. As expected, the POD for ID cracks is higher than that for OD cracks (99% with 98% OSL at 60% TW vs. 75% with 65% OSL at 60% TW). Figure 2.49 shows raw data and the logistic fit curve for the BC POD for one of the RR teams. As can be seen, the probability of a hit is very high for the deepest flaws, which are dominant in this set of cracks. Figure 2.50 compares the POD results (with OSL) for the TSP cracks with the results for free-span cracks. While as expected the POD for free-span LODSCC (95% at 60% TW) is higher than the POD for TSP LODSCC (75% at 60% TW), it is lower than the POD for TSP LIDSCC (99% at 60% TW). Figure 2.51 shows the result when combining free-span and TSP data.

Figure 2.52 (for TSP and free span combined) compares the logistic fit when depths are estimated by ANL's multiparameter algorithm against the fit with the +Point maximum depth estimates. The +Point data result in a more conservative POD curve. Figure 2.53 compares the maximum depth estimates from the multiparameter algorithm with the maximum depth from the +Point data for a variety of flaws. This type of variation is the cause for the variation in the logistic fits to the POD data shown in Fig. 2 52.

In addition to examining the RR data as a function of flaw depth, the POD has been evaluated as a function of BC voltage for TSP SCC. The results are shown in Fig. 2.54. A pattern similar to that found for POD versus depth is observed for the POD vs. TSP bobbin coil voltage. In this figure, the percentage of correctly calling a flaw is plotted against binned data as indicated in the graph. Figure 2.55 shows the logistic fits to the POD vs. voltage data for both LODSCC and LIDSCC, along with the 95% one-sided confidence limits. In contrast to POD as a function of depth, the POD as a function of voltage for LIDSCC at the TSP is lower than that for LODSCC. The lower POD vs. voltage curve for LIDSCC is possibly the result of missing shallow cracks that are in dents with high voltages.





+Point Phase Maximum Depth (%TW)

Fig. 2.51.
Logistic fit to BC POD as a function of maximum depth (as fraction throughwall) when combining free-span and TSP data (solid line). The one-sided 95% confidence limit (dotted line) includes the uncertainty in depth.
Depths are determined with the multiparameter algorithm.

Fig. 2.52.
Comparison of the BC POD for TSP and free-span LODSCC when depths (as fraction throughwall) are estimated by multiparameter algorithm (MP) with the POD based on +Point maximum depth estimates (PP).

Fig. 2.53.

Maximum crack depth as determined by the multiparameter algorithm vs. the maximum crack depth as determined by phase analysis of +Point data at 300 kHz. Data are sorted by type of SCC.

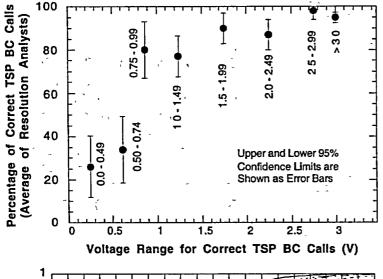


Fig. 2.54.
Round-robin resolution analysts' results as a function of BC voltage for TSP crack. The BC POD has been evaluated for LODSCC at the TSP. Depths are determined with the multiparameter algorithm.

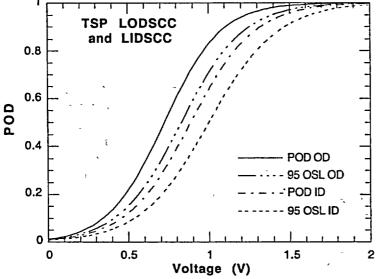


Fig. 2.55.
Logistic fit curves for BC POD as a function of voltage for LODSCC and LIDSCC in TSP.

The results were analyzed by the teams to determine whether strong team-to-team variations existed in the POD. For this exercise, all teams were given optical disks containing the same data sets to analyze. All analysts were given the same instructions and documents related to analyzing the data. Team-to-team variations resulted from varying analyst interpretations of the same signals. The results as a function of team for free-span and TSP LODSCC combined are shown in Fig. 2.56. The performance of most of the teams clusters rather tightly, although there is a significant variation between best and worst. Figure 2.57 shows team-by-team variation for free-span LODSCC alone. Figure 2.58 shows team-by-team variation for TSP LIDSCC alone.

Based on the procedure discussed in Section 2.5.2, we can estimate the probability that team-to-team variations in logistic fits to data are due to chance. For LIDSCC at the TSP, the variation from best to worst (Fig. 2.58) is statistically significant. The probability is <0.1% that the difference is due to chance (DTC). For FS LODSCC, the variation from best to worst (Fig. 2.57) is probably significant (DTC <20%). For TSP LODSCC, the variation from best to worst (DTC >60%) is probably not significant.

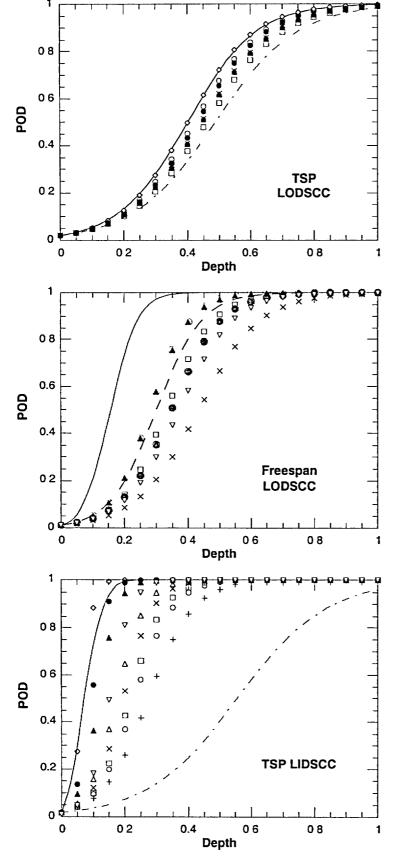


Fig. 2.56.
BC POD by team for TSP LODSCC as function of depth. The maximum crack depth (as fraction of wall) was determined by the multiparameter algorithm. The highest solid line represents the best team, the lowest dashed line represents the worst team, and the other symbols represent the remaining teams.

Fig. 2.57.
BC POD by team for free-span
LODSCC as function of depth. The
maximum crack depth (as fraction of
wall) was determined by the
multiparameter algorithm. The solid
line represents the best team, while
the symbols and dashed line
represent the remaining teams.

Fig. 2.58.

BC POD by team for TSP LIDSCC as function of depth. The maximum crack depth (as fraction of wall) was determined by the multiparameter algorithm. The solid line represents the best team, the dashed line represents the worst team, and the symbols represent the remaining teams.

Figure 2.59 shows the POD logistic fits for LODSCC at the TSP as a function of  $m_p$ . Figure 2.60 shows the corresponding results for LIDSCC at the TSP. Figure 2.61 shows the logistic fits for POD for axial SCC in free-span test sections as a function of  $m_p$ . The errors in calculating  $m_p$  by using the NDE characterization of the crack geometry compared to using fractography data have been determined with the 23-tube set (Tables 2.3 and 2.4 and Fig. 2.22). Because only one value of  $m_p$  per crack is obtained, fewer data are available than in the case of depth (multiple points per crack); hence, estimates of  $m_p$  have greater uncertainty. In all three graphs, the 95% one-sided lower confidence limit includes the error due to the use of NDE data to calculate  $m_p$ , as well as the statistical uncertainties associated with finite samples. In the TSP and FS regions, the POD for cracks that would fail or leak under  $3\Delta p$  internal pressure (corresponding to  $m_p \approx 2.3$ ) is >95%, even when accounting for depth uncertainties.

The analysis presented in this section is based on the resolution analysts' reports. In some cases, the bobbin coil signal was difficult to analyze, and significant disagreement occurred between the calls of the resolution analyst and the primary and secondary analysts. Three examples for the TSP are presented here. The first is for a 23% TW LIDSCC, the second is for a 67% TW LODSCC, and the third is for a very short 99% TW LODSCC. Table 2.10 shows that while for 13 out of the 33 cases all analysts were in agreement with respect to making I-code calls with the bobbin coil data; for the other 20 cases there was disagreement. In 13 cases the resolution analysts incorrectly dismissed a correct call by the primary and/or secondary analyst. In four cases the resolution analysts made a correct call while the primary and/or secondary analysts did not. In three cases, all analysts made incorrect calls. These examples show significant team-to-team variations for difficult-to-analyze signals and suggest that limiting the impact that the resolution analysts have in making the final call for these types of SCC might be prudent.

### 2.6.1.2 MRPC Tube Sheet Results

The adequacy of detecting SCC in the tube sheet level of the mock-up with an MRPC has been evaluated. The maximum depths were derived by multiparameter analysis of the MRPC data. Table 2.11 presents the general format for tabulating the MRPC results from four test sections. Each flaw is indicated by row, column, and level (A for tube sheet). The three-letter code and flaw type are recorded along with the estimated depth. The teams participating (11 for tube sheet analysis, though only 9 shown in Table 2.11) are numbered 1, 2, ... If the analyst recognizes that a crack is present within 25 mm (1 in.) of the correct location, a "1" is recorded in the column corresponding to the analyst/team; otherwise, a "0" is recorded. Figure 2.62 shows the 11-team average (resolution analysts) for MRPC POD as a function of maximum depth for combined axial and circumferential IDSCC in the tube sheet. A maximum likelihood fit is used with an OSL estimate that includes the uncertainty in maximum depth. The false call rate for the tube sheet was 6%. The POD at 60% TW is ≈90% with an OSL of 70%. Figure 2.63 shows the TS MRPC POD as a function of maximum depth for LIDSCC and CIDSCC combined and LODSCC and CODSCC combined. The POD for IDSCC is higher than for ODSCC, as expected. At 60% TW, the POD for IDSCC is  $\approx$ 90% with an OSL of  $\approx$ 75%. Figure 2.64 shows the POD as a function of maximum depth for axial and circumferential SCC in the tube separated into a POD curve for LIDSCC only, and a curve for LIDSCC combined with CIDSCC. The highest POD curve is for LIDSCC data only where the POD at 60% TW is 95%. Figure 2.65 shows MRPC POD by team as a function of maximum depth (as estimated by the multiparameter algorithm) for axial and circumferential IDSCC and ODSCC in the tube sheet. The POD at 60% TW ranges from 90% to 70%.

The logistic fits to the data depend, as previously discussed, on the estimates of crack depth. Figure 2.66 compares differences in logistic fits to the tube-sheet POD data when the depths are determined from the multiparameter algorithm and from the +Point phase analysis at 300 kHz. The difference is significant. The logistic curve fit to the data using maximum likelihood is higher for the depths estimated by the multiparameter algorithm.

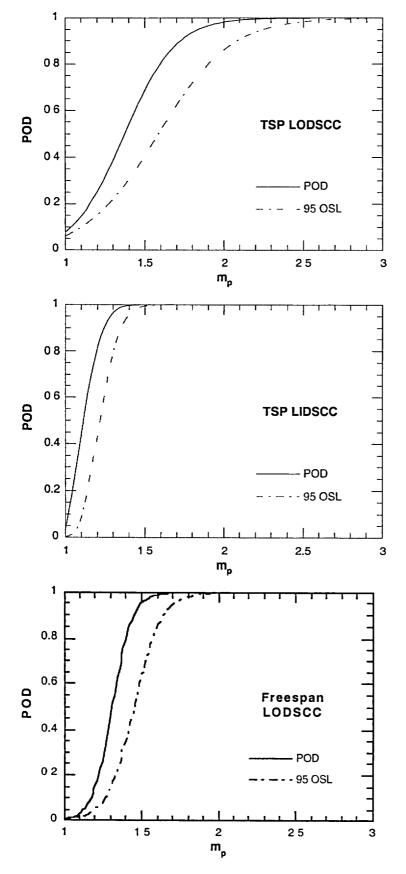


Fig. 2.59.
BC POD for TSP LODSCC as a function of mp. Curves derived by maximum likelihood fit and an estimate of the one-sided 95% confidence limit. The values of mp are derived by using depths from the multiparameter algorithm.

Fig. 2.60.
BC POD for TSP LIDSCC as a function of mp. Curves derived by maximum likelihood fit and an estimate of the one-sided 95% confidence limit. The values of mp are derived by using depths from the multiparameter algorithm.

Fig. 2.61.
BC POD for free-span data for LODSCC as a function of mp. Curves derived by maximum likelihood fit and an estimate of the one-sided 95% confidence limit. The values of mp are derived by using depths from the multiparameter algorithm.

Table 2.10. Bobbin coil calls for primary, secondary, and resolution analysts for three different SCCs.

Note that the deep (99% TW) LODSCC is very short.

• •	**								
	LIDSCC at TSP (23% TW)	LODSCC at TSP (67% TW)	LODSCC at TSP (99% TW)						
Number of teams where the resolution, primary, and secondary analysts all made a correct bobbin coil I-code call.	4.	6	3						
Number of teams where the resolution analysts made a correct bobbin coil I-code call, but the primary and/or secondary analyst did not.	11:	.3	.0						
Number of teams where the resolution analysts did not make a correct bobbin coil I-code call, but the primary and/or secondary analyst did.	. 5	2	6						
Number of teams where the resolution, primary, and secondary analysts all failed to make a correct bobbin coil I-code call.	1	0	2						

Table 2.11. Format for tabulating MRPC TS results (11 teams analyzed MRPC data from the tube sheet).

Flaw ID	MRPC Location	Three- Letter Code	Flaw Type	Depth % TW	1	<u> 2</u>	3	4	<u>5</u>	<u>_6</u>	7	 _ <u>8</u>	9
H21A	14314	MAI	LOD	51	0	1	1	1	1	0	1	1	1
N18A	20550	MCI 🚆	COD	₹ 85	1 ·	1	1	1	1	1~	1	1	`1
N08A	20286	MAI	LID	87 -									
K24A	21870	MMI	LOD	90	1.	. 1	0	1	0	1	1	- 0	1

The logistic fits to the data depend, as previously discussed, on the estimates of crack depth. Figure 2.66 compares differences in logistic fits to the tube-sheet POD data when the depths are determined from the multiparameter algorithm and from the +Point phase analysis at 300 kHz. The difference is significant. The logistic curve fit to the data using maximum likelihood is higher for the depths estimated by the multiparameter algorithm.

Comparisons are made between the tube-sheet BC POD and tube-sheet MRPC POD in Fig. 2.67 and 2.68. Figure 2.67 compares BC and MRPC PODs for tube sheet LIDSCC and CIDSCC, with the MRPC curve substantially higher. Figure 2.68 compares BC and MRPC POD for tube sheet LIDSCC only. The MRPC POD at 60% TW is 95%, while the BC POD is only 40%.

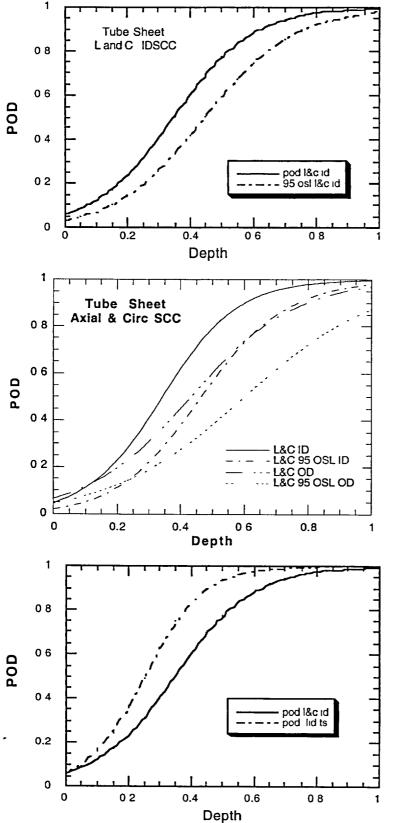


Fig. 2.62.
Tube-sheet MRPC POD as a function of maximum depth (as fraction of wall) for combined axial and circumferential IDSCC. Maximum likelihood fit is used with an estimate of the one-sided 95% confidence limit. Depths are determined with the multiparameter algorithm.

Fig. 2.63.
Tube-sheet MRPC POD as a function of maximum depth (as fraction of wall) for LIDSCC and CIDSCC combined and LODSCC and CODSCC combined. Maximum likelihood fit is used with an estimate of the one-sided 95% confidence limit that includes uncertainty in maximum depth. Depths are determined with the multiparameter algorithm.

Fig. 2.64.
Tube-sheet MRPC POD as a function of maximum depth (as fraction of wall) for axial and circumferential IDSCC.
The solid line is for LIDSCC and CIDSCC combined. The upper dashed line is for LIDSCC only.
Depths are determined with the multiparameter algorithm.

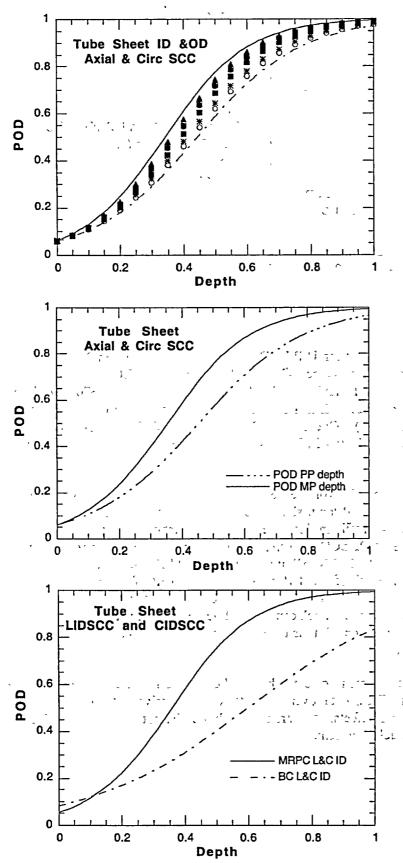


Fig. 2.65.
Tube-sheet MRPC POD by team as a function of maximum depth (as fraction of wall) for axial and circumferential IDSCC and ODSCC. Maximum depth is estimated by the multiparameter algorithm. The solid line represents the best team, the dashed line represents the worst team, and the symbols represent the remaining teams.

٢'.

Fig. 2.66.
Tube-sheet MRPC POD as a function of maximum depth (as fraction of wall) for all axial and circumferential SCC combined. Depths estimated by conventional phase analysis with a +Point<sup>TM</sup> probe (PP) and by the multiparameter method (MP).

Fig. 2.67.
Tube-sheet BC and MRPC POD for CIDSCC and LIDSCC. Depths are determined with the multiparameter algorithm.

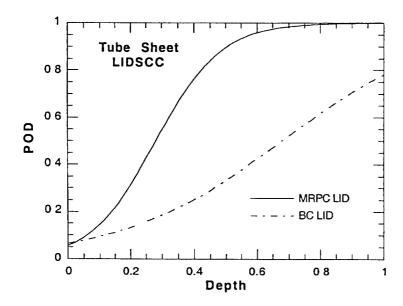


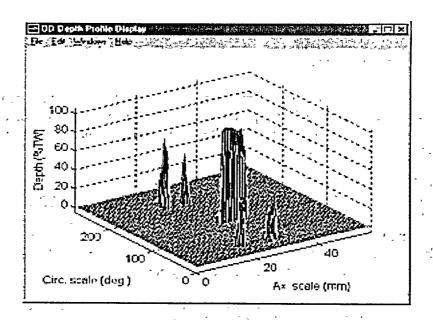
Fig. 2.68.
Tube-sheet BC and MRPC POD for LIDSCC. Depths (as fraction of wall) are determined with the multiparameter algorithm.

### 2.6.1.3 MRPC Special Interest Results

A review of MRPC results was carried out for TSP LODSCC BC voltages between 2.0 and 5.6 V. Such calls are normally made to confirm or dismiss the BC call. There are 17 TSP LODSCC flaws with BC voltages in the range 2.0 to 5.6 V, and maximum depths are estimated to be >70% TW (by multiparameter algorithm). The average correct call using the MRPC data for this set of cracks is 98% (with a lower 95% confidence limit of 96%). One other LODSCC in the TSP with BC voltage of 2.0–5.6 V range had an estimated maximum depth of 28% TW. None of the teams correctly called this flaw with the MRPC data.

The possibility of a crack with a high BC voltage being missed by the subsequent MRPC data analysis could arise when a flaw is shallow and long, shallow and volumetric, or deep and short. An example is shown in Fig. 2.69. The crack profile in this case is generated from mock-up data with the multiparameter algorithm. An axial TSP LODSCC with maximum depth of 99% TW was missed by teams analyzing MRPC data. In this case, the MRPC +Point voltage at 300 kHz was only  $\approx 0.2$  V. The largest part of the segmented crack has a length of about 10 mm. The lower part of the figure shows the crack along the test section axis. The  $m_p$  for this flaw is  $\approx 4.5$ , indicating that the tube would leak at pressures well below  $3\Delta p$ . The BC voltage for this crack can, depending on analyst, vary from 4.5 to 8 V. The dye penetrant image of the crack intersection with the tube OD is consistent with the isometric image generated by the multiparameter algorithm.

These results suggest that flaws detected correctly by the bobbin coil could subsequently be dismissed upon further examination of MRPC data, even when flaws are relatively deep. The MRPC probes are very effective in characterizing defects, compared to bobbin coils, but may be less effective than bobbin coils in recognizing that a crack is present.



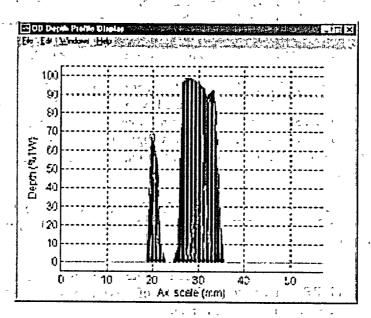


Fig. 2.69. Depth profiles of TSP LODSCC with maximum depth of 99% TW that was missed by all teams analyzing MRPC data. The largest piece of the segmented crack has a length of about 10 mm (0.4 in.). The lower part of the figure shows the crack along the test section axis.

### 2.6.1.4 Analysis of Subsets of Data

### 2.6.1.4.1 Dented TSP with LIDSCC

The BC and MRPC results for LIDSCC in dented TSP test sections have been analyzed as a subset of the mock-up (using resolution analyst reports). Figure 2.70 shows the BC voltage vs. maximum LIDSCC depth as determined from the Argonne multiparameter algorithm. As expected, the BC voltage does not correlate with maximum crack depth.

Figure 2.71 shows the results for the 11 teams using the bobbin coil data only. This graph shows the detection rate increasing with depth. The overall success in detecting an LIDSCC in a dented TSP location is somewhat less than for LIDSCC in TSP locations without data. Nevertheless, success with a bobbin coil in detecting LIDSCC in a dent is generally high for depths greater than 40% TW. Detection as a function of BC voltage is presented in Fig. 2.72. The dent signal can mask the presence of a SCC, but for the 2.5-4.5 volt range the detection rate was generally good.

Figure 2.73 shows the result for a correct call using the BC data followed by a correct call using the MRPC data for the same SCC. It is evident (Figs. 2.71 and 2.73) that some mock-up LIDSCCs in a dented TSP were detected correctly by the BC data, but then incorrectly dismissed using the MRPC data. Figure 2.74 shows the results for those LIDSCCs correctly called with BC data and then dismissed with the MRPC data. Most but not all of those cases are for depths less than about 45% TW.

Figure 2.75 shows the result for a BC miss but detection with an MRPC. Some of the shallow mock-up LIDSCCs missed by the BC could be detected with the MRPC data. Figure 2.76 shows the result for LIDSCCs in a dented TSP where there was a miss with both BC and MRPC data. The double misses are mainly for shallow LIDSCCs. These results suggest that by combining the BC and MRPC calls, rather than trying to verify a BC call with MRPC data, the success rate would be very high for depths greater than 40% TW.

Some false calls did occur in test sections with a dent but no SCC. Figure 2.77 shows the result for dented TSP test sections as a function of BC dent voltage. In more than half of the dented test sections without an SCC, an "I Code" was called.

Figure 2.78 summarizes the results for LIDSCCs in dented TSP test sections by showing the correct calls from BC data only and MRPC data only as a function of maximum crack depth. The MRPC and BC reports from resolution analysts were used for this graph.

### 2.6.1.4.2 Intergranular Attack

The round-robin results for the small number of test sections with IGA were analyzed separately from the other flawed test sections. The resolution analyst calls using bobbin coil data for the 11 teams are presented in Fig. 2.79 for IGAs having maximum depths determined using Argonne's multiparameter algorithm. The results suggest that this type of volumetric cracking can be detected easily with a bobbin coil for depths greater than 40% TW.

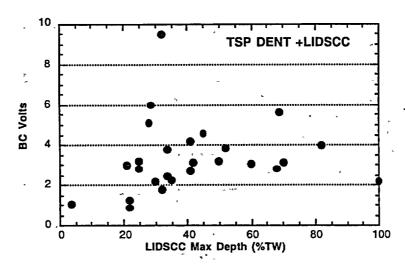


Fig. 2.70. Bobbin coil voltage as a function of maximum depth of LIDSCC in a TSP dent. These data show no correlation between BC voltage and LIDSCC depth. The depth was determined by application of Argonne's multiparameter algorithm to MRPC data.

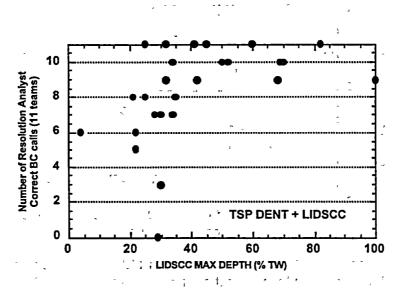


Fig. 2.71. Number of teams out of 11 correctly calling LIDSCC in a dented TSP from mock-up bobbin coil data (using resolution analyst reports) as a function of maximum crack depth. The depth was determined by application of Argonne's multiparameter algorithm to MRPC data.

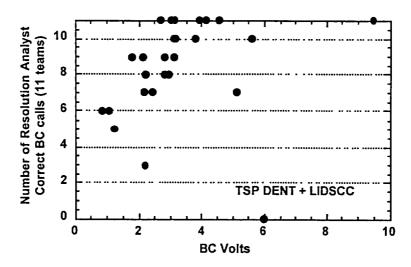


Fig. 2.72. Number of teams out of 11 correctly calling LIDSCC in a dented TSP from mock-up bobbin coil data (using resolution analyst reports) as a function of BC voltage.

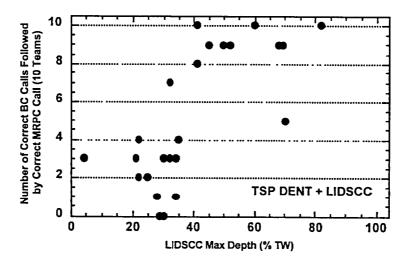


Fig. 2.73. Number of teams out of 10 correctly calling an LIDSCC in a dented TSP from mock-up bobbin coil data followed by a correct call for that crack using MRPC data (from resolution analyst reports) as a function of maximum crack depth. The depth was determined by application of Argonne's multiparameter algorithm to MRPC data.

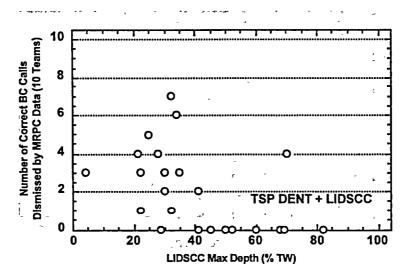


Fig. 2.74. Number of teams out of 10 correctly calling an LIDSCC in a dented TSP from bobbin coil data followed by dismissing that crack using MRPC data (from resolution analyst reports) as a function of maximum crack depth. The depth was determined by application of Argonne's multiparameter algorithm to MRPC data.

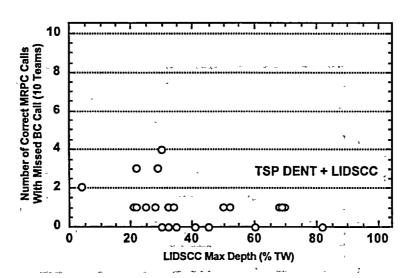


Fig. 2.75. Number of teams out of 10 missing an LIDSCC in a dented TSP from bobbin coil data followed by a correct call using MRPC data (from resolution analyst reports) as a function of maximum crack depth. The depth was determined by application of Argonne's multiparameter algorithm to MRPC data.

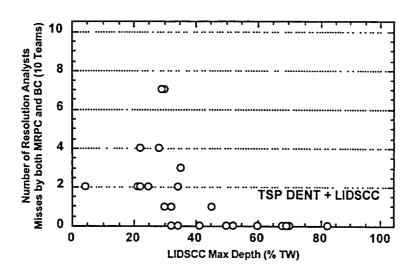


Fig. 2.76. Number of teams out of 10 missing an LIDSCC in a dented TSP with both bobbin coil and MRPC data (from resolution analyst reports) as a function of maximum crack depth. The depth was determined by application of the multiparameter algorithm to MRPC data. This result for the mock-up suggests a very high detection rate if calls from BC and MRPC data were combined rather than using MRPC data to check a BC call.

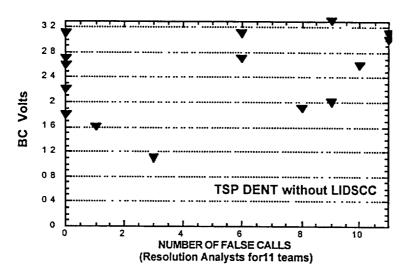


Fig. 2.77. Number of false calls in dented TSP test sections as a function of BC voltage (0.1-V window).

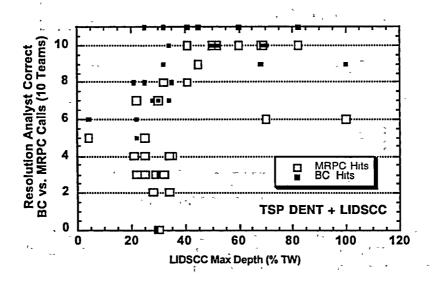


Fig. 2.78. Number of teams out of 10 correctly calling an LIDSCC in a dented TSP using only bobbin coil data compared to correct calls using only MRPC data (from resolution analyst reports) as a function of maximum crack depth. The depth was determined by application of Argonne's multiparameter algorithm to MRPC data.

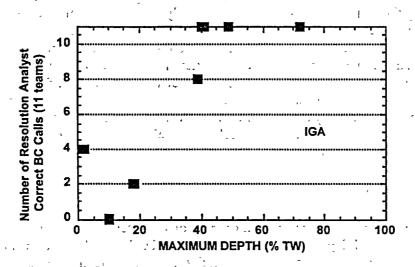


Fig. 2.79. Number of teams out of 11 correctly calling IGA from bobbin coil data (using resolution analyst reports) as a function of maximum flaw depth. The depth was determined by application of Argonne's multiparameter algorithm to MRPC data.

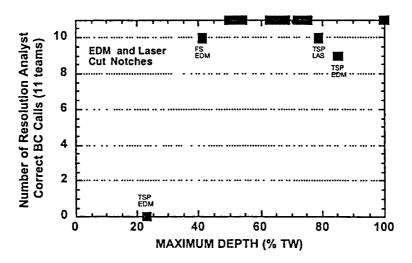


Fig. 2.80. Number of teams out of 11 correctly calling EDM and laser cut slots (LAS) from bobbin coil data (using resolution analyst reports) as a function of maximum depth. The location and type of notch missed is indicated in the graph.

### 2.7 Nature of Missed Flaws

The primary cause of missing a flaw is that the flaw signal is distorted by geometry or deposits, and the flaw signal is no longer recognized. A tight crack that does not generate a significant EC signal is another cause for missing a flaw. Another possibility is that the signal from an EC coil does not conform to what is expected (i.e., the signal could be out of the flaw plane or could be generated by multiple cracks). Very long flaws may be missed because the analysts may concentrate on a small portion of the flaw, thereby missing the overall response. Confusion could also arise from conflicting behavior of two or more coils. For example, there could be a clear bobbin coil signal but nothing reportable from an MRPC. Analysts have a preconceived idea of what flaw responses at various locations should be like, and might not pursue anomalous indications that are actually from a flaw. A few cracks in the mock-up have been called by the bobbin coil and dismissed following an MRPC analysis. Some cracks detectable with an MRPC are not detected by the bobbin coil. The reasons vary, as described above, but in the case of a crack and a bobbin coil indication, the crack is not called because the indication has a very high phase angle or is out of the flaw plane.

### 2.8 Nature of Overcalls

Overcalls are the result of signals from certain coils that tend to generate flaw-like signals from geometrical distortions and deposits. Overcalls could also be the result of confusion from conflicting behavior of two or more coils. In a round-robin exercise, participants tend to make calls that might not be made under field conditions because there is no penalty for overcalling as long as the overcalling is not abused. In fact, the reports from resolution analysts show a reasonably low overcalling rate for the free span (0.1%) and TSP (1.7%). The overcalling in the tube sheet level is significantly higher (6%). The complex nature of the roll transition is probably the root cause of the tube sheet overcalling, although further review and destructive analysis suggest that unintentional flaws may have been introduced to the tube sheet level during tube expansion, flaw fabrication, and assembly.

# 3 Summary

The mock-up has been shown to have flaws similar to those in operating steam generators, and the RR exercise has successfully mimicked an in-service inspection from preparation of documentation, to collection of BC and MRPC data, to analysis of the data by qualified teams. Eleven teams have participated in the steam-generator RR exercise. The resolution analysts' reports have been used to provide POD estimates for some flaw morphologies. The feasibility of determining the reference state (that is, estimating the maximum depth, average depth, area, and mp) from the eddy current profile of mock-up flaws has been validated through fractography of laboratory samples containing cracks with various morphologies similar to those in the mock-up. Nevertheless, for the final analysis, the "true" size of some flaws will be determined through destructive examination. The current NDE validation effort has led to POD estimates for axial and circumferential ID and OD SCC, shallow to deep. For the flaws analyzed, the mock-up POD is generally high for the deeper free-span and tube-support-plate SCCs. However, as noted previously, noise levels in the mock-up are generally less than in field data. Noise as severe as that in the U-bends of nuclear plants, such as Indian Point 2, was not present in the mock-up free-span and TSP levels.

A flaw being detected by BC and dismissed as a flaw by further MRPC evaluations has been demonstrated in this exercise. This situation can occur even when flaws are relatively deep. The MRPC probes are more effective in characterizing defects than are BCs, but the RR exercise did not improve in POD by supplemental rotating probe examinations when following "I" code calls made with the bobbin coil. This finding is understandable because the POD for bobbin calls requiring a supplemental MRPC analysis is simply the probability determined from the two PODs, each of which is less than 1. The combined POD (BC followed by MRPC) = (POD BC) x (POD supplemental MRPC). The flaws missed by the BC examination were not reviewed by an MRPC. Because some of the flaws correctly called by the bobbin coil were incorrectly dismissed by the MRPC examination, the combined POD is less than the BC-alone POD. Note that for the tube sheet where all test sections were examined by MRPC and BC, the MRPC POD is higher than the BC POD (see Figs. 2.67 and 2.68) Also, signals from the geometry of the tube sheet area can lead to significant overcalling, although generally the number of overcalls was not particularly high.

Most of the cracks in the mock-up are deep, as determined by the application of the multiparameter algorithm. The uncertainty in depth and the skewing toward deeper cracks are accounted for in the confidence limits associated with POD curves.

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The maximum depth from crack profiles and false call rates were estimated to establish POD as a function of crack depth and mp and to generate logistic curve fits to the data. The NDE uncertainty in depth is included in the one-sided 95% lower confidence limit (OSL). In general, the curves have a reasonable shape and thus provide plausible PODs (increasing POD with increasing depth). As expected, the POD for TSP ID cracks is higher than for OD cracks (99% with 98% OSL at 60% TW vs. 75% with 65% OSL at 60% TW). While as expected, the POD for free-span LODSCC (95% at 60% TW) is higher than that for TSP LODSCC (75% at 65% TW), it is lower than that for TSP LIDSCC (98% at 60% TW). The logistic fit when depths are estimated by ANL's multiparameter algorithm were compared with the fit from the +Point maximum depth estimates. The +Point data results led to a more conservative POD curve.

In addition to examination of the RR data as a function of flaw depth, the POD has been evaluated as a function of BC voltage for TSP LODSCC. The resulting curve was similar to that found for POD versus depth. In the POD vs. voltage case, the TSP POD curve is lower for LIDSCC than for LODSCC. This lower POD curve for LIDSCC is possibly the result of missing shallow cracks that are in dents with high voltages.

The results were analyzed by team to determine whether strong team-to-team variations existed in the POD. The performances of most of the teams cluster rather tightly, although in some cases significant variation occurred between best and worst. The probability that team-to-team variations in logistic fits to data are due to chance was estimated. For LIDSCC at the TSP, the variation from best to worst is very significant statistically. The probability is <0.1% that the difference is due to chance (DTC). For FS OD, the variation from best to worst is likely to be significant (DTC is <20%). For TSP OD, this variation is probably not significant (DTC > 60%).

The round-robin results for the small number of test sections with IGA have been analyzed separately from the other flawed test sections. The results suggest that this type of volumetric cracking can be detected easily with a bobbin coil for depths greater than 40% TW.

The BC results for EDM notches and laser cut slots have also been analyzed as a subset of the mock-up. For depths of 40% TW and greater, the success in detecting notches and laser cut slots is greater than for SCC of comparable depths. This finding suggests that POD curves generated using notches are unrealistically high for deep cracks.

### 3.2 Tube-Sheet MRPC Results

The POD has been calculated for SCC in the tube sheet level of the mock-up with an MRPC. The maximum-likelihood logistic fit as a function of depth is presented in this report. For all TS POD curves, a false call rate of 6% was used. The OSLs included uncertainties in maximum depth.

For MRPC in the tube sheet, the POD for IDSCC is  $\approx 90\%$ , with an OSL of  $\approx 75\%$ . The highest POD curve is for LIDSCC where the POD at 60% TW is 95%. Results are given for MRPC POD by team for axial and circumferential ID and OD SCC in the tube sheet. The POD at 60% TW ranges from 90 to 70%.

Comparisons were made between the BC and MRPC PODs for the tube sheet. For all SCCs, the POD curve is higher for the MRPC (80 vs. 40% at 60% TW). For tube-sheet LIDSCC only, the MRPC POD at 60% TW is 95%, while the BC POD is only 40%. For the tube sheet, the MRPC is clearly the probe of choice for detection of SCCs. The complication of the roll transition and the presence of circumferential SCCs make separating the crack signals from geometry difficult when using a bobbin coil.

# 3.3 MRPC Analysis of TSP Signals

A review was carried out of MRPC results for BC voltages between 2.0 and 5.6 V. Such calls are normally made to confirm or dismiss the BC flaw call. The result for LODSCC >74% TW is an average correct call of 98%. All teams missed an LODSCC at the TSP with an estimated maximum depth of 28% TW. This example illustrates the possibility of having a strong BC signal and a weak MRPC signal that would not be called a crack by analysts. The example presented had an estimated maximum depth of

99% TW with only a few tenths of a volt generated by the +Point coil at 300 kHz. This situation could arise when a flaw is shallow and long, shallow and volumetric, or short and tight.

# 3.4 LIDSCC in Dented TSP

'; \*1 ^ -

The BC and MRPC results for LIDSCC in dented TSP test sections have been analyzed as a subset of the mock-up (using resolution analyst reports). These results suggest that by combining the BC and MRPC calls, rather than trying to verify a BC call with MRPC data, the success rate would be very high for depths greater than 40% TW.

### 3.5 Accuracy of Maximum Depth for Mock-up Cracks

Accuracy in estimating the maximum depth of cracks in the mock-up was determined by a comparison between crack profiles generated by ANL's multiparameter algorithm and profiles determined from fractography. The overall RMSE for all cracks of all depths is 15.1%, but the RMSE varies significantly with depth. The RMSE value is significantly better for 80–100% TW cracks than for cracks with other depths.

Table 2.4 gives two sets of RMSE values. One set is based on the values obtained directly from the multiparameter algorithm and the other on "corrected" values obtained from the regression fit shown in Fig. 2.22. For the shallowest cracks, the "corrected" values give a significantly lower RMSE value, but when all the data are considered, the differences in the RMSE for corrected and uncorrected predictions are small. This finding indicates little systematic bias in the predictions of the multiparameter algorithm, i.e., the errors are random.

These sizing-accuracy results can be used to estimate the uncertainty in POD curves if the multiparameter algorithm is used to determine the "true" state of the mock-up for the NDE round-robin. Instead of characterizing the error in the depths in terms of the overall average for all depths (≈15%), the error was taken as a function of depth. Analytically, the RMSE values given in Table 2.3 are assumed to apply at the midpoint of the depth range for each bin. The error at other depths is then estimated by linear interpolation of these values.

# 3.6 Overall Capability

The detection capability of current ISI technology and procedures has been assessed by an eddy-current RR exercise with a mock-up for a steam-generator tube bundle. Inspection of the mock-up and analysis of the data mimicked industry ISI practices conducted on operating steam generators. All documentation for conducting the inspection was prepared with input from an industry-based NDE Task Group, and the realism of the mock-up was established. Data were acquired in June and August 1999, and the data were analyzed by 11 commercial teams in December 2000. Each team consisted of five qualified analysts. The exercise took seven to eight working days per team.

The conclusion from the RR results is that a good POD can be achieved for deep flaws when commercial techniques are used in a similar manner to the RR exercise. The level of success in detection of SCCs did vary with flaw location. The maximum depth from eddy current crack profiles and false call rates were estimated to establish POD as a function of depth and  $m_p$ . Logistic fits to the data were generated. The BC POD for TSP ID cracks is higher than for OD cracks (99% with 98% OSL at 60% TW vs. 75% with 65% OSL at 60% TW). The BC POD for free-span LODSCC is  $\approx$ 95% at

60% TW. For MRPC in the tube sheet, the POD for IDSCC is  $\approx$ 90% with an OSL of  $\approx$ 75%. The highest POD curve is for LIDSCC, where the POD at 60% TW is 95%.

No useful correlation was found between signal amplitude or phase and the maximum depth of the mock-up flaws. When the PODs are considered as a function of  $m_p$  in the TSP and FS regions, the POD for cracks that would fail or leak under  $3\Delta p$  internal pressure (corresponding to  $m_p \approx 2.3$ ) is >95%, even when uncertainties are accounted for.

In sum, the adequacy of the multiparameter algorithm for obtaining profiles and maximum depth was established. The results of POD as a function of depth or  $m_p$  were based on the profiles generated with this algorithm.

# References

- 1. D. S. Kupperman, S. Bakhtiari, W. J. Shack, J. Y. Park, and S. Majumdar, Evaluation of Eddy Current Reliability from Steam Generator Mock-Up Round Robin ANL-01/22, U.S. Nuclear Regulatory Commission, Washington, DC (2002).
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- 5. P. R. Bevington and D. K. Robinson, Data Reduction and Error Analysis for the Physical Sciences, 2nd Ed., McGraw Hill, New York (1992).
- 6. A. H. Bowker and G. J. Lieberman, *Engineering Statistics*, Prentice Hall, Englewood Cliffs, NJ (1972).
- 7. D. A. Powers and Y. Xie, Statistical Methods for Categorical Data Analysis, Academic Press, New York (2000).

# Appendix A: Multiparameter Algorithm Profiles vs. Fractography

# A1. SCC used for validation but not from the mock-up

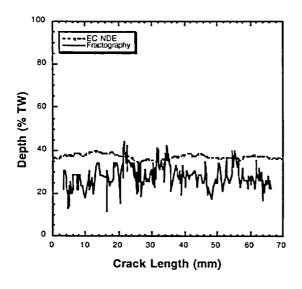


Fig. A1.
AGL 2241 CODSCC:
EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

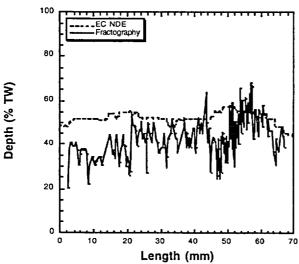


Fig. A2.
AGL 2242 CIDSCC:
EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

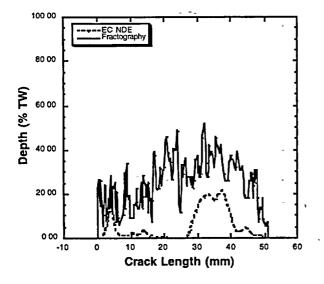


Fig. A3.
AGL 288 LIDSCC:
EC NDE depth versus position

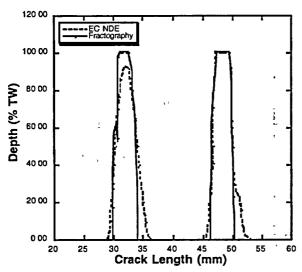


Fig. A4. AGL 394 CODSCC:

EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

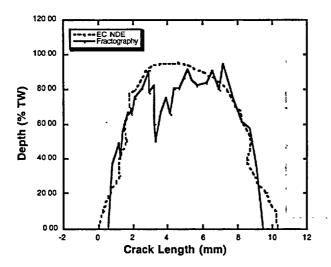


Fig. A5. AGL 533 LODSCC:

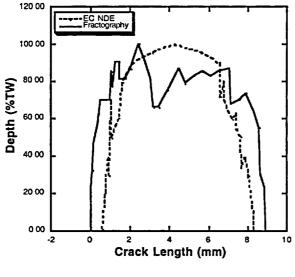


Fig. A6. AGL 535 LODSCC:

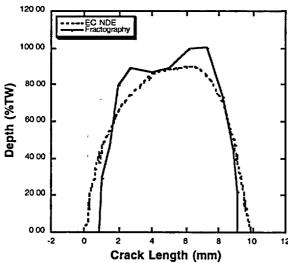


Fig. A7. AGL 536 LODSCC:

EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

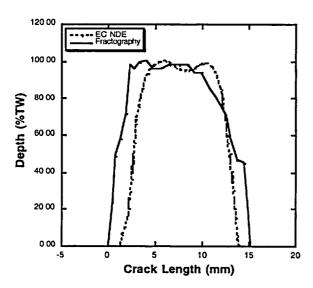


Fig. A8. AGL 503 LODSCC:

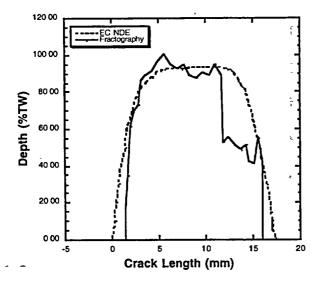


Fig. A9. AGL 516 LODSCC:

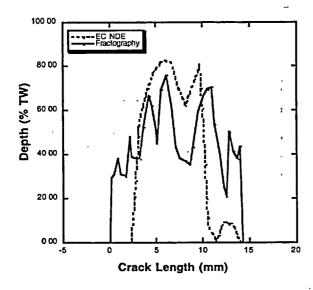


Fig. A10. AGL 517 LODSCC:

EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

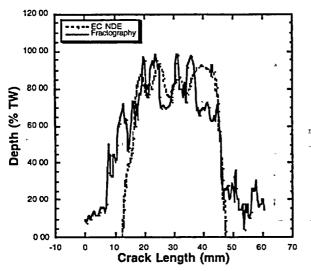


Fig. A11. AGL 824 LODSCC:

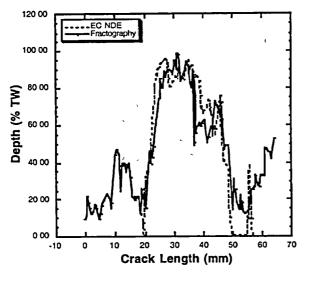


Fig. A12. AGL 826 CODSCC:

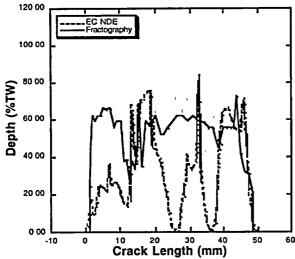


Fig. A13. AGL 835 LODSCC:

EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

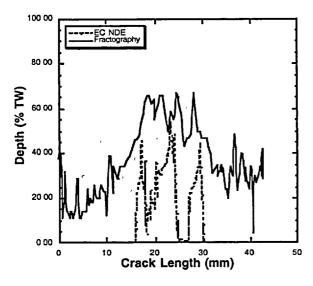


Fig. A14. AGL 838 CODSCC:

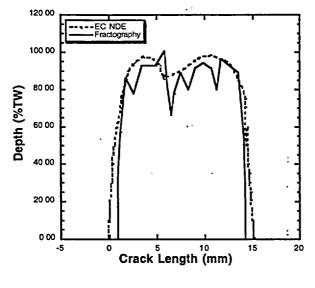


Fig. A15. AGL 854 LODSCC:

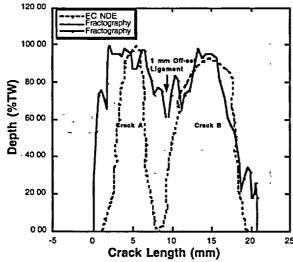


Fig. A16. AGL 855 LODSCC:

EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

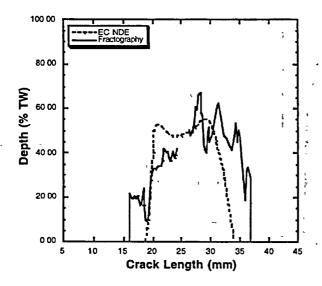


Fig. A17. AGL 861 LODSCC:

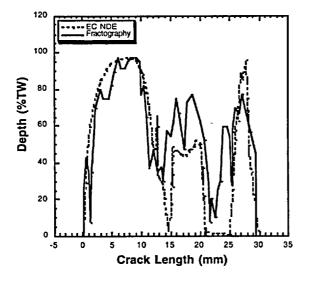


Fig. A18. AGL 874 LODSCC:

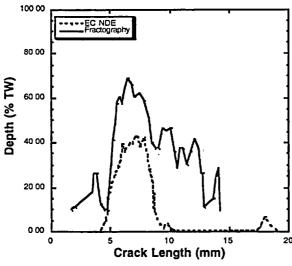


Fig. A19. AGL 876 LODSCC:

EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

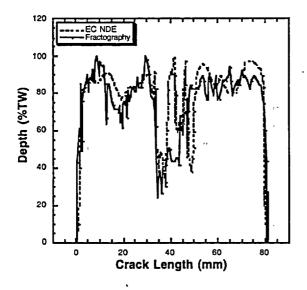
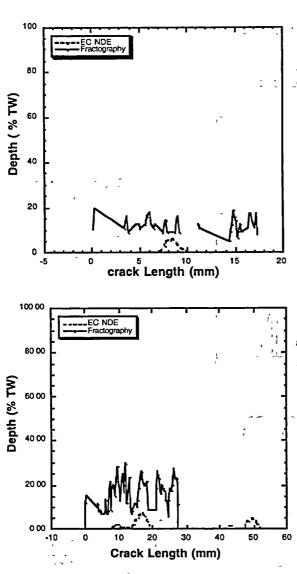


Fig. A20. AGL 883 LODSCC: -



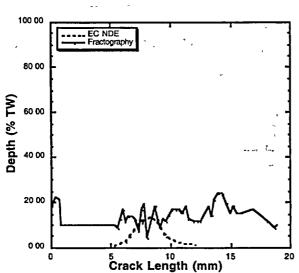


Fig. A21. AGL 893 CODSCC:

Fig. A22. AGL 8161 LIDSCC:

EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

Fig. A23. AGL 8162 LIDSCC:

# A2. SCC in test sections removed from the mock-up

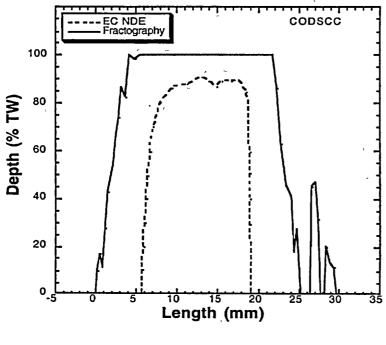


Fig. A24.
Test section 42 removed from mock-up with a CODSCC. EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

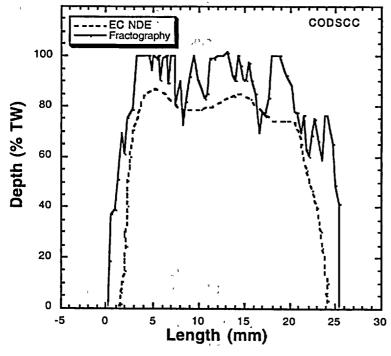


Fig. A25..
Test section 43 removed from mock-up with a CODSCC. EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

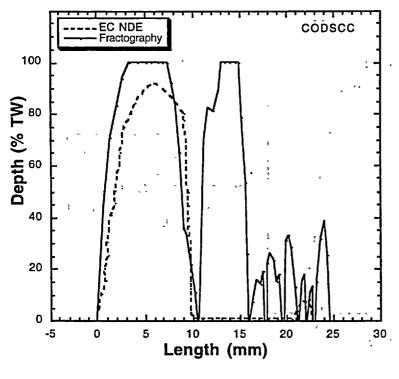


Fig. A26.
Test section 45 removed from mock-up with a CODSCC. EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

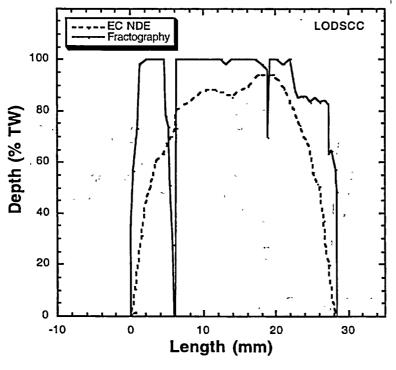
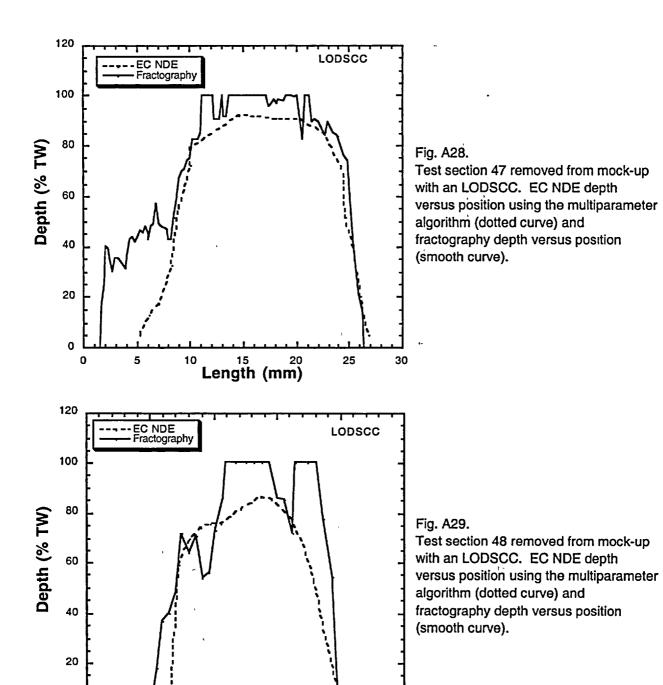


Fig. A27.
Test section 44 removed from mock-up with an LODSCC. EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).



Length (mm)

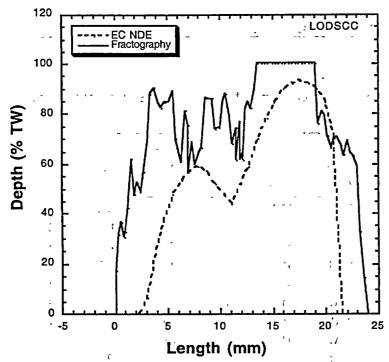


Fig. A30.
Test section 49 removed from mock-up with an LODSCC. EC NDE depth versus position using the multiparameter algorithm (dotted curve) and fractography depth versus position (smooth curve).

# Appendix B: Mock-up Reference State Table

Table B1. Reference table showing data for axial SCC and EDM notches at TSP for test sections that had  $m_{\rm D}$  determined.

Flaw Type	BC Volts	BC Phase (deg.)	ID/OD	Ref. State Call	Max Depth (% TW)	Length (mm)	Avg. Depth (% TW)	Ave. Depth x Length (mm <sup>2</sup> )	, m <sub>p</sub>
LIDSCC	9.97	107-	· ID	MAI	35.2	10.7	26 4	2.8	1.2
LODSCC	3.57	71	OD	SAI	888	27.1	67 6	18.3	2.6
LODSCC	8.78	70	OD	SAI	87 8	200	78 8	15.7	3.6
LIDSCC	2.7	24	ID	MMI	45.7	34.2	19 2	6.5	1.2
LODSCC	2.28	91	OD	SAI	84.1	7.8	62.7	48	1.5
LODSCC	5.56	59	OD	MAI	94.5	30.2	68.5	20 6	4.5
LODEDM	0	0	OD	SAI	24.4	9.2	164	1.4	1.1
LODSCC	5.18	68	OD	MAI	942	29.7	81.4	24.1	5.4
LODSCC	6.69	74	OD	MAI	95 2	13 6	72.1	9.7	3.4
LODEDM	4.7	36	OD	SAI	99.8	7.0	82.4	3.3	34.2
LIDSCC	2.19	187	ID	SAI	28.1	9.5	17.3	16	1.1
LODSCC	5.56	63	OD	MAI	93.8	21.0	69 8	13 2	3.2
LODSCC	6.49	39	OD	MAI	78.9	21.9	66 0	144	2.3
LODSCC	4.76	53	OD	SAI	98.7	40.7	58.1	23 6	3.3
LODSCC	0.63	46	OD	MAI	61.3	40.5	41.5	168	1.6
LODSCC	3.46	54	OD	MAI	95.0	32.5	72 4	23.5	5.2
LIDSCC	6.02	187	ID	SAI	29.5	12.0	25.5	30 6	1.2
LODSCC	29.07	18	OD	MAI	93.7	14.2	57 3	8.1	2.2
LODEDM	1.47	104	OD	SAI	73.5	21.6	63.9	13 8	2.2
LODSCC	2.52	134	OD	SAI	93.7	18.5	53.8	9.9	2.4
LIDSCC	0.97	32	ID	SAI	40	26	1.9	0 05	1.0
LODSCC	0.47	58	OĐ	MAI	66.5	35 0	31 2	10.9	1.6
LODSCC	21.42	64	OD	MAI	97.8	30.1	86.6	260	12.0
LODSCC	16.74	77	OD	MAI	95.6	21.6	57.5	12.4	3.7
LODSCC	1.5	131	OD	MAI	864	41.7	29 6	12.3	2.3
LODSCC	5.89	51	OD	SAI	93 4	15 0	68 4	102	2.3
LODSCC	1.41	66	OD	SAI	97 4	15 8	508	8 0	3.5
LODSCC	3.11	53	OD	SAI	85.0	21.1	40 0	8 4	18
LIDSCC	1.09	25	ID	SAI	25.5	8.0	15.5	1 2	1.1
LODSCC	0	0	OD	SAI	9.5	59 8	28	16	10
LIDSCC	1.41	103	ID	SAI	66.9	10.7	48 2	5.1	1.4
LODSCC	4.53	192	OD	MAI	99.4	16.8	57.5	96	4.8
LODEDM	32	89	OD	SAI	74.7	21.9	64.0	14.0	2.2
LODSCC	19.84	90	OD	MMI	97.5	283.7	80 0	19.3	7.7

Table B1. (Cont'd.).

Flaw Type	BC Volts	BC Phase (deg.)	ID/OD	-Ref State Call	Max Depth (% TW)	Length (mm)	Avg Depth (% TW)	Ave Depth x Length (mm <sup>2</sup> )	$^{ m m_p}$
LIDSCC	-1.72	19	<sup>'</sup> ID	SAI -	25.6	100	19.2	1.9	1.1
LODSCC	7.2	36	OD	MAI	91.4	26.3	72.1	189	-3.5
LODSCC	12.1	93	OD	MAI	84.0	29.5	45.6	13.4	2.0
LODSCC	2.28	142	OD	SAI	73.7	15.7	24.4	3.8	1.3
LODSCC	1.69	142	OD	MAI	44.2	11.9	30.2	3.6	1.2
LODEDM	0	0	OD	SAI	72.4	25.1	56 4	14 1	2.0
LIDSCC	1.17	18	ID	SAI	28.1	24.8	11.4	2.8	1.1
LODSCC	3.64	61	OD	SAI	81.9	21.1	46.5	9.8	1.8
LODSCC	0 87	152	OD	SAI	12.3	11.6	<b>= 4.9</b>	0.5	1.0
LODEDM	1.06	121	OD	SAI	86.1	24.4	709	17.3	2.7
LIDSCC	3.64	38	ID	MMI	51.2	54.5	18 8	102	1.2
LIDSCC	0.73	33	ID	SAI	22.0	147	10.7	1.5	1.1
LIDSCC	1.23	32	ID	MMI	23.2	57.0	9.9	5.6	1.1
LODSCC	7.75	46	OD	MAI	96.4	25.9	·84.6	21.8	7.6
LIDSCC	4.98	47	ID	MAI	60.3	10.3	43 0	4.4	1.3
LIDSCC	2.48	16	ID	MMI	33.4	25.7	18.8	4.8	1.2
LODSCC	5.19	70	OD	SAI	93.0	22.2	68.3	15.1	3.1
LIDSCC	3.4	22	ID	MMI	41.7 .	146 8	25.3	37.1	1.5
LODSCC	1.26	127	OD	SAI	71.4	7.1	42 5	1.6	1.1
LODSCC	2 02	131	OD	SAI	75.8	264	38.5	10 1	1.6
LIDSCC	1.42	31	ID	MMI	64.6	41.9	20.6	8.6	1.3
LODSCC	1.06	21	OD	SAI	95.5	15.6	69.6	10.2	23
LODSCC	6.26	43	OD	MAI	96.0	24.2	70 7	17.0	<b>5.5</b> ,
LODSCC	2.21	140	OD	SAI	84.8	12.8	61.1	7.8	1.9
LODSCC	6.36	78	OD	MAI	93.0	22.0	67.0	_ 14.7	3.1
LODSCC	6 69	47 .	OD	MAI	99.4	41.4	78.3	32.4	13.2
LODEDM	1.97	96	OD	SAI	73.6	22.1	64.3	14.2	2.2
LIDSCC	5 56	36	ID	SAI	69.7	23.0	40.5	7.9	1.6
LIDSCC	2.93	42	ID	MMI	51.0	61.5	- 26 1	16.0	~1.6
LODSCC	7.12	65	OD	SAI	91.1	23.3	58.1	13.5	2.3
LODSCC	16.92	66	OD	MAI	90.8	73.6	÷23.8	√ 17.5	2.3
LIDSCC	3.9 •	59	ID	MAI	82.7	17.0	66 6	11.2	2.4
LIDSCC	3.93	31	ID	MMI	42.3	38 9	148	5.7	1.2
LODSCC	28.13	29	OD	MAI	91.9	18.9	78.0	14.7	3.6
LODSCC	16.79	70	OD	MAI	93.7	20.5	64.9	13.3	3.5
LODSCC	5.25	58	OD	SAI	90.6	24.4	71.3	- 17.3	30
LODSCC	3.3	65	OD	MAI	94.8	36.2	50.2	18 1	4.4
LODSCC	21.84	9	OD	MAI	25.5	16.2	8.9	. 1.1	1.1
LODSCC	1.58	119	OD	SAI	85.6	10.8	66 4	· 7.20	1.9
LODSCC	3.17	187	OD	MAI	17.6	7.8	5.9	0 46	1.0

Table B2. Reference table showing data for axial SCC and EDM notches in the free span for test sections that  $\ensuremath{\mathsf{m}}_p$  had determined.

Flaw Type	BC Volts	BC Phase (deg)	ID/OD	Ref State	Depth (% TW)	Length	Ave. Depth (% TW)	Ave. Depth x Length (mm <sup>2</sup> )	m <sub>p</sub>
LODSCC	4 61	70	OD	SAI	91 8	12 2	77.2	94	28
LODSCC	3 38	61	OD	SAI	91.7	20 1	57.2	11.5	20
LODSCC	1 29	51	OD	SAI	86 4	20.5	48 6	100	19
LODSCC	3.79	186	OD	SAI	70 7	17.7	54 0	96	1.8
LIDEDM	5 04	30	1D	SAI	53 5	128	41.7	5.3	1 4
LODSCC	3 13	50	OD	SAI	87.3	17 8	67 4	120	2 (
LODEDM	1 84	102	OD	SAI	71 0	13.5	598	8.1	1.5
LODSCC	1 83	68	OD	MAI	82.4	20 9	46 0	96	1.3
LODEDM	08	120	OD	SAI	52.0	13 6	41.3	5 6	1 4
LODSCC	12.9	82	OD	MAI	95 0	16 6	73 6	122	63
LODSCC	129	82	OD	MAI	95 0	166	73 6	122	6
LODSCC	17.06	74	OD	MAI	97.4	13.1	86 9	11 4	5 (
LODSCC	8 03	84	OD	MAI	94.7	25.7	80 5	20 7	5.:
LODSCC	76	48	OD	MAI	943	23 9	81 4	19 5	5
LODSCC	6 68	68	OD	MAI	91.1	17 8	72 4	129	3
LIDEDM	5.7	34	ID	SAI	66 1	13 9	55 2	7.7	1
LODSCC	4.12	57	OD	MAI	88.8	10.5	73 7	7.7	2
LODSCC	08	141	OD	SAI	77.4	197	19.7	39	1
LODSCC	1.81	74	OD	SAI	928	120	76 2	9.1	2.
LODSCC	0 59	133	OD	MAI	70 2	13 6	49 6	6.7	1
LIDEDM	2 22	25	ID	SAI	417	12.8	28.1	36	1
LIDSCC	3 47	8	ID	MAI	55 6	14.1	33 5	47	1.
LODSCC	8 06	95	OD	MAI	93 7	26.5	61 6	163	2
LODSCC	2 44	79	OD	MAI	93 9	21.8	71 0	15 5	3
LODSCC	4 95	75	OD	MAI	92 1	13.1	698	9.1	19
LODSCC	12.19	60	OD	MAI	98 5	24 0	80 6	193	8.
LODSCC	0	0	OD	SAI	30 6	12.4	13.7	1.7	1.
LODSCC	1.37	95	OD	MAI	88 0	14.9	61 5	92	2.
LODSCC	2.74	124	OD	MAI	567	7.5	39 3	2.9	1
LODSCC	2 56	137	OD	SAI	26 1	13 3	11.7	1.6	1.
LODSCC	2.12	107	OD	MAI	78 <b>7</b>	168	63 9	10.7	2.
LODSCC	5.5	53	OD	MAI	90 6	25 3	67.4	17.1	3.
LODSCC	1.12	113	OD	SAI	83 5	25 2	32.9	83 *	1
LODSCC	6 62	78	OD	SAI	96 3	29 1	85 0	24.7	9.
LODSCC	2 46	107	OD	SAI	80.2	11 4	64 6	74	1
LODSCC	4.74	50	OD	MAI	98.5	22 1	76 1	168	4
LODSCC	34	89	OD	MAI	97.2	23 6	500	118	3
LODSCC	2.92	73	OD	MAI	90 5	13 9	64 4	90	2.
LODSCC	6.12	81	OD	MAI	878	20 9	57 8	12.1	2

Table B2. (Cont'd.)

Flaw Type	BC Volts	BC Phase (deg)	ID/OD	Ref. State	Depth (% TW)	Length (mm)	Ave. Depth (% TW)	Ave. Depth x Length (mm <sup>2</sup> )	, m <sub>p</sub>
LODSCC	7	- 65	OD	- MAI	99 2	37 4	420 -	15.7	7.5
LODSCC	4 28	70	OD	SAI	91.8	28 6	39.7	11.4	24
LIDSCC	0.68	110	ID	SAI	64 1	20 3	48.8 -	9.9	1.7
LODSCC	0 57	-45	OD	SAI	65 5	30 3	28 3	86	14
LIDSCC	5 27	37 -	ID	SAI	68 1	26.1	54 1	14 1	20
LODSCC	1 68	-76	OD.	SAI	800 ~	25.3	398	101 ,	1.7
LODSCC	0 36	144	OD	MAI	<b>7</b> 96 1	24 8	64.4	160	3.2
LODSCC	6 15	. ~ ~ 68	OD	MAI	96 1	24.8	64 4	160	3.2
LODSCC	1 01	81	OD	MAI	80 4	28.1	48 0	13 5	2.2
LODSCC	1.37	148	OD	SAI	583	12.4	27.4	3 4	1.2
LODŠCC	6.77	129	OD	MAI	90 4	28.7	66 0	189	3 1
LODSCC	8 81	169	OD	SAI	78 2	17.8	55.5	99	1.9
LODSCC	5.76	72	OD	SAI	94.1	18.6	68 2	12.7	33
LIDEDM	5.99	39	ID	SAI	67.3	25 8	55 8	14 4	20

# **Appendix C: Examination Technique Specification Sheets**

Examination Technique Specification Sheet for Bobbin Coil

ETSS #1 BOBBIN P	ROBE ACQUISITION	ON		<u> </u>	<del></del>		R	evision 6
Site: Argonne SG Mocl	k-up				Page	1 of 5		
Examination Scope		· ·					-	
Applicability: Standard Anondented drilled TSPs, intersections, wastage a 96007 and 96008 and 96	and above the TS slu and wear. This techni	dae pile regio	on. Det	ection of	axial PWSCC	at dented o	drilled tub	e support plate
Instrument			T	ubing				·
Manufacturer/Model: Ze	tec MIZ-30, Tecrad TC	6700	M	laterial T	ype: Inconel 6	00		
Data Recording Equipr	nent		0	D X Wal	(inch): 0.875	₹ 0.050		
Manuf /Media: HP Hard	Drive, 2.6 Gb Optical of	r Equiv.			n Standard			<del>-</del>
Software	<u>-</u>		T	ype: ASI	ME Rev. 5 requi	rements		
Manufacturer: Zetec or	Westinghouse latest a	pproved versi	on A	nalog S	ignal Path			
	<del> </del>		P	robe Ext	ension Manuf.:	Zetec		
Examination Procedure	e .		E	xtension	Type & Length:	Universal	940-176	0, 50 ft.
Number/Revision: ANL0	02/Rev. 3		s	lip Ring	Model Number:	508-2052	2 or equiv	alent
Scan Parameters							· · · · · · · · · · · · · · · · · · ·	<del> </del>
Scan Direction: Pull			_		<del></del>			
Digitization Rate, Sampl	es Per Inch (minimum)	: A	xial Dire	ection	- 37 -	Circ. Dir	ection	I N/A
Nominal Probe Speed	Sample Rate	RPM Set			RPM Recom	mended	RPM R	ecommended
21*/sec.	800	N/A			N/A		N/A	· · · · · · · · · · · · · · · · · · ·
Probe/Motor Unit	<del></del>	L		-	<u> </u>		·	
Description (Model/Diam	neter/Coil Dimensions)	<del></del>		Manuf	acturer/Part Nu	mber		Length
A-720-M/ULC (720UL)	<u> </u>			Zetec	760-1192-000			110 ft.
Data Acquisition				<u>.                                    </u>				1
Calibration Coil 1 Char	nnels		<del></del> -					
Frequency Channel	400 kHz Ch.1	200 kHz Ch. 3		· <del>-</del>	100 kHz Ch. 5		20 kHz Ch. 7	
Phase Rotation	100% TWH 40 degrees	100% TWH 40 degrees			100% TWH 40 degrees		TSP 270 De	grees
Span Setting	100% TWH 5 divisions	100% TWH 5 divisions			100% TWH 5 divisions		TSP 5 division	-
Calibration Coil 5 Char								
Frequency Channel	400 kHz Ch. 2	200 kHz Ch. 4			100 kHz Ch. 6		20 kHz	
Phase Rotation	100% TWH 40 degrees	100% TWH 40 degrees		· · · · · · · · · · · · · · · · · · ·	100% TWH 40 degrees		Ch. 8 TSP 270 De	orees
Span Setting	100% TVVH 3 divisions	100% TWH 3 divisions			100% TWH 3 divisions		TSP 5 division	

ETSS#1	BOBBIN	PROBE	AC	QUIS	SITIC	N												Rev	/15101	n 6			
Site: Arg	onne SG	Mock-up	,														- '	Pag	e 2	of 5		•	
					Cor	ıfigu	ratio	n Bo	ard S	Settin	gs ·	-											
trig: off	-	down	con	figu	ration	#.0			nar	ne:Bo	bbit	1	san	nples	sec:	see p	g1		rec.	.med	1a =	HD	
tester=		j	boa	ırd#1			boa	rd#2	,		boa	rd#3			boa	ırd#4	ļ		bos	ard#5	i		
#of chan	nels= 8		pro	be#1			pro	be#1			рго	be#2			рго	be#2	<b>)</b> i		pro	be#1			
		,		DR	IVE		Ì	DR	IVE	-		DR	IVE			DR	IVE	-	T,	DR	IVE		
		а :	Α	D	В	C-	Α	D	В	С	A	D	В	· C	Α	D	В	С	Á	D	В	С	
Drive Pol	•	,	N		N						,			1					,				
Group Nu	mber	. 1	1		1										***			_	T				
Coil Num	ber		1		5														T			_	
freq#1	Time slot	#1					1	•				•							⇈				
400kHz	G.x2	12.0V	D	-	Α						7.5	```							١.				
freq#2	Time slot	#2 ,	1				T			· · · · · · · · · · · · · · · · · · ·		·			1				十				
200kHz	G x2	12 0V	D	un ana	A	**				<b>.</b> .			-				,			~			
freq#3	Time slot	#3 ,	1				T	-							$\vdash$				十一				$\vdash$
100kHz	G x2	12 OV,	D.	7.14	A	,					-	-1 -				ı	~ r	~	Ι.			-	. 1
freq#4	Time slot	#4	十				十				1				1				十				$\Box$
20kHz	G x2	12.00	D		A	τ,	٠.										,	•				-	1
freq#5	Time slot	#5 (	1.				1-	,		,	-				-				十				
4		1 .	1				٠.						,	,	l						•		
End loc cl	h:	1 4	1		driv	eA: L	)=A1	-A2,	P=dr	Al pı	ı:A2,	DP=	dr: D	01&D	2 pu	A1&	A2		÷			1	-
Threshold	1	off _	off		driv	eB· D	)=B1	-B2, <i>i</i>	A=A	1-A2		. ,			-								•
(P) Gain		<b>x6</b>					P=	dr B	l pu l	B <b>2,</b> DI	P = di	C18	έC2 p	ou. B1	&B2	!						1	,
Active Pro	obes	-	1		driv	e C:D	)=C1	-	C2,	A=D	î-C2							~			<b>.</b> -	1.	
		(see note	1)		' driv	e D I	)= D	1-D2													,	1	
	-	1 ~-				.,,,,,	-										- 1			- 5			
	- Tan	3		*		S	peci	al In	struc	tions		<b>.</b> -								,		**.	
-	~ -		- <b>,</b>								-	~		·····		- 1						, 1	~~~
1. The	720MUL	C probe 1	s the	prin	агу і	ıse p	robe	for t	he bo	obbin	exa	mina	tion.			,		•				-	
· ·		٠.			-							~						-	,	-			
2. Exan	nine each	tube full	leng	th or	to th	e ext	ent j	possi	ble.	- 1	-		·				-		٠	- ,			
'									- N						-				~		- 1944 11		
	e recordir												beg	ginnir	ig an	id en	d of	-		~	-	~	٠.
each	ı calıbrati	on group	or e	very	four	hour	s, wi	niche	ver c	come	s firs	t.	~ ·								-	- 12	/ p ==
A Domin	dicaller	onitor of	1 44-		. f	dat-	a1	·	L		Lini.			ı									
4. Peno	dically m	ionnor al	i cna	el	101 (	uata (	quan	ity ar	io ac	cepta	omity	/٠					,	~	4		*		
-	*			4	-		- **	*				~ ~	ν,1	•							.~		***
									- '-	1 ,			•										-

	Examinat	ion Techniqu	ie Specifica	ion Sheet			
ETSS#1- BC	DBBIN PRO	BE ANALY	SIS	<del></del>		Revision 6	Page: 3 of 5
				Data Ana	lysis		
k			Calibration	Differential	Channels		
Channels	&	Ch 1		Ch 3		, Ch 5	Ch 7
Frequen		400 kH		200 kH		100 kHz	20 kHz
Phase Rota	tion	100% T	WH	100% TV	ИН	100% TWH	TSP
	• .	40±1°	100	40±1°	4 D'	40±1°	270±3°
Span Sett Minimu		4x20FBH @	4 DiV	4x20FBH @	4 Div	4x20FBH @ 4 Div	TSP 5 divisions
MIIIIIII		<u> </u>	Calibrat	on Absolute	Channels	<u> </u>	J divisions
Channel	&	Ch 2		Ch 4	Channels	Ch 6	Ch 8
Frequen		400 kH	*	200 kH	Iz	100 kHz	20 kHz
Phase Rot		Probe Motio	n Horiz.	Probe Motio		Probe Motion Horiz.	TSP
		Flaws U	Jp '	Flaws U	Jр	Flaws Up	270±3°
Span Set	ting	- 100% TV	WH	100% T	WH	100% TWH	TSP
Minimu	ım	2 divisi	ons ,	2 divisi	ons	2 divisions	5 divisions
			Calibrat	on Process a	nd Other Cl	iannels	
Channels		P1(Ch 1/	-	P2(Ch 2/	•	P3(Ch 3/1/5)	
Frequenc		400/100 kH		400/100 kH		200/400/100 kHz Diff	
Configur		Suppre		Suppre		Save 100,60,20	
Adjust Paramete		Drilled	TSP	Drilled '	ISP .	Suppress Drilled	
Phase Ro		100% T	3777	100% T	1/T I	TSP, Expansion	
Filase Ro	lation	~35°, noise		~35°, noise	•	@40±3°	
Span Set	ting	4x20 FB1		100% T		100% TWH	
Minimu		- @ 4 divis		2 divisio		5 divisions	
	Voltage No	rmalization	<u>-</u>	-		Calibration Curves	<u>. I </u>
СН	Signa	1	Set	Normalize	Туре	СН	Set Points
1	4X20%	FBH	4.0 volts	All	Phase	1,3,5,P1 Max Rate	100,60,20,FBH
					Curve	2,4,6,P2 Vpp	(use as-built dimens)
			Dat	a Screening	·	,	
Left S	trip Chart		Right	Strip Chart		Lissajous	
	PI			Ch 6		. P1	
· · · · · · · · · · · · · · · · · · ·				Reporting I	Requirement	S	-
Condition/I	Region	Report		Ch P1		Comment	<u>-</u>
Free Span					All indication		
	osolute Drift ADI					cations that lack a different	ential response
Drilled TSP						ns within TSP	
					<u></u>	pp of Tubesheet	
Dent(Structure) DNT				P1(Vpp)		ents > 2.0 volts at TSP's	
Ding(Free S		DNG		P1(Vpp)		ings in free span > 2 00 v	
Dent/Ding w		DNI		P1	1	nt/ding with possib, indic	•
ID Chatter o Permeability		IDC		P1		on which you believe con	
remeability	v ai lat.	PVN		PI	Any indicati	on which you believe cor	uid mask an indic.

**Examination Technique Specification Sheet** 

ETSS# 1- Bobbin Probe Analysis Revision 6 Page 4 of 5

**Special Instructions** 

- 1. Provide a best estimate of % Tw on all bobbin indications based on ASME calibration curve. Place appropriate "I-Code" in the Utility 1 field. Place flaw origin in Util 2 (ID or OD).
- 2. Zoom the strip charts to 3 (or equivalent setting based on window size) for increased visibility of small amplitude indications.
- 3. Scroll each free span region with channel 3.
- 4. Scroll each top of tube-sheet region and expansion transition with channel P1 and P3.
- 5. Review each drilled TSP with channel P1 and Channel 3.
- 6. Monitor the 100 kHz absolute strip chart for positive drift.
- 7. Refer to the flow chart on the following page for additional information on evaluation of indications.
- 8. When distorted indications within dents or dings are identified, record the dent voltage as well as the indication.
- 9. All data should be analyzed unless voided by the operator. There are no retest codes necessary for the mock-up. Use BDA for bad data.
- 10. Landmarking is not necessary. All elevations will be recorded by data point.
- 11. Graphics are not required.
- 12. Do not report signals within one inch of test section ends.

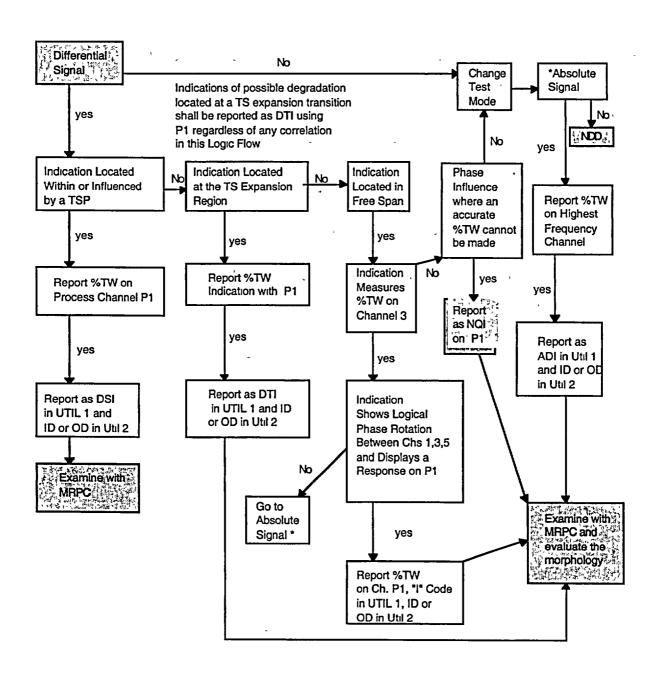
# **Examination Technique Specification Sheet**

ETSS#1-Bobbin Probe

Revision 6

Page 5 of 5

### Bobbin Probe Flow Chart



# Examination Technique Specification Sheet for MRPC

ETSS #2 3-Coil RPC	(.115/+PT/ 080 HF) ACQUIS	ITION	ì." _	7	- I		Revision 6
Site Argonne SG Mod	ck-up	** * s *			Page 1 of 7	٠.	
Examination Scope	4 4 77	y	-		4 4 5 3 3 4 6	mark.	·
Applicability. Detection at or above TS Expans of ETSSs, 96403, 9650	n of PWSCC at TS Expanse sion Transitions and TSPs v 08, 96702, 96703.	with or without dents	Ps or Sizing	Free-sp g of crac	an Regions with or witho k-like indications as app	ut de licat	ents. Detection of ODSCO ole. Satisfies requirements
Instrument		4 T FF		oing .	1		+ ~
Manufacturer/Model Z	etec MIZ-30, Tecrad TC670	00	Mai	terial Ty	pe: Inconel 600 ",	_	
Data Recording Equipme	ent	•	OD	X Wall	(inch). 0.875 X 0 050		
Manuf./Media: HP Har	d Drive, 2 6 Gb Optical or E	quiv.	Cal	ibration S	Standard	-	
Software	A		Typ	e: EDM	notches meeting Rev. 5	requ	urements
Manufacturer: Zetec o	r Westinghouse latest appro	oved version 5	Ana	ilog Sign	al Path		<del> </del>
			Pro	be Exte	nsion Manuf.: Zetec		
Examination Procedure		1	Ext	ension 1	ype & Length Universal	940-	1760, 50 ft
Number/Revision: ANI	<u> </u>	1			odel Number: 508-205		
Scan Parameters			1		<u> </u>		
Scan Direction: Pull o		, <i>T</i>			•		17
	ples Per Inch (minimum):	Axial [	Directi	on	30 Circ	Dire	ection 30
Probe Speed	Sample Rate	RPM Set :			RPM Min		RPM Max
0.5*/sec.	1391			<u> </u>	750		1012
Probe/Motor Unit	1391 *** - •	900			' ' ' ' ' ' ' ' ' ' ' ' ' ' ' ' ' ' '		
			-	NA	, to an all part through a a		
	ameter/Coil Dimensions)	w w			cturer/Part Number		Length .
	PT/080 HF (shielded), Mag-l	Bias			700-4055-071	•	
		ar k man in the	40 0	Zetec 8	310-4077-001		83 ft
Data Acquisition		·			<u> </u>		an year at the Act of
Calibration Coil 1 (.11	<u> </u>						
Frequency Channel	400 kHz Ch.2	300 kHz Ch. 5		-	200 kHz Ch. 8		100 kHz Ch. 10
Phase Rotation	40% ID Axial	40% ID Axial			40% ID Axial		TSP
	15 degrees	15 degrees			15 degrees		90 Degrees
Span Setting	40% ID Axial 3 divisions	40% ID Axial	-		40% ID Axial		TSP
Calibration Coil 5 (+P7		3 divisions			3 divisions		3 divisions
Frequency	400 kHz	300 kHz			200 kHz		100 kHz
Channel	Ch. 3	Ch. 6			Ch. 9		Ch. 12
Phase Rotation		40% ID Axial	•	-	40% ID Axial		40% ID Axial
Span Setting	15 degrees 40% ID Axial	15 degrees 40% ID Axial			15 degrees 40% ID Axial		15 degrees 40% ID Axial
opan detung	3 divisions				3 divisions		3 divisions
		Calibration Coil 7	7 -	٢.	(.080"HF Pan)	T	-
Frequency	600 kHz	400 kHz			300 kHz		
Channel Phase Betation	Ch 1	Ch 4			Ch. 7		
Phase Rotation	40% ID Axial 15 degrees	40% ID Axial 15 degrees	£ 4		40% ID Axial 15 degrees		
Span Setting	40% ID Axial	40% ID Axial		<u> </u>	40% ID Axial	à	
	3 divisions	3 divisions			3 divisions		1
		Calibration Coil 4	4		(Trigger)		
Frequency Channel		100 kHz Ch. 11					
		Trigger Pulse Main Pulse Up	هید می		r - 4 1		,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,
Span Setting		Trigger Pulse					
-		4 Divisions					

ETSS#2	- 3-Coil			80)						ision	6				Pag	ge: 2 c	of 7			
		d		Configur	atıor	ı Boaı	d Se	ttıng	S	4				-			-	-		
trig: off		down	configur	ation# 0			nan	ie:					e page			rec.	media	= 1	ID	_
tester=		٠ -	board#1			rd#2			boa	rd#3.			board	#4		boa	rd#5			Π
of chanr	nels= 12		probe#1	~~	prot	pe#1		1	prot	oe#3			probe	#4		pro	be#5			T
-		~	DR	IVE ,~	7	DRI	VE	4	1	DR	VE			DRIVE		1	DR	VE	h. #	T
			A - D	B∼ C	A	D-	В	С	A٠	D	В	C·	А٠	D B	С	A	D	В	С	"
Drive Pol	•	-	N	- , N	N		N _	N	Π			-		•		1		-		$\Box$
Group No			1	i	1		1	1					-				-			Т
Coil Nun			1 .	4	5		7	8								1				T
freq#1	Time slo	t #1		٠				-	Т						-	1				T
600kHz	G:x2	12 0V	7 .	•		*	D		1											l
freq#2	Time slo	t#2							Т						V-1	1				T
400kHz	G.x2	12 0V	D		D		D		ı	,										
freq#3	Time slo	t#3	1			y.			1							1				T.
300kHz	G·x2	12 0V	Ď	***	D		D						ļ							
freq#4	Time slo	t#4																-		T
200kHz.	G:x2	12.0V	D .	,	D	• .							i							
freq#5	Time slo	t#5			Т	4	-		Т				T.		_	1				T
100kHz -	G x2	12 OV	D	-, <b>D</b>	D				1				1			-				1

#### Special Instructions

- One calibration standard may be recorded at the beginning and end of each cal group provided it is a successful scan of the standards' complete length.
- 2. Data will be recorded on the PUSH when running top of tube-sheet exams. Data recorded on the PUSH is acceptable for other regions of the mock-up. The operator shall state the direction of scanning in a message.
- 3. All locations shall be acquired from structure to structure unless an encoder is used. When an encoder is used the location may be acquired from the respective structure to a few inches past the area of interest. Care should be taken to insure that the proper location is scanned with adequate data past the target location to account for any variations in probe speed or axial scaling.
- 4. Tubes that have been mis-encoded should be corrected by entering a message to void that entry and re-examining the tube with the proper encode.
- 5. Periodically monitor all channels for data quality and acceptability.

	Examina	ation Tech	nique Spe	cification	Sheet					
TSS#2-3 Coi		+PT/.080) Ana				Revision 6		Page 3 of 7	-	
				Data Analy		- y	1 -			
1		~	Calibration (	Coil 1 (.115" P	ancake) Chan	nels			1	
Channels &	ζ	Ch 2	-	; Ch 5		Ch 8	, 1	1		
Frequency		400 kHz 115	MR -	300 kHz 11	5MR	200 kHz 115	MR	-100 kHz 115		
Phase Rotation	on	40% ID Axia	1	40% ID Axia	1	40% ID A	kial	40% ID Ax	ial	
•		.15±1°	-	15±1°	+	15±1°		15±1°	£	
Span Setting	g	40% ID Ax	ial	40% ID A	xial	40% ID Ax	ial	40% ID Ax	ial	
Mınımum		3 divisions		3 divisions		3 divisions		3 divisions	•	
	- 1		Calibration	n Coil 5 (+PT)				-		
Channel &		- Ch 3		Ch 6		Ch 9		Ch 12		
Frequency		400 kHz+A		300 kHz+A		200 kHz+A		100 kHz+Axıal		
Phase Rotati	ion	40%ID Ax	nal	40%ID Ax	<u>-</u>	40%ID A	xial	40%ID Axial		
		15°±1°		15°±1°,		15°±1°	1 -	15°±1°		
Span Settin	<del>-</del>	40% ID Ax		40% ID Ax		40% ID Ax		40%ID Axi		
Mınımum	1	3 divisio		3 divisio		3 division	S	3 divisions		
			Calibratio	n Coil 7(.080"						
Channels &	4	Ch 1		Ch 4				,		
Frequency		600 kHz 08		400 kHz 08	•	300 kHz 080		٠,		
Phase Rotati	ion	40%ID Ax	ial	40%ID Axi		40%ID Ax				
		15°±1°	3. 1	15°±1° ;		15°±1°		,		
Span Settin		40%ID A		40%ID A		40%ID A				
Minimum				3 divisio		3 division	ıs ,	ř. 1		
,	( )	F.	Calibration	Coil 4 (Trigg	er) Channels			#- ·	-	
Channel &		Ch 11		<u> </u>		<u></u>		-	33 + 35	
Frequency		100 kHz T		<u> </u>			ļ			
Phase Rotation	on.	Trigger Pu			-		, -		•	
1	1.	Main Puls	•		,		د ا	,	•	
Span Settin		Trigger Pu				ļ				
Minimum	l .	4 divisions		<u> </u>	<u> </u>	<u> </u>				
				n Process Cha	•	,	, ,	'	12	
Channels &	έ 	Ch P1(Ch		Ch P2 (Ch		Ch P3 (Ch		Ch P4 (Ch		
Frequency		400 kHz + C	IRC	300 kHz+C	CIRC	'200 kHz +C	IRC 1	100 kHz +	CIRC	
djust Parame	ters	N/A		N/A	1	N/A		N/A		
51		" " (0 m to 2)			+ 11 7	£, ,	4.	10078	,	
Phase Rotati		40%ID Cir	-	40%ID C		1 40%ID C	irc	40%ID C	itc ; ,	
001		15°±1°		: 15°±1°		15°±1°	<u>-</u>	15°±1°		
Span Settin		40%ID C		40%ID C		40%ID C		, 40%ID Ci	rc ·	
Minimum		3 division	<u> </u>	3 division		3 division		3 divisions	<b>X</b>	
	alization (See	note #3)	C 6.2	  Normalize		Jurve (See No		C-A D-'A		
CH	Signal	_1	Set		Туре	,	СН	Set Point	S ;	
5,6	6 100% Axial EDM (Note 3) 100%Circ 20 volts		20 Vpp	C.1 Chnls	DE (VVV	<u> </u>		A - OD 100 (	0.40/00.100.40.20	
2			(Note 3)	C.5 Chnls	Ph (Vpp) whe		6	1	0 40/ID 100,60,20	
<u> </u>	100%Circ 20	voits		Ch P1,P2	Ph (Vpp) who	n req a	P2	CF OD 100,6	0,40/ID 100,60,20	
			Data	<u> </u>	<u> </u>			ļ		
1 -6 6	- Chart			Screening			1	J.,		
Left Stri			_	rip Chart		<u> </u>	Lissajous			
<u>un</u>	P2		CH IU OF AD	alyst Discretion		L	Ch 6	,		
ondition (P -	ondition/Region Report			1	rquirements		l and	ļ		
				Ch	Dancet dansk	Comm	ide( I-Code Uti	115014)	<u> </u>	
	ngle/Multi.Ax.Ind. S/MAI 6			<u> </u>					· · · ·	
ingle/Multi C		S/MCI		P2						
ingle/Multi.V		S/MVI		6 or P2 Report depth at max amplitude( 1-Code Util 1field)						
olumetric ·		VOL	Ser.	6 or P2						
Mixed mode MMI 6 or P2 Report depth at max amplitude (I-Code Util I field)					Keport depth	at max amplitu	ide( I-Code Uti	ii itield)		

Examination Technique Specification Sheet		-
ETSS #2 - 3-Coil RPC (.115/+PT/.080) Analysis	Revision 6	Page: 4 of 7
Specific Instructions		

- 1. Span, Phase, and Volts are to be set using the center of the notch. The above span settings are a minimum.
- 2. Rotate data using "Data Slew Menu" so coils 5 and 7 are aligned with Coil 1. Label the coils using the acronyms shown in the "channel & frequency" column of the data analysis calibration section.
- 3. When the 100% axial EDM notch saturates, substitute the 60% ID axial EDM notch for voltage normalization and set it to a value of seven (7) volts (Vpp).
- 4. Use the tube outside diameter (0.875 in.) in user selects for tube diameter.
- 5. The evaluation shall consist of reviewing Lissajous, strip chart, and C-scan displays to the extent that all tube wall degradation and other conditions are reported.
- 6. All data shall be screened using the +300 kHz Point coil channel as a minimum.
- 7. All indications indicative of degradation shall be reported, with no minimum voltage threshold. All types of degradation shall be reported with % TW estimate (% TW Field) and a characterization code in the Utility 1 field.
- 8. To achieve accurate measurements, the axial scale should be set using a known distance of greatest length. Manual scales should be reset on each data record, which provides structure-to-structure response.
- 9. All reported indications shall have ID or OD in Util2.
- 10. All coils must be producing acceptable data for all scans.

Normalize voltage, set up Cal curves, and report all indications in the main Lissajous window. Do not report signals within 1" of the test section.

Use the axial and circumferential Lissajous windows provided in the C-scan plot for determining ID or OD origination if necessary.

CTSS#2-3 Co		ique Speci +PT/.080) Ana				Revision 6		Page: 5 of 7	· · · · · · · · · · · · · · · · · · ·
	1	1	7	Data Sizing			I		
			Calibration C			nels	<u>'                                    </u>		
Channels	<u>.</u>	Ch 2		Ch 5		Ch 8		Ch 10	
Frequenc		400 kHz 115	MR	300 kHz 11	5MR	200 kHz 115	MR	100 kHz 115	MR
Phase Rotat	•	40% ID Axia	1	40% ID Axia		40% ID A	kial	- 40% ID Ax	tial
		15±1°		15±1°		15±1°	I	15±1°	
Span Setti	19	40% ID Ax	ial	40% ID A	xial	40% ID Ax	ial	40% ID Ax	ial
Minimun		3 divisions		3 divisions		3 divisions		3 divisions	
	<u> </u>	J divisions		Coil 5 (+PT)				<u> </u>	
Channel	<u> </u>	Ch 3	Cunorudos	Ch 6		Ch 9		Ch 12	
Frequenc		400 kHz+A	xial .	300 kHz+A	x1al	200 kHz+A	xial	100 kHz+A	xıal
Phase Rota		40%ID Ax		- 40%ID Ax		40%ID A		40%ID A	
I muse Rom	1	15°±1°		15°±1°		15°±1°		15°±1°	
Span Sett	7	40% ID Ax	~	40% ID Ax		40% ID Ax	i lein	40%ID Axi	
Minimui		3 division		3 division		3 division		3 division	
1ATTHITH IN	1	3 UIVISIO				2 (114121081		2 division	,
Channels of	<u> </u>	Ch 1	Campranor	Coil 7(.080" HF Pancake) Ch 4		·			
		600 kHz 08	OUE.	400 kHz 080	NIE .	Ch 7 300 kHz 080HF		<b> </b>	
Frequency Phase Rota				400 kHz 080 40%ID Axi		40%ID Axia		<del> </del>	
rnase Kota	uon ,	40%ID Ax	1211		aı .				
- C C	<u> </u>	-15°±1°		15°±1°.		15°±1°		<u> </u>	
Span Sett	_	40%ID A		40%ID A	,	40%ID A			
Mınimu	n	3 division		3 divisio		3 division	1S	-	
			Calibration	Coil 4 (Trigg	er) Channels	<u>,</u>	ļ		
Channel		Ch 11				<u> </u>	, ~		
Frequenc	<u> </u>	100 kHz T	_	1	٤ .				
Phase Rotat	ion ,	Trigger Pu		فيقيد أه	•	. • 5	-1.		
		Main Puls	•	,	* -	:			
Span Sett		Trigger Pu	lse	4		- +			- 1
Minimui	n	4 division							
				Process Cha					
Channels	&	Ch P1(Ch:		Ch P2 (Ch		Ch P3 (Ch		Ch P4 (Ci	
Frequency		400 kHz + C	IRC	300 kHz+C	IRC	200 kHz +C	ZIRC	100 kHz +	CIRC
djust Param	eters	N/A		N/A		N/A	-	N/A	* * * 1
	T z		Ł	11			,	,* ,	-
Phase Rota	tion	40%ID Cir	С	40%ID C	irc .	, 40%ID Circ		40%ID C	uc
		15°±1°		15°±1°		15°±1°		15°±1°	-
Span Sett	ing	40%ID C	irc	40%ID C	irc	40%ID C	irc ·	40%ID C	rc
Mınımur	1	· 3 division	ıs '	3 division	is -	3 divisio	ns i	3 divisions	•
oltage Norn	nalization (See	note #3)			Calibration (	Curve		1	. 4
CH	Signal		Set	Normalize	Туре		СН	Set Poin	ts
,5,6	100% Axi	al	20 Vpp	C.1 Chnls		1		j	
	EDM	[		C.5 Chnls	Phase (Vpp)	·	6	Ax OD 100,0	60 40/ID 100,60,40
22	100%Circ		20 Vpp	Ch P1,P2	Phase (Vpp)		P2	Ax OD 100,60 40/ID 100,60,4 Cir OD 100,60,40/ID 100,60,40	
				2.1	2	1	,	Ch OD 100,00,40/1D 100,00,40	
	<del>                                     </del>		Data	Screening	- , !		- 1	,	
Left St	rip Chart	1	Right St	rip Chart .	, -, -		Lissajous		
	n P2						· Ch 6		
		<del> </del>				1	<del>                                     </del>		
ondition/R	egion	Report	<u> </u>	Ch	1	Comm		<del> </del>	<del>                                     </del>
ingle/Multi			··		See next page	I	-,	l	
ingle/Multi								-	, .
ingle/Multi.			· · · · · · · · · · · · · · · · · · ·	1					
olumetric				1				<del> </del>	
/ 4 )		. 102	Set Normalize Type Cl 20 Vpp C.1 Chnls C.5 Chnls Phase (Vpp) 6 20 Vpp Ch P1,P2 Phase (Vpp) P2  Data Screening Right Strip Chart Liss: Ch 10 or Analyst Discretion Reporting Requirements  Report Ch Comment			1			

Examination Technique Specification Sheet		-
ETSS #2 - 3-Coil RPC (.115/+PT/.080) Analysis	Revision 6	Page: 6 of 7
Specific Instructions		

These instructions apply to line-by-line sizing of all indications. The specific instructions for analysis as delineated in ETSS#2 still apply, as appropriate, to this ETSS.

### For sizing circumferential indications:

Voltage normalization is performed in the axial Lissajous window and is set on the 100% circumferential notch at 20 volts. Adjust the span such that the 40% ID circ notch is 3 div for 300 kHz. Monitor the 300 kHz raw and process channels on the strip chart and scroll the region of interest while viewing the Lissajous. Terrain-plot the 300 kHz raw and process channels in the area of interest.

A phase curve is established on process channel P2 using 100%, 60%, 40% circumferential notches in the axial Lissajous window; in addition, set a zero percent value in the curve. All phase measurements are performed on the Lissajous response in the axial Lissajous window. Careful analysis should be performed, watching specifically for any change in the Lissajous signal. Record a zero percent call prior to the first call of the indication and after the last call unless the indication is 360 degrees. Record only those indications which provide a flaw-like Lissajous response at a maximum of 10 degree increments. Applying an axial "to-from" may be necessary to reduce the effect of geometry on the indication phase measurement. Filters are acceptable for detection but are not applied for sizing. Dent responses may also form in the same plane as the flaw response.

### For sizing axial flaws:

Voltage normalization is performed in the circ. Lissajous window and is set on the 100% axial notch at 20 volts. Adjust the span such that the 40% OD axial notch is 3 div. at 300 kHz (channel 6). Set phase so that the 40% ID axial notch is 15 degrees at 300 kHz. A phase curve is established on the 300 kHz raw channel using 100%, 60%, and 40% ID axial notches. Terrain-plot the 300 kHz raw channel in the area of interest. Axial indications will form in the positive direction.

Dent responses may also form in the same plane as the flaw response. Careful analysis should be performed watching specifically for any change in the Lissajous signal. Phase and amplitude measurements are performed on the Lissajous response from the circumferential Lissajous window. Record only those indications which provide a flaw-like Lissajous response. Apply a circ. from to to isolate the indication and minimize the number of data points in the Lissajous. Use the strip chart to step through one scan line at a time along the length of the indication. Record a call for each step along the length of the indication. Record a zero percent call prior to and as near the first call of the indication and after the last call.

Examination Technique Specification Sheet		
ETSS #3 - 3-Coil RPC (.115/+PT/.080) Analysis and	Revision 6	Page: 7 of 7
Sizing		
Specific Instructions		

Filters are acceptable for detection but are not applied for sizing.

## Adjustment Procedure

At the completion of the initial analysis process, adjustment for data points at the ends of the cracks is required. Data points within 0.2 in. of the indicated crack ends will be adjusted as follows:

- (a) Ignore all data points from the first reading to the point at which phase angles change from ID to OD.
- (Paragraph A does not apply if the crack exhibits primarily OD phase angles over its length.)
- (b) Data points of less than 1 volt, with ID phases indicating 85% throughwall and greater, will be ignored from the first reading to that point provided within 0.2 in. of the first reading.
- c) ID phase data points of less than 1 volt, exhibiting depth increases of greater than 10% throughwall over approximately a 0.05 in. span, will be ignored.

NRC FORM 335 (2-89) NRCM 1102, 3201, 3202  BIBLIOGRAPHIC DATA SHEET (See instructions on the reverse)  2. TITLE AND SUBTITLE  Eddy Current Reliability Results from the Steam Generator Mock-up Analysis Round Robin	1 REPORT NUMBER (Assigned by NRC, Add Vol., Supp , Rev., and Addendum Numbers, If any )  NUREG/CR-6791				
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	FIN OR GRANT NUMBER W6487				
5. AUTHOR(S)	6. TYPE OF REPORT				
D. S. Kupperman, S. Bakhtiari, W. J. Shack, J. Y. Park, S. Majumdar		Technical Report			
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	06/01-06/02				
8 PERFORMING ORGANIZATION - NAME AND ADDRESS (If NRC, provide Division, Office or Region, U.S. Nuclear Regulatory Community Provide name and mailing address) Argonne National Laboratory 9700 S. Cass Avenue Argonne, IL 60439	ssion, and mailing address	, if contractor,			
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J. Davis, NRC Project Manager					
This report presents the results of a nondestructive evaluation round-robin des igned to independently assess the reliability of steam generator (SG) inspection. A SG mock-up at Argonne National Laboratory (ANL) was used for this study. The goal of the round-robin was to assess the current state of in-service inspection reliability for SG tubing, determine the probability of detection (POD) as a function of flaw size or severity, and assess the capability for sizing of flaws. Eleven teams participated in analyzing bobbin and rotating coil mock-up data collected by qualified indus try personnel. The mock-up contains hundreds of cracks and simulations of artifacts such as corrosion deposits and tube supp ort plates. This configuration mimics more closely than most laboratory situations the difficulty of detection and charact erization of cracks experienced in an operating steam generator. An expert task group from industry, ANL, and the Nuclear Regulatory Commission (NRC) has reviewed the signals from the laboratory-grown cracks used in the mock-up to ensure that the y provide reasonable simulations of these obtained in the field. The number of tubes inspected and the number of team participating in the round-robin are intended to provide better statistical data on the POD and characterization accuracy than is currently available from Electric Power Research Institute (EPRI) qualification programs. This document reports result s beyond those presented in ANL-01/22, "Evaluation of Eddy Current Reliability from Steam Generator Mock-up Round-Robin."					
12 KEY WORDS/DESCRIPTORS (List words or phrases that will assist researchers in locating the report.)	13 AVAILABII	UTY STATEMENT			
steam generator		Inlimited CLASSIFICATION			
tubes stress corrosion cracks	(This Page)	CLASSIFICATION			
Eddy Current Testing	unclassified				
Nondestructive Evaluation In-Service Inspection	(This Report)  unclassified				
Round Robin Alloy 600, Inconel 600		R OF PAGES			
	16 PRICE				



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NUREG/CR-6791

# EDDY CURRENT RELIABILITY RESULTS FROM THE STEAM GENERATOR MOCK-UP ANALYSIS ROUND-ROBIN

**NOVEMBER 2002** 

**UNITED STATES NUCLEAR REGULATORY COMMISSION** WASHINGTON, DC 20555-0001

> OFFICIAL BUSINESS PENALTY FOR PRIVATE USE, \$300